R&S®RTP HIGH-PERFORMANCE OSCILLOSCOPE

Specifications



Specifications Version 08.00

ROHDE&SCHWARZ

Make ideas real



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Definitions

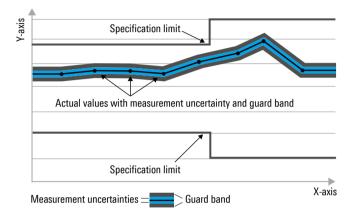
General

Product data applies under the following conditions:

- · Three hours of storage at ambient temperature followed by 30 minutes of warm-up operation
- Specified environmental conditions met
- · Recommended calibration interval adhered to
- All internal automatic adjustments performed, if applicable

Specifications with limits

Represent warranted product performance by means of a range of values for the specified parameter. These specifications are marked with limiting symbols such as $\langle, \leq, \rangle, \geq, \pm$ or descriptions such as maximum, limit of, minimum. Compliance is ensured by testing or is derived from the design. Test limits are narrowed by guard bands to take into account measurement uncertainties, drift and aging, if applicable.



Non-traceable specifications with limits (n. trc.)

Represent product performance that is specified and tested as described under "Specifications with limits" above. However, product performance in this case cannot be warranted due to the lack of measuring equipment traceable to national metrology standards. In this case, measurements are referenced to standards used in the Rohde & Schwarz laboratories.

Specifications without limits

Represent warranted product performance for the specified parameter. These specifications are not specially marked and represent values with no or negligible deviations from the given value, e.g. dimensions or resolution of a setting parameter. Compliance is ensured by design.

Typical data (typ.)

Characterizes product performance by means of representative information for the given parameter. When marked with <, > or as a range, it represents the performance met by approximately 80 % of the instruments at production time. Otherwise, it represents the mean value.

Nominal values (nom.)

Characterize product performance by means of a representative value for the given parameter, e.g. nominal impedance. In contrast to typical data, a statistical evaluation does not take place and the parameter is not tested during production.

Measured values (meas.)

Characterize expected product performance by means of measurement results gained from individual samples.

Uncertainties

Represent limits of measurement uncertainty for a given measurand. Uncertainty is defined with a coverage factor of 2 and has been calculated in line with the rules of the Guide to the Expression of Uncertainty in Measurement (GUM), taking into account environmental conditions, aging, wear and tear.

Device settings and GUI parameters are designated with the format "parameter: value".

Non-traceable specifications with limits, typical data as well as nominal and measured values are not warranted by Rohde & Schwarz.

In line with the 3GPP standard, chip rates are specified in million chips per second (Mcps), whereas bit rates and symbol rates are specified in billion bit per second (Gbps), million bit per second (Mbps), thousand bit per second (kbps), million symbols per second (Msps) or thousand symbols per second (ksps), and sample rates are specified in million samples per second (Msample/s). Gbps, Mcps, Mbps, Msps, kbps, ksps and Msample/s are not SI units.

Base unit

Vertical system

| Input channels | | 4 channels |
|------------------------------|-------------------------------------|--|
| Input impedance | offset and position set to zero | $50 \Omega \pm 2 \%$ |
| Analog bandwidth (-3 dB) | R&S [®] RTP044B | ≥ 4 GHz |
| Analog bandwidth (-5 db) | R&S®RTP064B | ≥ 6 GHz |
| | R&S®RTP084B | ≥ 8 GHz |
| | R&S®RTP134B | \geq 13 GHz on 2 channels ¹ , |
| | Ras RIPI34D | |
| | | \geq 8 GHz on 4 channels |
| | R&S [®] RTP164B | \geq 16 GHz on 2 channels ¹ , |
| D | | ≥ 8 GHz on 4 channels |
| Rise/fall time | 10 % to 90 %, calculated from 0 | 5 |
| | R&S [®] RTP044B | 108 ps |
| | R&S [®] RTP064B | 72 ps |
| | R&S [®] RTP084B | 54 ps |
| | R&S [®] RTP134B | 33 ps |
| | R&S [®] RTP164B | 27 ps |
| | 20 % to 80 %, calculated from 0 | .3/analog bandwidth |
| | R&S®RTP044B | 75 ps |
| | R&S [®] RTP064B | 50 ps |
| | R&S [®] RTP084B | 38 ps |
| | R&S®RTP134B | 23 ps |
| | R&S®RTP164B | 19 ps |
| Vertical resolution | | 8 bit, |
| Venical resolution | | 16 bit for high resolution decimation |
| | | (with reduction of the sampling rate), |
| | | 16 bit for high definition mode (without reduction of the sampling |
| | | rate ²) |
| | offect and position act to zero | Tale) |
| DC gain accuracy | offset and position set to zero | |
| | > 5 mV/div | ±1.5 % |
| | ≤ 5 mV/div | ±2 % |
| Input coupling | | DC |
| Input sensitivity | entire analog bandwidth | 2 mV/div to 1 V/div |
| | supported for all input | |
| | sensitivities | |
| | in high definition mode | 1 mV/div to 1 V/div |
| Maximum input voltage | | ±5 V |
| Position range | | ±5 div |
| Offset range | input sensitivity | |
| - | > 100 mV/div | ±5 V |
| | ≤ 100 mV/div | \pm (1.5 V – input sensitivity × 5 div) |
| Offset accuracy | input sensitivity | |
| | > 100 mV/div | ±(0.35 % × net offset |
| | | + 0.1 div × input sensitivity) |
| | ≤ 100 mV/div. | $\pm (0.35 \% \times \text{ net offset })$ |
| | net offset ≤ 1 V | + 0.1 div × input sensitivity + 2 mV) |
| | $\leq 100 \text{ mV/div},$ | |
| | net offset > 1 V | ±2 % × net offset |
| | | |
| | net offset = offset - position × in | |
| DC measurement accuracy | after adequate suppression of | ±(DC gain accuracy × |
| A secold second | measurement noise | reading – net offset + offset accuracy) |
| Amplitude accuracy | DC to 90 % of analog bandwidth | |
| | ≤ 8 GHz | < 0.5 dB (typ.) |
| | > 8 GHz | < 0.75 dB (typ.) |
| Phase accuracy | maximum deviation from best fit | line |
| | over full analog bandwidth | < 3° (typ.) |
| | within any 500 MHz span | < 1° (typ.) |
| | between channels 1-3, 1-4, 2-3, | > 60 dB (typ.) |
| Channel-to-channel isolation | | |
| (each channel at same input | 2-4 | |

¹ Two channels means either channel 1 or channel 2 and either channel 3 or channel 4.

 $^{^{2}\;}$ The maximum realtime sampling rate of the high definition mode is 10 Gsample/s.

| RMS noise floor (meas.) | input sensitivity | R&S [®] RTP044B | R&S [®] RTP064B | |
|-----------------------------------|-------------------|--------------------------|--------------------------|--|
| (corresponding signal to noise | 2 mV/div | 270 μV (28.3 dB) | 340 µV (26.3 dB) | |
| ratio at full scale (calculated)) | 5 mV/div | 280 μV (36.0 dB) | 360 µV (33.8 dB) | |
| | 10 mV/div | 410 μV (38.7 dB) | 500 μV (37.0 dB) | |
| | 20 mV/div | 630 μV (41.0 dB) | 750 μV (39.5 dB) | |
| | 50 mV/div | 1.4 mV (42.0 dB) | 1.7 mV (40.3 dB) | |
| | 100 mV/div | 2.7 mV (42.3 dB) | 3.1 mV (41.1 dB) | |
| | 200 mV/div | 6.6 mV (40.6 dB) | 8.2 mV (38.7 dB) | |
| | 500 mV/div | 14 mV (42.0 dB) | 17 mV (40.3 dB) | |
| | 1 V/div | 27 mV (42.3 dB) | 32 mV (40.9 dB) | |
| | input sensitivity | R&S [®] RTP084B | R&S [®] RTP134B | |
| | 2 mV/div | 430 µV (24.3 dB) | 670 μV (20.5 dB) | |
| | 5 mV/div | 440 µV (32.1 dB) | 720 μV (27.8 dB) | |
| | 10 mV/div | 620 μV (35.1 dB) | 900 μV (31.9 dB) | |
| | 20 mV/div | 880 μV (38.1 dB) | 1.3 mV (34.7 dB) | |
| | 50 mV/div | 2.0 mV (38.9 dB) | 2.7 mV (36.3 dB) | |
| | 100 mV/div | 3.6 mV (39.8 dB) | 4.3 mV (38.3 dB) | |
| | 200 mV/div | 9.8 mV (37.2 dB) | 12 mV (35.4 dB) | |
| | 500 mV/div | 21 mV (38.5 dB) | 27 mV (36.3 dB) | |
| | 1 V/div | 36 mV (39.8 dB) | 43 mV (38.3 dB) | |
| | input sensitivity | R&S [®] RTP164B | | |
| | 2 mV/div | 840 μV (18.5 dB) | | |
| | 5 mV/div | 900 µV (25.9 dB) | | |
| | 10 mV/div | 1.15 mV (29.8 dB) | | |
| | 20 mV/div | 1.5 mV (33.5 dB) | | |
| | 50 mV/div | 3.4 mV (34.3 dB) | | |
| | 100 mV/div | 5.2 mV (36.6 dB) | | |
| | 200 mV/div | 14 mV (34.1 dB) | | |
| | 500 mV/div | 32 mV (34.8 dB) | | |
| | 1 V/div | 48 mV (37.3 dB) | | |

Horizontal system

| Timebase range | | 10 ps/div to 10 000 s/div, settable to any value within range |
|---------------------------|---|--|
| Reference position | horizontal position of trigger point | 0 % to 100 % of measurement display area |
| Horizontal position range | max. | +(memory depth/current sampling rate) |
| honzontal position range | min. | $-10000\mathrm{s}$ |
| Horizontal modes | normal mode | if timebase < 1 s/div (default value) or roll mode = off |
| | roll mode | The acquired waveform points are continuously scrolled from the right to the left of the display. Sample rates up to 20 Msample/s with a maximum record length of 40 Mpoints are supported. |
| Channel-to-channel skew | | < 10 ps (meas.) |
| Deskew range | | -100 ns to +100 ns in steps of 10 fs |
| Timebase accuracy | after delivery/calibration, at +23 °C | ±10 ppb |
| | during calibration interval | ±100 ppb |
| | long-term stability (more than one year since calibration) | $\pm(50 + 50 \times \text{years since calibration}) \text{ ppb}$ |
| Sample clock jitter | acquired time range | RMS value (meas.) |
| . , | 1 µs | 50 fs |
| | 10 µs | 63 fs |
| | 100 µs | 72 fs |
| | 1 ms | 76 fs |
| | 10 ms | 124 fs |
| Intrinsic jitter | RMS value | 200 fs (meas.) |
| Time interval error (TIE) | RMS values | $\sqrt{(\text{Noise/SlewRate})^2 + (\text{Intrinsic Jitter})^2}$ |
| Periodic jitter | RMS values | $\sqrt{2}\sqrt{(\text{Noise/SlewRate})^2 + (\text{Intrinsic Jitter})^2}$ |
| Cycle-to-cycle jitter | RMS values | $\sqrt{3}\sqrt{(\text{Noise/SlewRate})^2 + (\text{Intrinsic Jitter})^2}$ |
| Delta time accuracy | intra channel, peak-to-peak, ±5 sigma | $\pm \left(5 \cdot \sqrt{\text{TIE}_{\text{edge1}}^2 + \text{TIE}_{\text{edge2}}^2} + \right)$ |
| | | timebase accuracy · delta time) |

Acquisition system

| Realtime sampling rate | | max. 20 Gsample/s on 4 channels, |
|------------------------------------|--|---|
| | | max. 40 Gsample/s on 2 channels |
| Realtime waveform acquisition rate | max. | > 750 000 waveforms/s |
| Memory depth ³ | standard | 100 Mpoints on 4 channels |
| | | 200 Mpoints on 2 channels |
| | - | 400 Mpoints on 1 channel |
| | R&S [®] RTP-B102 option | 200 Mpoints on 4 channels |
| | | 400 Mpoints on 2 channels |
| | | 800 Mpoints on 1 channel |
| | R&S [®] RTP-B105 option | 500 Mpoints on 4 channels |
| | | 1 Gpoints on 2 channels |
| | | 2 Gpoints on 1 channel |
| | R&S [®] RTP-B110 option | 1 Gpoints on 4 channels |
| | | 2 Gpoints on 2 channels |
| | | 3 Gpoints on 1 channel |
| | R&S [®] RTP-B120 option | 2 Gpoints on 4 channels |
| | | 3 Gpoints on 2 channels |
| | | 3 Gpoints on 1 channel |
| | R&S [®] RTP-B130 option | 3 Gpoints on 4 channels |
| | | 3 Gpoints on 2 channels |
| | | |
| De altima a distital filtana | a state to far the data as wisiting and (and | 3 Gpoints on 1 channel |
| Realtime digital filters | selectable for the data acquisition and/or t | |
| | lowpass for acquisition system | cutoff frequency selectable from 100 kHz to 500 MHz |
| | lowpass for acquisition and trigger | cutoff frequency selectable from 1 GHz to |
| | system | the analog bandwidth with fine granularity |
| Decimation modes | sample | first sample in decimation interval |
| | peak detect | largest and smallest sample in decimation |
| | | interval |
| | high resolution | average value of samples in decimation |
| | | interval |
| | root mean square | root of squared average of samples in |
| | | decimation interval |
| Waveform arithmetic | off | no arithmetic |
| | envelope | envelope of acquired waveforms |
| | average | average of acquired waveforms, |
| | avolago | max. average depth depends on |
| | | decimation mode ⁴ |
| | sample | max. 16 777 215 |
| | high resolution | max. 65 535 |
| | root mean square | max. 255 |
| | • | |
| | reset condition | no reset (standard), reset by time, reset |
| | | by number of processed waveforms |
| Waveform streams per channel | | up to 3 with independent selection of |
| | | decimation mode and waveform |
| | | arithmetic |
| Sampling modes | realtime mode | max. sampling rate set by digitizer |
| | interpolated time | enhancement of sampling resolution by |
| | | interpolation; max. equivalent sampling |
| | | rate is 10 Tsample/s |
| Interpolation modes | | linear, sin(x)/x, sample & hold |
| Fast segmentation mode | continuous recording of waveforms in acq visualization | uisition memory without interruption due to |
| | max. realtime waveform acquisition rate | > 3 000 000 waveforms/s |
| | 1010 | < 350 ns |
| | min. blind time between consecutive | < 350 fis |
| | acquisitions | |
| | | up to 1.5 million acquisitions, |
| | acquisitions | |

³ The maximum available memory depth depends on the bit depth of the acquired data and, therefore, on the settings of the acquisition system, such as decimation mode, waveform arithmetic, number of waveform streams and high definition mode.

⁴ Waveform averaging is not compatible with peak detect decimation.

| History mode | accesses previous acquisitions for fur | accesses previous acquisitions for further analysis | |
|--------------|--|--|--|
| | max. recordable acquisitions | up to 1.5 million acquisitions, depending on instrument settings and memory option (R&S [®] RTP-B102/-B105/ -B110/-B120/-B130) | |
| | analysis functions | same as for the waveform of the latest acquisition: waveform measurements, mask testing, waveform math, search and mark functions, zoom and others | |
| | history player | shows one history acquisition after the other for a user definable display time (40 µs to 10 s) | |
| | timestamp formats | timestamp of each acquisition: absolute (date and time) or relative to latest acquisition | |
| | save options | all history acquisitions or a user definable subset | |

Differential signals

| General description | to separate input channels. Becau | Calculation of differential and common mode signals from p part and n part connected to separate input channels. Because of the R&S [®] RTP digital trigger concept, these signals can be used as a trigger input. | |
|--|-----------------------------------|---|--|
| Input channels | | channel 1, channel 2, channel 3, | |
| | | channel 4 | |
| Differential signal | | difference between any two input | |
| | | channels | |
| Common mode signal | | sum of any two input channels | |
| Maximum number of outputs ⁵ | differential signals | 2 | |
| | common mode signals | 2 | |

High definition mode

| General description | The high definition mode increases the numeric resolution of the waveform signal by using digital filtering, leading to a reduced noise. Because of the R&S®RTP digital trigger concept, the signals with increased numeric resolution are used as input for triggering. | |
|------------------------|---|-----------------------------------|
| Numeric resolution | bandwidth | resolution |
| | 10 kHz to 200 MHz | 16 bit |
| | 300 MHz | 12 bit |
| | 500 MHz | 12 bit |
| | 1 GHz | 11 bit |
| | 2 GHz | 10 bit |
| Realtime sampling rate | | max. 10 Gsample/s on each channel |

⁵ Together with R&S[®]RTP-K122 realtime deembedding extension, only one output can be calculated, differential or common mode.

Trigger system

| Sources | | channel 1, channel 2, channel 3, |
|---------------------|--|---|
| | | channel 4, inverted channels, external |
| | | trigger, line trigger, differential, common |
| | | mode |
| Trigger bandwidth | max. | same bandwidth as analog bandwidth for |
| | | all vertical scales and trigger types |
| | user-defined | 1 GHz to analog bandwidth |
| Trigger sensitivity | | 0.0001 div, from DC to analog bandwidth |
| | | for all vertical scales and trigger types |
| Trigger hysteresis | modes | auto (standard) or manual |
| | sensitivity | 0.0001 div, from DC to analog bandwidth |
| | | for all vertical scales and trigger types |
| Trigger jitter | full-scale sine wave of frequency set to | < 80 fs (RMS) (meas.) |
| | -3 dB bandwidth | |
| Sweep mode | | auto, normal, single, n single |
| Event rate | max. | one event for every 200 ps time interval |
| Trigger level range | internal | ±5 div from center of screen |
| | external | see External trigger input |
| Holdoff range | time | 100 ns to 10 s, fixed and random |
| - | events | 1 event to 2 000 000 000 events |

| Main trigger modes | | | | |
|--------------------|---|---|--|--|
| Edge | triggers on specified slope (positive, negative or either) and level | | | |
| Glitch | triggers on glitches of positive specified width | triggers on glitches of positive, negative or either polarity that are shorter or longer than | | |
| | glitch width | 25 ps to 10 000 s | | |
| Width | triggers on positive or negative inside or outside the interval | ve pulse of specified width; width can be shorter, longer, | | |
| | pulse width | 25 ps to 10 000 s | | |
| Runt | triggers on pulse of positive, | negative or either polarity that crosses one threshold but | | |
| | fails to cross a second thresh | old before crossing the first one again; runt pulse width | | |
| | can be arbitrary, shorter, long | ger, inside or outside the interval | | |
| | runt pulse width | 25 ps to 10 000 s | | |
| Window | | r exits a specified voltage range; triggers also when signal | | |
| | stays inside or outside the vo | stays inside or outside the voltage range for a specified period of time | | |
| Timeout | triggers when signal stays high | gh, low or unchanged for a specified period of time | | |
| | timeout | 25 ps to 10 000 s | | |
| Interval | triggers when time between two consecutive edges of same slope (positive or | | | |
| | negative) is shorter, longer, inside or outside a specified range | | | |
| | interval time | 25 ps to 10 000 s | | |
| Slew rate | triggers when the time require | ed by a signal edge to toggle between user-defined upper | | |
| | and lower voltage levels is shorter, longer, inside or outside the interval; edge slope | | | |
| | may be positive, negative or | may be positive, negative or either | | |
| | toggle time | 25 ps to 10 000 s | | |
| Data2clock | triggers on setup time and ho | Id time violations between clock and data present on any | | |
| | two input channels; monitored time interval may be specified by the user in the range | | | |
| | from -100 ns to 100 ns around a clock edge and must be at least 100 ps wide | | | |
| Pattern | triggers when a logical combination (and, nand, or, nor) of the input channels stays true | | | |
| | for a period of time shorter, longer, inside or outside a specified range | | | |
| State | State triggers when a logical combination (and, nand, or, nor) of the input of | | | |
| | at a slope (positive, negative | at a slope (positive, negative or either) in one selected channel | | |

| Advanced trigger modes | | | |
|----------------------------------|--|---|--|
| Trigger qualification | trigger events may be qualified by a logical combination of unused channels | | |
| | qualifiable events | edge, glitch, width, runt, window, timeout, interval | |
| Sequence trigger (A/B/R trigger) | triggers on B event after occurrence of A event; delay condition after A event specified either as time interval or number of B events; an optional R event resets the trigger sequence to A | | |
| | A event | any trigger mode | |
| | B event | edge, glitch, width, runt, window, timeout, interval, slew rate | |
| | R event | edge, glitch, width, runt, window, timeout, interval, slew rate | |
| Zone trigger | | with R&S [®] RTP-K19 option | |
| CDR trigger | | with R&S®RTP-K136/-K137 option | |
| External trigger input | input impedance | 50 Ω (nom.) | |
| | max. input voltage | 5 V (RMS) | |
| | trigger level range | ±5 V | |
| | sensitivity, for input frequency ≤ 500 MHz | 300 mV (peak-to-peak) | |
| | input coupling | 50 Ω, GND, HF reject (attenuates > 50 kHz), LF reject (attenuates < 50 kHz) | |
| | trigger modes | edge (rise or fall) | |
| Trigger out | functionality | a pulse is generated for every acquisition trigger event | |
| | output voltage | 0 V to 5 V at high impedance | |
| | | 0 V to 2.5 V at 50 Ω | |
| | pulse width | selectable between 4 ns and 60 ms | |
| | pulse polarity | low active or high active | |
| | output delay | depends on trigger settings | |
| | jitter | ±40 ps (RMS) (meas.) | |

RF characteristics ⁶

| Sensitivity/noise density | at 1.001 GHz | –157 dBm (1 Hz) (meas.) |
|-----------------------------------|--|-------------------------|
| | (measurement of the power spectral | |
| | density at 1.001 GHz at input sensitivity | |
| | 2 mV/div, corresponding to –30 dBm input | |
| | range of the oscilloscope, using the FFT | |
| | with center frequency 1.001 GHz, span | |
| | 500 kHz, RBW 3 kHz) | |
| Noise figure | at 1.001 GHz | 17 dB (meas.) |
| Noise lighte | (calculated based on the noise density | |
| | above) | |
| Dynamic range | measured for an input carrier with | 107 dB (meas.) |
| Dynamic range | frequency 1 GHz and level –1 dBm at | TOT UD (meas.) |
| | input sensitivity 70 mV/div, corresponding | |
| | to 0 dBm input range of the oscilloscope, | |
| | using the FFT with center frequency | |
| | | |
| | 1 GHz, span 100 MHz, RBW 400 Hz at | |
| Abaaluta amalituda aaauraay | +20 MHz from the center frequency | |
| Absolute amplitude accuracy | input frequency | (0.25 dD (mass)) |
| | ≤ 12 GHz | ±0.25 dB (meas.) |
| Dhasa asias | > 12 GHz to ≤ 15 GHz | ±0.5 dB (meas.) |
| Phase noise | at 1 GHz | |
| | 10 kHz offset | -118 dBc (1 Hz) (meas.) |
| | 100 kHz offset | –126 dBc (1 Hz) (meas.) |
| EVM | 802.11, 20 MHz bandwidth, 64QAM | |
| | 802.11n, 2.4 GHz carrier | -46 dB (meas.) |
| | 802.11ac, 5.7 GHz carrier | -44 dB (meas.) |
| Spurious-free dynamic range | measured for an input carrier with | 66 dB (meas.) |
| (excl. harmonics) | frequency 950 MHz and level –1 dBm at | |
| | input sensitivity 70 mV/div, corresponding | |
| | to 0 dBm input range of the oscilloscope, | |
| | using the FFT with center frequency | |
| | 3 GHz, span 5 GHz, RBW 100 kHz | |
| Second harmonic distortion | measured for an input carrier with | –52 dBc (meas.) |
| | frequency 950 MHz and level –1 dBm at | |
| | input sensitivity 70 mV/div, corresponding | |
| | to 0 dBm input range of the oscilloscope, | |
| | using the FFT with center frequency | |
| | 3 GHz, span 5 GHz, RBW 100 kHz | |
| Third harmonic distortion | measured for an input carrier with | –43 dBc (meas.) |
| | frequency 950 MHz and level –1 dBm at | |
| | input sensitivity 70 mV/div, corresponding | |
| | to 0 dBm input range of the oscilloscope, | |
| | using the FFT with center frequency | |
| | 3 GHz, span 5 GHz, RBW 100 kHz | |
| Third order intercept point (TOI) | measured for two input tones with | 23.5 dBm (meas.) |
| | frequencies 2.436 GHz and 2.438 GHz | |
| | and level 0 dBm at input sensitivity | |
| | 160 mV/div, corresponding to 8 dBm input | |
| | range of the oscilloscope, | |
| | using the FFT with center frequency | |
| | 2.437 GHz, span 10 MHz, RBW 30 kHz | |
| Input VSWR | input frequency | |
| | ≤ 4 GHz | 1.25 (meas.) |
| | > 4 GHz to ≤ 16 GHz | 1.4 (meas.) |

⁶ The RF characteristics are measured for an R&S[®]RTP164B oscilloscope with 16 GHz bandwidth at zero offset.

Waveform measurements

| General features | measurement panels | up to 8 measurement panels; each panel may contain any number of automatic measurements of the same category |
|----------------------|--------------------|---|
| | gate | delimits the display region evaluated for |
| | | automatic measurements |
| | reference levels | user-configurable vertical levels define support structures for automatic measurements |
| | statistics | displays maximum, minimum, mean, standard deviation, RMS and measurement count for each automatic |
| | track | measurement measurement results displayed as continuous trace that is time-correlated to |
| | | the measurement source |
| | long-term analysis | history of selected measurements as trace against count index |
| | histogram | available for the main measurement of |
| | | each measurement panel; automatic or manual selection of bin number and scale; counters for measurements under, within |
| | Party also als | and over the histogram range |
| | limit check | measurements tested against user- defined margins and limits; pass or fail conditions may launch automatic |
| | | response: acquisition stop, beep, print |
| •• | | and save waveform |
| Measurement category | amplitude and time | amplitude, high, low, maximum, minimum, peak-to-peak, mean, RMS, sigma, |
| | | overshoot, area, rise time, fall time, positive width, negative width, period, |
| | | frequency, duty cycle, delay, phase, burst width, pulse count, positive switching, |
| | | negative switching, cycle area, cycle mean, cycle RMS, cycle sigma, |
| | | setup/hold time, setup/hold ratio, pulse |
| | | train, slew rate rising, slew rate falling, |
| | | DC voltmeter (requires Rohde & Schwarz active probe with R&S [®] ProbeMeter |
| | | functionality) |
| | eye diagram | extinction ratio, eye height, eye width, eye top, eye base, crossing points, Q factor, |
| | | Noise (RMS), S/N ratio, duty cycle |
| | | distortion, eye rise time, eye fall time, eye bit rate, eye amplitude, jitter (peak-to- peak, 6-sigma, RMS) |
| | optical | optical average power, optical modulation amplitude |
| | spectrum | channel power, bandwidth, occupied bandwidth, harmonic search, total |
| | | harmonic distortion THD in dB and % using power values, total harmonic |
| | | distortion variants THD _a , THD _u and THD _r using voltage, overall voltage and overall |
| | | voltage root means square, peak list (THD _a , THD _u , THD _r and peak list require R&S [®] RTP-K37 option) |
| | jitter | cycle-to-cycle jitter, N-cycle jitter, cycle-to- |
| | | cycle width, cycle-to-cycle duty cycle, |
| | | time-interval error, data rate, unit interval, skew delay, skew phase; requires |

| Cursors | setup | up to 4 cursor sets on screen, each set consisting of two horizontal and two vertical cursors |
|-----------|------------------------|--|
| | target | acquired waveforms (input channels), math waveforms, reference waveforms, track waveforms, XY diagrams |
| | operating mode | vertical measurements, horizontal measurements or both; vertical cursors either set manually or locked to waveform |
| Histogram | source | acquired waveform (input channels), math waveform, reference waveform |
| | mode | vertical (for timing statistics), horizontal (for amplitude statistics) |
| | automatic measurements | waveform count, waveform samples, histogram samples, histogram peak, peak value, maximum, minimum, median, range, mean, sigma, mean ± 1, 2 and 3 sigma, marker ± probability |

Mask testing

| Test definition | number of masks | up to 8 simultaneously |
|---|------------------------------------|---|
| | source | acquired waveforms (input channels), math waveforms |
| | fail condition | sample hit or waveform hit |
| | fail tolerance | minimum number of fail events for test fail in range from 0 to 4 000 000 000 |
| | test rate | up to 600 000 waveforms/s |
| | action on error | acquisition stop, beep, print and save waveform |
| | save/load to file | test and mask settings (.xml format) |
| Mask definition with segments | number of independent segments | up to 8 |
| | segment definition | array of points and connecting rule (upper, lower, inner) define segment region |
| | segment input | point and click on touchscreen, editable list |
| Mask definition with tolerance tube | input signal | acquired waveform |
| | definition of tolerance tube | horizontal width, vertical width, vertical stretch, vertical position |
| Mask definition with eye mask assistant | primary mask shape | stretch, ventical position |
| (requires one of the following options: | type | diamond, square, hexagon, octagon |
| R&S [®] RTP-K12/-K91/-K93/-K133/-K134/ -K136/-K137) | dimensions | main and secondary height, main and secondary width, depending on selected shape |
| | position | vertical offset, horizontal offset |
| | secondary mask shapes | |
| | locations | any combination of left, right, top, bottom |
| | position | horizontal and vertical offset with respect to center of primary mask shape |
| Serial standard masks | multiple predefined protocol masks | D-PHY, M-PHY, C-PHY, PCIe, USB, HDMI™, JESD204C, ITU and Ethernet |
| Result statistics | category | completed acquisitions, remaining acquisitions, state, sample hits, mask hits, fail rate, test result (pass or fail) |
| Visualization options | waveform style | vectors, dots |
| | violation highlighting | hits (on/off), highlight persistence (50 ms to 50 s or infinite), waveform color (default: red) |
| | mask colors | configurable colors for mask without violation (default: translucent gray), mask with violation (default: translucent red), mask with contact (default: translucent pale red) |

Waveform math

| General features | number of math waveforms | up to 8 |
|-----------------------|-------------------------------------|---|
| | number of reference waveforms | up to 4 |
| | waveform arithmetic | user-selectable average or envelope of |
| | | consecutive waveforms |
| Algebraic expressions | user may define complex mathematica | al expressions involving waveforms and |
| | measurement results | |
| | math functions | add, subtract, multiply, divide, absolute |
| | | value, square, square root, integrate, |
| | | differentiate, exp, log ₁₀ , log _e , log ₂ , rescale, |
| | | sin, cos, tan, arcsin, arccos, arctan, sinh, |
| | | cosh, tanh, autocorrelation, |
| | | crosscorrelation |
| | logical operators | not, and, nand, or, nor, xor, nxor |
| | relational operators | Boolean result of =, \neq , >, <, ≤, ≥ |
| | frequency domain | spectral magnitude and phase, real and imaginary spectra, group delay |
| | digital filter | lowpass, highpass or user-defined filter (specified by up to 1 million FIR filter coefficients) |
| | special functions | CDR transform; requires R&S [®] RTP-K12 option |
| Optimized math | operators | add, subtract, multiply, invert, absolute value, differentiate, log ₁₀ , log _e , log ₂ , rescale, FIR, FFT magnitude |

Spectrum analysis

| General description | spectrum analysis allows signal analysis in the frequency domain | |
|---------------------|--|--|
| Spectrum | sources | channel 1, channel 2, channel 3, channel 4 |
| | spectrum types | magnitude spectrum, phase spectrum |
| | setup parameters | center frequency, frequency span, automatic RBW, resolution bandwidth, |
| | | gate position, gate width, vertical scale, vertical position, frame overlap |
| | scaling | volucial position, name overlap |
| | magnitude spectrum | linear, dB, dBm, dBµV, dBmV, dBV, dBps dBns, dBµs, dBms, dBs, dBHz, dBkHz, dBMHz, dBGHz, dBµA, dBmA, dBA |
| | phase spectrum | degrees, radians |
| | frequency range | DC to Nyquist frequency (1/2 sample rate e.g. 20 GHz at 40 Gsample/s) |
| | frequency axis scaling | linear or logarithmic |
| | span | 1 Hz to 20 GHz |
| | resolution bandwidth | ≤ 1 Hz to 2 GHz |
| | window types | rectangular, Hamming, Hann, Blackman Harris, Gaussian, Flattop, Kaiser Bessel |
| | trace types | normal, envelope, average, RMS, min. hold, max. hold |
| | spectrum measurements | channel power, bandwidth, occupied bandwidth, various THD variants (total |
| | | harmonic distortion), harmonic search, peak list (with user definable threshold) |
| | max. realtime waveform acquisition rate | > 1000 waveforms/s |
| | spectrogram | requires R&S [®] RTP-K37 option |

Search and mark function

| General description | scans acquired waveforms for oc highlights each occurrence | currence of a user-defined set of events and | |
|----------------------|---|--|--|
| Basic setup | source | all physical input channels, math waveforms, reference waveforms | |
| | search panels | up to 8, where each panel may manage multiple event searches | |
| | search mode | manually triggered or continuous | |
| | search conditions | | |
| | supported events | edge, glitch, width, runt, window, timeout, interval, slew rate, data2clock, state | |
| | event configuration | identical to corresponding trigger event | |
| | event selection | single or multiple events on same source | |
| Search oscilloscope | mode | current waveform, gated time interval | |
| Result visualization | table | | |
| | sort mode | horizontal position or vertical value | |
| | max. result count | specifies max. table size | |
| | zoom window | centered on highlighted event | |

Display characteristics

| Diagram types | Yt, XY, spectrum, long-term measurement, spectrogram (spectrogram requires R&S [®] RTP-K37 option) | |
|---------------------------------|--|--|
| Horizontal divisions | 10 | |
| Vertical divisions | 10 | |
| Display interface configuration | display area can be split up into separate diagram areas by dragging and dropping signal icons; | |
| | each diagram area can hold any number of signals; | |
| | diagram areas may be stacked on top of each other and later accessed via the dynamic tab menu | |
| Signal icon | each active waveform is represented by a separate signal icon on the signal bar; the signal icon displays individual vertical and acquisition settings; a waveform can be minimized to signal icon to appears as a realtime preview in miniature; measurement results may also be minimized to a signal icon | |
| Toolbar | quick access to 28 important tools; directly set most common parameters in a simple menu and access to more detailed parameters in main menu; user-defined selection of tools in toolbar | |
| Upper menu | displays trigger, horizontal and acquisition settings; quick access to settings | |
| Main menu | provides access to all instruments settings in compact menu | |
| Axis label | X-axis ticks and Y-axis ticks labeled with tick value and physical unit | |
| Diagram label | diagrams may be individually labeled with a descriptive user-defined name | |
| Diagram layout | grid, crosshair, axis labels and diagram label may be switched on and off separately | |
| Persistence | 50 ms to 50 s, or infinite | |
| Zoom | user-defined zoom window provides vertical and horizontal zoom; | |
| | each diagram area supports multiple zoom windows; | |
| | touchscreen interface simplifies resize and drag operations on zoom window | |
| Signal colors | predefined or user-defined color tables for persistence display | |

Input and output

| Front | | |
|---------------------------|-----------------|---|
| Channel inputs | | BNC-compatible, |
| | | for details see Vertical system |
| | probe interface | auto-detection of passive probes, |
| | | Rohde & Schwarz active probe interface |
| External trigger input | | BNC, |
| | | for details see Trigger system |
| | probe interface | auto-detection of passive probes, |
| | | Rohde & Schwarz active probe interface |
| Probe compensation output | signal shape | rectangle, $V_{low} = 0 V$, $V_{high} = 1 V$ |
| | | amplitude 1 V (V _{pp}) ± 5 % |
| | frequency | 1 kHz ± 1 % |
| | impedance | 50 Ω (nom.) |
| Ground jack | | 4 mm, connected to ground |
| USB interface | | 2 ports, type A plug, version 3.1 gen 1 |
| Option slots | | 2 |

| Rear | | |
|----------------------------|-----------------------|--|
| Trigger out | | BNC, |
| | | for details see Trigger system |
| USB interface | | 2 ports, type A plug and |
| | | 1 port, type B plug, version 3.1 gen 1 |
| LAN interface | | RJ-45 connector, |
| | | supports 10/100/1000BASE-T |
| External monitor interface | | HDMI [™] 2.0 and DisplayPort++ 1.3, |
| | | output of oscilloscope display or extended |
| | | desktop display |
| GPIB interface | function | interface in line with IEC 625-2 |
| | | (IEEE 488.2) |
| | command set | SCPI 1999.0 |
| | connector | IEEE-488 24-pin Amphenol female |
| | interface functions | SH1, AH1, T6, L4, SR1, RL1, PP1, DC1, |
| | | DT1, C0 |
| External reference input | connector | BNC female |
| | impedance | 50 Ω (nom.) |
| | input frequency range | 1 MHz to 20 MHz in steps of 1 MHz |
| | sensitivity | ≥ 0 dBm into 50 Ω |
| Reference output 10 MHz | connector | BNC female |
| | impedance | 50 Ω (nom.) |
| | level | > 7 dBm |
| Auxiliary output | | SMA connector, for future use |
| Digital data interface 40G | | QSFP+ connector, for future use |
| Option slots | | 2 |
| Security slot | | for standard Kensington style lock |

General data

| Display | type | 13.3" LC TFT color display with capacitive |
|---------------------------|---------------------------------------|---|
| | resolution | touchscreen 1920 × 1080 pixel (Full HD) |
| Operating system | | Windows 10 64-bit |
| Hard disk drive | | ≥ 256 Gbyte removeable SSD |
| | | · · · · |
| Temperature | operating | +5 °C to +45 °C |
| | non-operating | -40 °C to +70 °C, |
| | | in line with MIL-PRF-28800F section 4.5.5.1.1.1 class 3 |
| Humidity | | +25° C/+40 °C at 85 % rel. humidity |
| Tarmany | | cyclic, in line with IEC 60068-2-30 |
| | | +30 °C/+40 °C/+45 °C at |
| | | 95 %/75 %/45 %, |
| | | in line with MIL-PRF-28800F section |
| A 1.12 | | 4.5.5.1.1.2 class 3 for operation |
| Altitude | operating | up to 3000 m/9 843 ft above sea level |
| Vibration | non-operating operating | up to 4600 m/15 093 ft above sea level sinusoidal: |
| | opolating | 5 Hz to 150 Hz, max. 1.8 g at 55 Hz, |
| | | 0.5 g from 55 Hz to 150 Hz, |
| | | in line with EN 60068-2-6 |
| | | random: |
| | | 8 Hz to 500 Hz, acceleration 1.2 g (RMS) |
| | non operating | in line with EN 60068-2-64 shock: |
| | non-operating | 40 g shock spectrum, |
| | | in line with MIL-STD-810E, |
| | | method no. 516.4, procedure I |
| | | |
| EMC | | |
| RF emission | | in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); |
| | | the instrument complies with the emission |
| | | requirements stipulated by EN 55011, |
| | | EN 61326-1 and EN 61326-2-1 class A, |
| | | making the instrument suitable for use in |
| har an an Mari | | industrial environments |
| Immunity | | in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial |
| | | environment ⁷ |
| Certifications | | VDE, _C CSA _{US} , CE, KC, UKCA, RCM |
| Calibration interval | | 1 year |
| Demen ermulu | | |
| Power supply AC supply | | 100 V to 240 V at 50 Hz to 60 Hz, |
| | | 100 V to 130 V at 400 Hz, |
| | | max. 13 A to 4.7 A, |
| | | in line with MIL-PRF-28800F section 3.5 |
| Power consumption | | max. 1000 W |
| Safety | | in line with IEC 61010-1, EN 61010-1, CAN/CSA-C22.2 No. 61010-1, UL 61010-1 |
| Mechanical data | | |
| Dimensions (W × H × D) | with R&S [®] RTP-B20 handles | 463 mm × 285 mm × 349 mm |
| | | (18.23 in × 11.22 in × 13.74 in) |
| | with shock protection | 441 mm × 285 mm × 316 mm |
| Maiabt | without options, nominal | (17.36 in × 11.22 in × 12.44 in) |
| | | |

⁷ Test criterion is displayed noise level within ±1 div for input sensitivity of 5 mV/div.

without options, nominal

Weight

18.0 kg (39.68 lb)

Options

R&S®RTP-B1 mixed signal option

Mixed signal option, additional 16 logic channels

Vertical system

| Input channels | | 16 logic channels (D0 to D15) |
|-------------------------------|---|--|
| Arrangement of input channels | | arranged in two logic probes with |
| | | 8 channels each, assignment of the logic |
| | | probes to the channels (D0 to D7 or |
| | | D8 to D15) is displayed on the probe |
| DC input resistance | at probe tips | 100 kΩ ± 2 % (meas.) |
| Input capacitance | | 4 pF (meas.) |
| Maximum input frequency | signal with minimum input voltage swing | 400 MHz (meas.) |
| | and hysteresis setting: normal | |
| Maximum input voltage | | ±40 V (V _p) |
| Minimum input voltage swing | | 500 mV (V _{pp}) (meas.) |
| Input dynamic range | | ±8.5 V (meas.) |
| Resolution | | 1 bit |
| Threshold groups | | D0 to D3, D4 to D7, D8 to D11 and |
| | | D12 to D15 |
| Threshold level | range | ±8 V in steps of 25 mV |
| | predefined | CMOS 5.0 V, CMOS 3.3 V, CMOS 2.5 V, |
| | | TTL, ECL, PECL, LVPECL |
| Threshold accuracy | threshold setting between ±4 V | ±(100 mV + 3 % of threshold setting) |
| - | - | (meas.) |
| Comparator hysteresis | | normal, robust, maximum |

Horizontal system

| Channel deskew | range for each channel | ±200 ns in steps of 200 ps |
|-------------------------|------------------------|----------------------------|
| Channel-to-channel skew | | < 500 ps (meas.) |

Acquisition system

| Sampling rate | max. | 5 Gsample/s on each channel |
|------------------------------------|-------------------------|-----------------------------------|
| Realtime waveform acquisition rate | max. | > 200 000 waveforms/s |
| Memory depth | at max. sampling rates | 200 Mpoints for every channel |
| | at lower sampling rates | 100 Mpoints for every channel |
| Decimation | | pulses lost due to decimation are |
| | | displayed |
| Minimum detectable pulse width | | 500 ps (meas.) |

Trigger system

| Holdoff range | time | 100 ns to 10 s, fixed and random |
|---------------|--------|----------------------------------|
| | events | 1 event to 2 000 000 000 events |

| Trigger modes | | |
|---------------|----------------------------------|--|
| Edge | triggers on specified slope (pos | sitive, negative or either) in the source signal |
| | sources | any channel from D0 to D15 or any logical |
| | | combination of D0 to D15 |
| Width | triggers on positive or negative | e pulse of specified width in the source signal; width can |
| | be shorter, longer, equal, insid | e or outside the interval |
| | sources | any channel from D0 to D15 or any logical |
| | | combination of D0 to D15 |
| | pulse width | 200 ps to 10 s |
| Timeout | triggers when the source signa | al stays high, low or unchanged for a specified period of |
| | time | |
| | sources | any channel from D0 to D15 or any logical |
| | | combination of D0 to D15 |
| | timeout | 200 ps to 10 s |

| Data2clock | signal; monitored time interval | triggers on setup time and hold time violations between a clock signal and a data signal; monitored time interval with a max. width of 200 ns and a position of max. ±1 µs relative to the clock edge | | |
|--------------------|---|---|--|--|
| | data signal | any subset of channels from D0 to D15 or any user-defined bus signal | | |
| | clock signal | any channel from D0 to D15 | | |
| Pattern | triggers when the source goes equal, inside or outside a speci | true or stays true for a period of time shorter, longer, ified range | | |
| | sources | any logical combination of D0 to D15 or any user-defined bus signal | | |
| | pulse width | 200 ps to 10 s | | |
| State | triggers on the slope (positive, matches a user-defined logical | negative or either) of the clock signal when data signal state | | |
| | data signal | any logical combination of D0 to D15 or any user-defined bus signal | | |
| | clock signal | any channel from D0 to D15 | | |
| Serial pattern | triggers on a serial data pattern of up to 32 bit; pattern bits may be high (H), low (L) or don't care (X); clock edge slope may be positive, negative or either | | | |
| | data signal | any channel from D0 to D15 or any logical combination of D15 to D15 | | |
| | clock signal | any channel from D0 to D15 | | |
| | max. data rate | 1 Gbps | | |
| Serial bus trigger | optional | dedicated software options | | |
| | sources | any channel from D0 to D15 | | |

Waveform measurements

| General features | measurement panels, gate, statistics, |
|----------------------------|---|
| | long-term analysis and limit check; see |
| | features of the base unit |
| Measurement sources | all channels from D0 to D15 or any logical |
| | combination of D0 to D15 |
| Automatic measurements | positive pulse width, negative pulse width, |
| | period, frequency, burst width, delay, |
| | phase, positive duty cycle, negative duty |
| | cycle, positive pulse count, negative pulse |
| | count, rising edge count, falling edge |
| | count |
| Additional cursor function | display of decoded bus value at the cursor |
| | position |

Waveform math

| Function any logical combination of D0 to D15 | |
|---|--|
|---|--|

Search and mark functions

The search function will be available in a future software release.

Display characteristics

| Display of logical channels | | selectable size and position on screen, |
|-----------------------------|---------------------------------|--|
| | | diagram configuration by dragging and |
| | | dropping signal icons |
| Bus decode | number of bus signals | 4 |
| | bus types | unclocked and clocked |
| | display types | decoded bus, logical signal, bus + logical signal, amplitude signal, amplitude + logical signal, tabulated list (decoded time interval selected with cursors) |
| | position and size | size and position on screen selectable |
| | data format of decoded bus | hex, unsigned integer, signed integer, fractional, binary |
| | data format of amplitude signal | unsigned integer, signed integer, fractional, binary offset |
| Channel activity display | | independent of the oscilloscope acquisition, the state (stays low, stays |
| | | high or toggles) of the channels from D0 to D15 is displayed in the signal icon |

R&S®RTP-B6 arbitrary waveform generator

Arbitrary function/waveform generator, 2 analog channels, 8-bit pattern generator

Analog channels

| General | |
|---------------------|---|
| Output channel | 2 channels |
| Vertical resolution | 14 bit |
| Operating modes | function generator, arbitrary waveform generator, modulation, frequency sweep |

| Function generator | output of predefined waveforms | EQO Maampla/a | |
|--|---|---|--|
| Sample rate | | 500 Msample/s | |
| Waveforms | sine, square, ramp, DC, noise, pulse, ca Lorentz, exponential rise, exponential fa | | |
| Sine | frequency range | 1 mHz to 100 MHz in steps of 1 mHz | |
| | amplitude flatness (relative to 1 kHz) | | |
| | f ≤ 100 kHz | ≤ ±0.1 dB | |
| | 100 kHz < f ≤ 60 MHz | ≤ ±0.3 dB | |
| | 60 MHz < f ≤ 100 MHz | ≤ ±0.5 dB | |
| | total harmonic distortion (THD at 1 V (V | _{oo}) into 50 Ω) | |
| | f ≤ 100 kHz | ≤ -70 dBc (= THD ≤ 0.032 %) | |
| | 100 kHz < f ≤ 15 MHz | ≤ –55 dBc | |
| | 15 MHz < f ≤ 35 MHz | ≤ –40 dBc | |
| | 35 MHz < f ≤ 100 MHz | ≤ –30 dBc | |
| | nonharmonic spurious (1 V (V _{pp}) | -65 dBc (meas.) | |
| | into 50 Ω) | 00 020 (measi) | |
| | phase noise (meas.) | | |
| | f ≤ 25 MHz | ≤ –105 dBc (1 Hz) at 1 kHz offset, | |
| | | ≤ –115 dBc (1 Hz) at 10 kHz offset, | |
| | | ≤ –125 dBc (1 Hz) at 100 kHz offset | |
| | 25 MHz < f ≤ 100 MHz | ≤ –105 dBc (1 Hz) at 1 kHz offset, | |
| | | ≤ –110 dBc (1 Hz) at 10 kHz offset, | |
| | | ≤ –115 dBc (1 Hz) at 100 kHz offset | |
| Square, pulse | frequency range | 1 mHz to 30 MHz in steps of 1 mHz | |
| | duty cycle (if pulse width limit is not | 0.01 % to 99.99 % in steps of 0.01 % | |
| | exceeded) | | |
| | duty cycle accuracy (meas.) | 1 | |
| | 50 % duty cycle | ≤ 0.001 % or ≤ 100 % · 150 ps · f | |
| | | whichever is larger | |
| | | f = frequency of square/ pulse signal | |
| | any duty cycle | $\leq 0.5\%$ | |
| | pulse width | ≥ 16.5 ns in steps of 0.1 ns | |
| | rise/fall time | | |
| | $f \le 10 \text{ Hz}$ | 90 µs (meas.) | |
| | $10 \text{ Hz} < f \le 30 \text{ MHz}$ | 9 ns (meas.) | |
| | overshoot | ≤ 2 % | |
| | jitter (cycle-to-cycle) | ≤ 40 ps (RMS) (meas.) | |
| Ramp (triangle, sawtooth) | frequency range | 1 mHz to 1 MHz in steps of 1 mHz | |
| | linearity | $\leq 0.1 \%$ (meas.) | |
| | · · · · · · · · · · · · · · · · · · · | 0 % to 100 % in steps of 0.1 % | |
| DC | variable symmetry | | |
| | level range into 50 Ω | (2)/(2) | |
| | | $\pm [3 V - (noise amplitude [V_{pp}] / 2)]$ | |
| Noise | into open circuit | \pm [6 V – (noise amplitude [V _{pp}] / 2)] | |
| 110126 | amplitude | $0 \rangle (to 6) \langle () \rangle \rangle$ (into 50 0) | |
| | DC | 0 V to 6 V (V_{pp}) (into 50 Ω), | |
| | | 0 V to 12 V (V_{pp}) (into open circuit), | |
| | | 4 digits resolution | |
| | all other waveforms | 0 % to 100 % of AC signal amplitude, 1 % resolution | |
| | bandwidth | ≥ 100 MHz | |
| | | 1 mHz to 5 MHz | |
| Cardinal sine (sinc) | | | |
| | frequency range | | |
| Cardiac | frequency range | 1 mHz to 1 MHz | |
| Cardinal sine (sinc) Cardiac Gauss (Gaussian pulse) Lorentz | | | |

| Arbitrary waveform generator | output of user-defined waveforms | |
|------------------------------|----------------------------------|---------------------------------------|
| Waveform length | | 1 point to 40 Mpoints on each channel |
| Sample rate | | 1 sample/s to 250 Msample/s |
| Filter bandwidth | | 100 MHz |

| Modulation | | |
|------------------|-----------------------------------|---|
| Sample rate | | 500 Msample/s |
| Modulation types | | amplitude modulation (AM), frequency modulation (FM), frequency-shift key modulation (FSK), pulse width modulation (PWM) |
| Carrier waveform | AM, FM, FSK | sine |
| | PWM | square/pulse |
| AM | carrier frequency | 1 mHz to 100 MHz |
| | modulation signals | sine, square, ramp (triangle, sawtooth) |
| | modulation frequency | 1 mHz to 1 MHz |
| | modulation depth | 0 % to 100 % in steps of 0.1 % |
| FM | carrier frequency | 1 mHz to 100 MHz |
| | modulation signals | sine, square, ramp (triangle, sawtooth) |
| | modulation frequency | 1 mHz to 1 MHz |
| | frequency deviation | 1 mHz to 10 MHz |
| FSK | modulation signal | 50 % duty cycle square wave |
| | range of frequency 1, frequency 2 | 1 mHz to 100 MHz |
| | hop rate | 1 mHz to 1 MHz |
| PWM | carrier frequency | 1 mHz to 30 MHz |
| | modulation signals | sine, square, ramp (triangle, sawtooth) |
| | modulation frequency | 1 mHz to 1 MHz |
| | modulation depth | 0 % to 99.99 % of the duty cycle, |
| | | 0.01 % resolution |

| Frequency sweep | | output of a sinusoidal waveform with the frequency changing linearly between the start frequency and the stop frequency within the sweep time | |
|-----------------|-----------------|---|--|
| | sample rate | 500 Msample/s | |
| | waveform | sine | |
| | frequency range | 1 mHz to 100 MHz | |
| | direction | up (start frequency < stop frequency) | |
| | | down (start frequency > stop frequency) | |
| | sweep time | 1 ms to 500 s | |

| Two-channel operation | operating modes | independent channels, coupled parameters, differential |
|-----------------------|-----------------------------------|---|
| | parameter coupling | none, frequency and/or amplitude |
| | relative phase | -180° to 180° in steps of 0.1° |
| | channel-to-channel skew | ≤ 200 ps (meas.) |
| | channel-to-channel isolation | |
| | (each channel with same output am | nplitude) |
| | f ≤ 10 MHz | ≥ 60 dB (meas.) |
| | 10 MHz < f ≤ 100 MHz | ≥ 40 dB (meas.) |

| Outputs | | |
|------------------------------|------------------------------------|--|
| Connectors | | BNC female on the rear panel |
| Function | | on, off, inverted |
| Output impedance | | 50 Ω (nom.) |
| Overload protection | | a short-circuit to ground is tolerated |
| | | indefinitely, |
| | | automatic shutoff in case of voltages |
| | | \geq +7 V or \leq -7 V (meas.), |
| | | automatic shutoff in case of overcurrent, |
| | | max20 V to +20 V without damage |
| | | (meas.), ESD protection |
| Amplitude range ⁸ | sine, square, ramp, pulse, expor | |
| 1 3 | into 50 Ω | 10 mV to 6 V (V _{pp}) |
| | | (frequency \leq 50 MHz), |
| | | 10 mV to 4 V (V_{pp}) |
| | | (frequency > 50 MHz) |
| | into open circuit | $20 \text{ mV to } 12 \text{ V } (\text{V}_{\text{pp}})$ |
| | opon onoun | (frequency \leq 50 MHz), |
| | | $20 \text{ mV to 8 V (V_{pp})}$ |
| | | (frequency > 50 MHz) |
| | cardinal sine (sinc), cardiac | |
| | into 50 Ω | 10 mV to 3 V (V _{pp}) |
| | into open circuit | 20 mV to 6 V (V _{pp}) |
| | Gauss (Gaussian pulse), Lorent | |
| | into 50 Ω | 10 mV to 2.5 V (V _{pp}) |
| | into open circuit | 1000000000000000000000000000000000000 |
| | | |
| | arbitrary waveforms into 50 Ω | 10 mV to 6 V (V _{pp}) |
| | 1110 50 12 | |
| | | (sample rate \leq 125 Msample/s), |
| | | 10 mV to 4 V (V_{pp}) |
| | forte an exaction of the | (sample rate > 125 Msample/s) |
| | into open circuit | 20 mV to 12 V (V _{pp}) |
| | | (sample rate ≤ 125 Msample/s), |
| | | 20 mV to 8 V (V _{pp}) |
| | | (sample rate > 125 Msample/s) |
| | resolution | 1 mV |
| | accuracy | \pm [1% of control + 1 mV (V _{pp})] at 1 kHz |
| DC offset range | sine, square, ramp, pulse, expor | · · · · · |
| | into 50 Ω | \pm [3 V – (amplitude [V (V _{pp})] / 2)] |
| | into open circuit | \pm [6 V – (amplitude [V (V _{pp})] / 2)] |
| | cardinal sine (sinc), cardiac, Gau | |
| | into 50 Ω | ±0.5 V |
| | into open circuit | ±1 V |
| | resolution | 1 mV |
| | accuracy | ± (2 % of control + 2 mV) |
| Frequency accuracy | | $ \Delta f \le [$ (timebase accuracy) × (nominal |
| · · · | | frequency) + 1 µHz] |
| | | (timebase accuracy: see Horizontal |
| | | system) |

 $^{^{\,8}\,}$ Amplitude is the sum of the AC amplitude and the noise amplitude.

8-bit pattern generator

| Function | output of user-defined patterns |
|-----------------|---|
| Output channels | 8 channels, coupled w.r.t. pattern length |
| | and data output rate |
| Pattern length | 1 bit to 40 Mbit on each channel |
| Bit rate | 1 bit/s to 40 Mbit/s |

| Outputs | | |
|---------------------|---|--|
| Connector | | 16-pin double row connector, 2.54 mm pitch, located on an adapter board, which is connected via a removable ribbon cable to the R&S [®] RTP-B6 |
| Output impedance | | 330 Ω (nom.) |
| Overload protection | reverse input voltage without damage | -0.5 V to +6.5 V (meas.), ESD protection |
| Amplitude | low level output voltage (I = $100 \mu\text{A}$) | |
| | output voltage | 0 V + 0.15 V/- 0.02 V |
| | accuracy | ≤ 0.15 V (meas.) |
| | high level output voltage | |
| | setting range | 1.2 V to 5.0 V in steps of 0.1 V |
| | accuracy | ≤ 0.05 V |
| Rise/fall time | | 8 ns (meas.) |
| Overshoot | | ≤ 5 % (meas.) |

R&S®RTP-B7 16 GHz differential pulse source

16 GHz differential pulse source with reference output

Output ⁹

| Output pulse | | two complementary negative going square wave pulse train signals, single-ended or differential operation, fast transition on rising and falling edge, adjustable amplitude and timing parameters, free-running or phase-locked to base unit |
|--------------------|-------------------------|---|
| Outputs | single-ended operation | single-ended output (OutP) |
| | | single-ended reference output (RefP) |
| | differential operation | differential output (OutP, OutN) |
| | | differential reference output (RefP, RefN) |
| Output connectors | | SMA female connectors |
| Reverse DC voltage | | 0 V |
| Output impedance | single-ended outputs | 50 Ω (nom.) |
| | both differential pairs | 100 Ω (nom.) |
| Return loss | ≤ 10 GHz | > 15 dB (meas.) |
| | ≤ 20 GHz | > 12 dB (meas.) |

DC characteristics ⁹

| Output high level | | 0 V ± 10 mV |
|----------------------------|-----------------------------------|------------------------|
| Output low level | | –200 mV to –50 mV |
| setting range | | in steps of 10 mV |
| Output low level error | OutP | ±2 % of setting ±15 mV |
| Output low level imbalance | between OutP and RefP, OutN, RefN | ±1 dB (meas.) |

 $^{^{9}}$ All four outputs terminated with 50 Ω ; all parameters are measured at all four single-ended outputs, unless noted.

Time domain characteristics ⁹

| Transition time | 10 % to 90 %, rising and falling edge, calculated from 0.36/bandwidth | |
|---------------------------|---|------------------------------------|
| | output low level: -120 mV to -50 mV | 20 ps |
| | output low level: -200 mV to -130 mV | 22 ps |
| Step response aberrations | for the first 100 ps after step transition | ±10 % (meas.) |
| | for the first 1 ns after step transition | ±4 % (meas.) |
| | until 100 ps before following step | ±2 % (meas.) |
| | transition | |
| Repetition rate | low frequency mode | 5/10/20/50/100/200/500 Hz to 1 MHz |
| | high frequency mode, phase-locked to | 5/10/25/50/100/250 MHz |
| | base unit | |
| | high frequency mode, free-running | 5/10/25/50 MHz |
| Positive duty cycle | measured at 50 % of transition | |
| | low frequency mode | 10 % to 90 % in steps of 10 % |
| | high frequency mode | 50 % |
| Duty cycle error | measured at 50 % of transition, at OutP an | d RefP outputs |
| | low frequency mode | ±2 % (meas.) |
| | high frequency mode | ±0.1 % (meas.) |
| Skew | measured at 50 % of transition, | < 0.5 ps (meas.) |
| | between OutP and OutN output | |
| Clock accuracy | free-running | ±100 ppm (meas.) |
| | phase-locked to base unit | see Timebase accuracy of base unit |

Frequency domain characteristics ⁹

| Analog bandwidth (-3 dB) | output low level: -120 mV to -50 mV | > 18 GHz (meas.) |
|--|--------------------------------------|--------------------------|
| | output low level: -200 mV to -130 mV | > 16.5 GHz (meas.) |
| Spectral magnitude error to ideal step | ≤ 5 GHz | +0.5 dB to -1 dB (meas.) |
| spectrum | ≤ 12 GHz | +0.5 dB to -2 dB (meas.) |
| | ≤ analog bandwidth | +0.0 dB to -3 dB (meas.) |

General

| Accessories | The R&S®RTP-B7 contains an accessory bag with 2 SMA cables, 4 SMA terminations, |
|-------------|--|
| | 2 SMA(f) to SMA(f) adapters, 2 SMA shorts and 1 ESD wrist strap with grounding cord. |

R&S[®]RTP-B21 adapter rear option slot

| General description | The R&S®RTP-B21 adapter is necessary to use the R&S®RTP-B1 or the |
|---------------------|---|
| | R&S®RTP-B1E option at the rear side of the instrument. For mounting instructions, |
| | please see R&S [®] RTP user manual. |

R&S®RTP-K1 I²C/SPI serial triggering and decoding

| I ² C triggering and decoding | | |
|--|-------------------------|--|
| Protocol configuration | bit rate | auto-detected |
| | auto threshold setup | assisted threshold configuration for I ² C |
| | | triggering and decoding |
| | device list | associate frame address with symbolic ID |
| Trigger | source (clock and data) | any input channel or logical channel |
| | bit rate | up to 6.5 Mbps |
| | trigger event setup | start, stop, restart, missing ACK, address, data, address + data |
| | address setup | 7 bit or 10 bit address (value in hex, |
| | | decimal, octal or binary); ACK, NACK or |
| | | either; read, write or either; R/W bit |
| | | included in address value or apart; |
| | | condition =, \neq , \geq , \leq , in range, out of range |
| | data setup | data pattern up to 8 byte (hex, decimal, |
| | | octal or binary); condition =, \neq , \geq , \leq , in |
| | | range, out of range; offset within frame in |
| | | range from 0 byte to 4095 byte |
| Decode | source (clock and data) | any input channel, math waveform, |
| | | reference waveform, logical channel |
| | display type | decoded bus, logical signal, bus + logical |
| | | signal, tabulated list, decode layers |
| | color coding | frame, start/restart, address, R/W bit, data ACK/NACK, stop, error |
| | address and data format | hex, decimal, octal, binary, ASCII; |
| | | symbolic names for user-defined subset o |
| | | addresses |
| | decode layer | off, edges, bit |
| Search | search event setup | combination of start, stop, restart, missing |
| | | ACK, address, data, address + data |
| | event settings | same as trigger event settings |

| SPI triggering and decoding | | |
|-----------------------------|--------------------------------|--|
| Protocol configuration | type | 2-wire, 3-wire and 4-wire SPI |
| | bit rate | auto-detected |
| | bit order | LSB first, MSB first |
| | word size | 4 bit to 32 bit |
| | frame condition | SS, timeout |
| | polarity (MOSI, MISO, SS, CLK) | active high, active low |
| | phase (CLK) | first edge, second edge |
| | auto threshold setup | assisted threshold configuration for SPI triggering and decoding |
| Trigger | source (MOSI, MISO, SS, CLK) | any input channel or logical channel |
| | bit rate | up to 50 Mbps |
| | trigger event setup | start of frame, MOSI, MISO, MOSI + MISO |
| | data setup | data pattern up to 256 bit (hex or binary); condition =, ≠; offset within frame in range from 0 bit to 32767 bit |
| Decode | source (MOSI, MISO, SS, CLK) | any input channel, math waveform, reference waveform, logical channel |
| | display type | decoded bus, logical signal, bus + logical signal, tabulated list, decode layers |
| | color coding | frame, word, error |
| | data format | hex, decimal, octal, binary, ASCII |
| | decode layer | edges, bit, words |
| Search | search event setup | start of frame, MOSI, MISO, MOSI + MISO |
| | event settings | same as trigger event settings |

R&S®RTP-K2 UART/RS-232/RS-422/RS-485 serial triggering and decoding

| | | 55 5 5 |
|------------------------|----------------------|--|
| Protocol configuration | bit rate | 300 bps to 20 Mbps |
| | signal polarity | idle low, idle high |
| | number of bits | 5 bit to 9 bit |
| | bit order | LSB first, MSB first |
| | parity | odd, even, mark, space, none |
| | stop bit | 1, 1.5 or 2 bit periods |
| | end of packet | word, timeout, none |
| | auto threshold setup | assisted threshold configuration for |
| | | UART triggering and decoding |
| Trigger | source (TX and RX) | any input channel or logical channel |
| | trigger event setup | start bit, packet start, data, parity error, |
| | | break condition |
| | data setup | data pattern up to 256 bit (hex, decimal, |
| | | octal, binary or ASCII); condition =, \neq ; |
| | | offset within packet in range 0 bit to |
| | | 32767 bit |
| Decode | source (TX and RX) | any input channel, math waveform, |
| | | reference waveform, logical channel |
| | display type | decoded bus, logical signal, bus + logical |
| | | signal, tabulated list |
| | color coding | packet, data payload, start error, parity |
| | | error, stop error |
| | data format | hex, decimal, octal, binary, ASCII |

R&S®RTP-K3 CAN/LIN serial triggering and decoding

| CAN triggering and decoding | | |
|-----------------------------|----------------------|--|
| Protocol configuration | signal type | CAN_H, CAN_L |
| | bit rate | 100 bps to 1 Mbps |
| | sampling point | 5 % to 95 % within bit period |
| | device list | associate frame identifier with symbolic ID, |
| | | load DBC file content |
| | auto threshold setup | assisted threshold configuration for CAN |
| | | triggering and decoding |
| Trigger | source | any input channel or logical channel |
| | trigger event setup | start of frame, frame type, identifier, |
| | | identifier + data, symbolic, error condition |
| | | (any combination of CRC error, bit stuffing |
| | | error, form error and ACK error) |
| | identifier setup | frame type (data, remote or both), |
| | | identifier type (standard or extended); |
| | | condition =, \neq , \geq , \leq , in range, out of range |
| | data setup | data pattern up to 8 byte (hex, decimal, |
| | | octal or binary); big-endian or little-endian; |
| | | condition =, \neq , \geq , \leq , in range, out of range |
| | symbolic setup | message name, signal name; |
| | | numeric signal condition =, \neq , \geq , \leq , in |
| | | range, out of range; |
| | | enumerated signal condition =, \neq , \geq , \leq |
| Decode | source | any input channel, math waveform, |
| | | reference waveform, logical channel |
| | display type | decoded bus, logical signal, bus + logical |
| | | signal, tabulated list |
| | color coding | start of frame, identifier, DLC, data |
| | | payload, CRC, end of frame, error frame, |
| | | overload frame, CRC error, bit stuffing |
| | data farra at | error |
| | data format | hex, decimal, octal, binary, ASCII, |
| | | symbolic |

| Search | source | any input channel or logical channel |
|--------|--------------------|--|
| | search event setup | combination of start of frame, frame type, |
| | | identifier, identifier + data, error condition |
| | | (any combination of CRC error, bit stuffing |
| | | error, form error and ACK error) or only |
| | | symbolic |
| | event settings | same as trigger event settings |

| LIN triggering and decoding | | | |
|-----------------------------|----------------------|--|--|
| Protocol configuration | version | 1.3, 2.x or SAE J602; mixed traffic is supported | |
| | bit rate | standard bit rate (1.2/2.4/4.8/9.6/10.417/ 19.2 kbps) or user-defined bit rate in range from 1 kbps to 20 kbps | |
| | device list | associate frame identifier with symbolic ID, data length and protocol version | |
| | auto threshold setup | assisted threshold configuration for LIN triggering and decoding | |
| Trigger | source | any input channel | |
| | trigger event setup | start of frame (sync break), identifier, identifier + data, wake-up frame, error condition (any combination of checksum error, parity error and sync field error) | |
| | identifier setup | range from 0d to 63d; select condition =, ≠, ≥, ≤, in range, out of range for trigger "identifier"; select single identifier and condition = for trigger "identifier + data" | |
| | data setup | data pattern up to 8 byte (hex, decimal, octal or binary); condition =, \neq , \geq , \leq , in range, out of range | |
| Decode | source (TX and RX) | any input channel, math waveform, reference waveform | |
| | display type | decoded bus, logical signal, bus + logical signal, tabulated list | |
| | color coding | frame, frame identifier, data payload, checksum, error condition | |
| | data format | hex, decimal, octal, binary, ASCII | |
| Search | search event setup | combination of start of frame (sync break), identifier, identifier + data, wake-up frame, error condition (any combination of checksum error, parity error and sync field error) | |
| | event settings | same as trigger event settings | |

R&S®RTP-K6 MIL-STD-1553 serial triggering and decoding

| Protocol configuration | signal type | single-ended |
|------------------------|---------------------------|--|
| | bit rate | standard bit rate (1 Mbit/s) |
| | polarity | normal, inverted |
| | device list | associate frame identifier with symbolic IE |
| | auto threshold setup | assisted threshold configuration |
| | timing | min. gap (2 µs to 262 µs) or off; max. response (2 µs to 262 µs) or off |
| Trigger | trigger event setup | sync, word, data word, command/status word, command word, status word, error condition |
| | sync and word setup | all words, command/status word, data word |
| | data word setup | RTA (condition =, ≠, ≥, ≤, in range, out of range); data pattern (condition =, ≠, ≥, ≤, in range, out of range); payload data index (=, <, >, ≥, ≤, range); max. length of data pattern is 4 byte |
| | command/status word setup | RTA (condition =, \neq , \geq , \leq , in range, out of range); 11 bit pattern (condition =, \neq , \geq , \leq , in range, out of range) |
| | command word setup | RTA (condition =, ≠, ≥, ≤, in range, out of range); subaddress/mode (condition =, ≠, ≥, ≤, in range, out of range); data word count/mode count (condition =, ≠, ≥, ≤, in range, out of range); direction (T/R) |
| | status word | RTA (condition =, ≠, ≥, ≤, in range, out of range); status flags (message error, instrumentation, service request, broadcast command, busy, subsystem flag, dynamic bus control, terminal flag) |
| | error condition | any combination of sync error, Manchester error, parity error, timing erro (see protocol configuration) |
| Decode | source | any analog input channel, math waveform, reference waveform |
| | display type | decoded bus, logical signal, bus + logical signal, tabulated list |
| | color coding | frame (word), sync, RTA, status bit field, parity, data field, error condition |
| | data format | hex, octal, binary, ASCII, signed, unsigned |
| Search | search event setup | sync, word, data word, command/status word, command word, status word, error condition |
| | event settings | same as trigger event settings |

R&S®RTP-K7 ARINC 429 serial triggering and decoding

| | | - |
|------------------------|----------------------|--|
| Protocol configuration | signal type | single-ended |
| - | bit rate | high (100 kbit/s) |
| | | low (12 kbit/s to 14.5 kbit/s) |
| | polarity | A leg, B leg |
| | device list | associate frame identifier with symbolic ID |
| | auto threshold setup | assisted threshold configuration |
| | timing | min. gap (0 bit to 100 bit) or off; |
| | | max. gap (0 bit to 1000 bit) or off |
| Trigger | trigger event setup | word start, word stop, label + data, error condition |
| | label + data setup | label (condition =, \neq , \geq , \leq , in range, out of range); data (condition =, \neq , \geq , \leq , in range, out of range); SDI/SSM |
| | error condition | any combination of coding error, parity error, timing error (see protocol configuration) |
| Decode | source | any analog input channel, math waveform, reference waveform |
| | display type | decoded bus, logical signal, bus + logical signal, tabulated list |
| | color coding | frame (word), label, SDI, data, SSM, parity, error condition |
| | data format | hex, octal, binary, ASCII, signed, unsigned |
| Search | search event setup | word start, word stop, label + data, error condition |
| | event settings | same as trigger event settings |

R&S[®]RTP-K8 Ethernet (10BASE-T/100BASE-TX) serial triggering and decoding

| Protocol configuration | signal type | one differential channel | |
|------------------------|----------------------|---|--|
| | bit rate | auto-detected | |
| | auto threshold setup | assisted threshold configuration | |
| | full autoset | adjust horizontal and vertical resolution | |
| | | and perform auto threshold | |
| | source (SDATA) | analog and math channels | |
| | variants | 10BASE-T, 100BASE-TX | |
| Trigger | frame start | trigger at start of any MAC frame | |
| | pattern | fast trigger for 10BASE-T MAC frames, | |
| | | 32 byte, index 0 to 65535 | |
| | frame | advanced trigger configuration for MAC | |
| | | frames only; | |
| | | 48 bit destination address, 48 bit source | |
| | | address, 16 bit length/type, 32 bit frame | |
| | | check; conditions =, \neq , <, ≤, >, ≥, in range, | |
| | | out of range | |
| | error | preamble error, length error, CRC error | |
| Decode | display type | decoded bus, logical signal, bus + logical | |
| | | signal, tabulated list, details, decode | |
| | | layers | |
| | color coding | preamble, frame, destination address, | |
| | | source address, data | |
| | data format | hex, octal, binary, signed, unsigned | |
| | decode layer | edges, binary | |
| | result export | export of all result data into CSV, XML, | |
| | | HTML and PY file formats | |
| Search | search event setup | frame, error | |
| | event settings | same as trigger event settings | |

R&S[®]RTP-K9 CAN-FD serial triggering and decoding

| Protocol configuration | signal type | CAN_H, CAN_L | |
|------------------------|-----------------------|---|--|
| | standard | ISO, non-ISO (Bosch) | |
| | bit rate | | |
| | arbitration rate | 10 kbps to 1 Mbps | |
| | data rate | 10 kbps to 15 Mbps | |
| | sampling point | 5 % to 95 % within bit period; independent settings for arbitration phase and data phase | |
| | device list | associate frame identifier with symbolic ID, load DBC file content | |
| | auto threshold setup | assisted threshold configuration | |
| Trigger | source | any input channel or logical channel | |
| | trigger event setup | start of frame, frame type, identifier, identifier + data, symbolic, error condition (any combination of CRC error, bit stuffing error, form error and ACK error) | |
| | identifier setup | frame type (data, remote or both), identifier type (standard or extended); condition =, ≠, ≥, ≤, in range, out of range | |
| | FD bit | FDF, BRS and ESI (0, 1, X) | |
| | data setup | data pattern up to 8 byte in the complete data range (hex, decimal, octal or binary); condition =, \neq , \geq , \leq , in range, out of range | |
| | symbolic setup | message name, signal name; numeric signal condition =, ≠, ≥, ≤, in range, out of range; enumerated signal condition =, ≠, ≥, ≤ | |
| Decode | source | any input channel, math waveform, reference waveform, logical channel | |
| | display type | decoded bus, logical signal, bus + logical signal, tabulated list | |
| | color coding | start of frame, identifier, FD bit, DLC, data payload, CRC, end of frame, error frame, overload frame, CRC error, bit stuffing error | |
| | data format | hex, decimal, octal, binary, ASCII, symbolic | |
| | supported data length | 64 | |
| Search | source | any input channel or logical channel | |
| | search event setup | combination of start of frame, frame type, identifier, identifier + data, error condition (any combination of CRC error, bit stuffing error, form error and ACK error) or only symbolic | |
| | event settings | same as trigger event settings | |

R&S®RTP-K11 I/Q software interface

| General | function | | mixing, filtering, decim baseband signals as I | nation and recording of RF o |
|-------------------------|--------------------------|---------------------------|---|----------------------------------|
| | input signals | | four real RF signals or | |
| | input signals | | two complex I/Q signals or | |
| | | | two real RF signals ar | |
| | | | one complex I/Q signal | |
| | mixer frequency | | between 100 Hz and 2 | |
| | mixer frequency | | deactivated) | |
| | compling rate of record | ded I/O complete | / | and 20 Coomple/s user |
| | sampling rate of recor | ded i/Q samples | selectable | and 20 Gsample/s user- |
| | digital filter bandwidth | (flat frequency response) | 4 % to 80 % of sampling rate | |
| | recording length | | max. 40 Mpoints with | four input signals ¹⁰ |
| Trigger | mode | | auto or normal | |
| | operation | | triggers on acquired s | ignal after A/D conversion |
| | | | serial bus and MSO tr | |
| Display | | | magnitude of the dow | |
| Amplitude flatness with | R&S [®] RTP044B | max. used center | with I/Q bandwidth | with I/Q bandwidth |
| RF signal input (meas.) | | frequency | 100 MHz | 500 MHz |
| Ri Signai input (meas.) | | ≤ 100 MHz | | 500 Mil 12 |
| | | | ±0.10 dB | .0.2.dP |
| | | ≤ 500 MHz | ±0.2 dB | ±0.2 dB |
| | | ≤ 1 GHz | ±0.2 dB | ±0.3 dB |
| | | ≤ 2 GHz | ±0.2 dB | ±0.3 dB |
| | | ≤ 4 GHz | ±0.4dB | ±1.8 dB |
| | R&S [®] RTP064B | max. used center | with I/Q bandwidth | with I/Q bandwidth |
| | | frequency | 100 MHz | 500 MHz |
| | | ≤ 100 MHz | ±0.10 dB | |
| | | ≤ 500 MHz | ±0.2 dB | ±0.2 dB |
| | | ≤ 1 GHz | ±0.2 dB | ±0.3 dB |
| | | ≤ 2 GHz | ±0.2 dB | ±0.3 dB |
| | | ≤ 4 GHz | ±0.3 dB | ±0.3 dB |
| | | ≤ 6 GHz | ±0.5 dB | ±2.0 dB |
| | R&S®RTP084B | max. used center | with I/Q bandwidth | with I/Q bandwidth |
| | | frequency | 100 MHz | 500 MHz |
| | | ≤ 100 MHz | ±0.10 dB | 300 10112 |
| | | | | |
| | | ≤ 500 MHz | ±0.2 dB | ±0.2 dB |
| | | ≤ 1 GHz | ±0.2 dB | ±0.3 dB |
| | | ≤ 4 GHz | ±0.3 dB | ±0.3 dB |
| | | ≤ 8 GHz | ±0.5 dB | ±2.0 dB |
| | R&S [®] RTP134B | max. used center | with I/Q bandwidth | with I/Q bandwidth |
| | | frequency | 100 MHz | 500 MHz |
| | | ≤ 100 MHz | ±0.10 dB | |
| | | ≤ 500 MHz | ±0.2 dB | ±0.2 dB |
| | | ≤ 1 GHz | ±0.2 dB | ±0.3 dB |
| | | ≤ 4 GHz | ±0.3 dB | ±0.3 dB |
| | | ≤ 8 GHz | ±0.5 dB | ±2.0 dB |
| | R&S [®] RTP164B | max. used center | with I/Q bandwidth | with I/Q bandwidth |
| | | frequency | 100 MHz | 500 MHz |
| | | ≤ 100 MHz | ±0.10 dB | |
| | | ≤ 500 MHz | ±0.2 dB | ±0.2 dB |
| | | ≤ 1 GHz | ±0.2 dB | ±0.3 dB |
| | | | ±0.2 dB ±0.3 dB | ±0.3 dB |
| | ≤ 4 GHz ≤ 8 GHz | | | |

¹⁰ Maximum recording length of 25 Msample for sampling rates of recorded I/Q samples: 250 Msample/s to 400 Msample/s.

R&S®RTP-K12 jitter analysis

| General description | The R&S®RTP-K12 jitter analysis option extends the functionality of the standard | | | |
|--------------------------------------|--|--|--|--|
| | R&S [®] RTP firmware with a suite of measurement, analysis and visualization tools for signal integrity analysis and jitter characterization. | | | |
| Waveform measurements | category jitter | | | |
| | measurement functions | cycle-to-cycle jitter, N-cycle jitter, cycle-to- cycle width, cycle-to-cycle duty cycle, time-interval error, data rate, unit interval, skew delay, skew phase; the standard time measurements period, frequency and setup/hold are also available in the jitter category for convenience | | |
| | track | measurement results displayed as continuous trace that is time-correlated to the measurement source; applicable to time measurements from categories "jitter" and "amplitude and time"; track trace may be used as source for cursor measurements, automatic measurements, math waveforms and reference waveforms | | |
| Waveform math | FFT on track | FFT spectrum of the track trace of measurement results | | |
| | CDR transform | recovers clock timing from source waveform with software CDR and generates synthetic clock waveform that is time-correlated to source | | |
| Software clock data recovery (CDR) | number of CDR instances | up to 2; independently configurable | | |
| | algorithm | phase-locked loop (PLL), constant frequency | | |
| | configuration | nominal bit rate, PLL order (first or second), PLL loop bandwidth, PLL damping factor, initial phase alignment, result selection during initial synchronization | | |
| Mask testing with eye mask assistant | primary mask shape | | | |
| | type | diamond, square, hexagon, octagon | | |
| | dimensions | main and secondary height, main and secondary width, depending on selected shape | | |
| | position | vertical offset, horizontal offset | | |
| | secondary mask shapes | | | |
| | locations | any combination of left, right, top, bottom | | |
| | position | horizontal and vertical offset with respect to center of primary mask shape | | |

R&S®RTP-K19 zone trigger

| General description | The R&S [®] RTP-K19 zone trigger the display. | The R&S [®] RTP-K19 zone trigger enables the triggering on user-defined zones drawr the display. | |
|-----------------------|--|--|--|
| Source | | acquired waveforms (input channels), math waveforms | |
| Zone definition | number of zones | up to 8 | |
| | shapes | rectangles, polygones | |
| | types | must intersect, must not intersect | |
| | combination of zones | logical combination of zones of multiple sources using Boolean expressions | |
| Trigger compatibility | | compatible with the trigger modes edge, glitch, width, runt, window, timeout, interval, slew rate, data2clock, pattern, state, serial pattern, trigger qualification, and sequence trigger | |

R&S®RTP-K21 USB 2.0 compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K21 performs USB 2.0 compliance test measurements with R&S[®]ScopeSuite, including tests for USB 2.0 (high speed), USB 1.1 (full speed) and USB 1.0 (low speed) with the R&S[®]RTP. R&S[®]ScopeSuite supports the R&S[®]RT-ZF1 USB 2.0 compliance test fixture set and the Allion USB test fixture solutions and the USB-IF signal quality board device/host; R&S[®]ScopeSuite supports Windows 7, 8 and 10.

| Supported USB 2.0 complian | ce tests | |
|----------------------------|--------------------------|--|
| USB device test | high speed | signal quality (EL_2, 4, 5, 6, 7); packet parameters (EL_21, 22, 25); chirp timing (EL_28, 29, 31); suspend/resume/reset timing (EL_27, 28, 38, 39, 40); test J/K, SE0_NAK (EL_8, 9); receiver sensitivity (EL_16, 17, 18) |
| | full speed and low speed | full speed signal quality; back voltage; inrush current |
| USB host test | high speed | signal quality (EL_2, 3, 6, 7); packet parameters (EL_21, 22, 23, 25, 55); chirp timing (EL_33, 34, 35); suspend/resume/reset timing (EL_39, 41); test J/K, SE0_NAK (EL_8, 9) |
| | full speed and low speed | low speed signal quality downstream; full speed signal quality downstream; drop; droop |
| USB hub test | high speed | signal quality upstream (EL_2, 4, 6, 7); signal quality downstream (EL_2, 3, 6, 7); jitter downstream (EL_47); packet parameters upstream (EL_21, 22, 25); hub receiver sensitivity upstream (EL_16, 17, 18); repeater downstream (EL_42, 43, 44, 45, 48); repeater upstream (EL_42, 43, 44, 45); chirp timing upstream (EL_28, 29, 31); suspend/resume/reset timing upstream (EL_27, 28, 38, 39, 40); test J/K, SE0_NAK upstream (EL_8, 9); test J/K, SE0_NAK downstream (EL_8, 9) |
| | full speed and low speed | low speed signal quality downstream; full speed signal quality upstream; full speed signal quality downstream; inrush current upstream; drop downstream; droop downstream; back voltage |

R&S®RTP-K22 Ethernet compliance test (10/100/1000BASE-T/EEE)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K22 performs Ethernet compliance test measurements with R&S®ScopeSuite, including tests for 10BASE-T, 100BASE-TX,1000BASE-T and energy efficient Ethernet (EEE) with the R&S®RTP. R&S®ScopeSuite supports the R&S®RT-ZF2 Ethernet compliance test fixture set as well as the R&S®RT-ZF4 and R&S®RT-ZF5 for EEE; R&S®ScopeSuite supports Windows 7, 8 and 10.

| Supported Ethernet complian | ice tests | |
|-----------------------------|------------------------|--|
| Standard reference | | IEEE 802.3-2012 |
| 1000BASE-T | with/without disturber | with/without TX_CLK transmitter |
| | | distortion (40.6.1.2.4) |
| | | peak differential output voltage |
| | | (40.6.1.2.1) |
| | | maximum output droop (40.6.1.2.2) |
| | | differential output templates (40.6.1.2.3) |
| | with TX_CLK | jitter master mode (40.6.1.2.5), |
| | | jitter slave mode (40.6.1.2.5) |
| | without TX_CLK | jitter master mode (40.6.1.2.5) |
| | common | MDI return loss (40.8.3.1), |
| | | common mode output voltage (40.8.3.3) |
| 100BASE-TX | | amplitude domain tests |
| | | (9.1.2.2, 9.1.3 and 9.1.4) |
| | | rise and fall times (9.1.6) |
| | | peak to peak duty cycle distortion (9.1.8 |
| | | peak to peak transmitter jitter (9.1.9) |
| | | active output interface template (annex |
| | | transmitter return loss (9.1.5) |
| | | receiver return loss (9.2.2) |
| 10BASE-T | no TPM | link test pulse template (14.3.1.2.1) |
| | | TP_IDL template (14.3.1.2.1) |
| | | peak differential voltage (14.3.1.2.1) |
| | | harmonic content (14.3.1.2.1) |
| | | output timing jitter (14.3.1.2.3) |
| | with TPM | link test pulse template (14.3.1.2.1) |
| | | TP_IDL template (14.3.1.2.1) |
| | | MAU template (14.3.1.2.1) |
| | | output timing jitter (14.3.1.2.3) |
| | common | transmitter return loss (14.3.1.2.2), |
| | | receiver return loss (14.3.1.3.4) |
| | | common mode output voltage |
| | | (14.3.1.2.5) |

| Supported EEE compliance tests | |
|------------------------------------|---|
| Standard reference | IEEE 802.3-2012 |
| 1000BASE-T EEE | quiet time (78.2) |
| (requires R&S [®] RT-ZF5) | refresh time (master) (78.2) |
| | refresh time (slave) (78.2) |
| | wake state levels (40.6.1.2.7) |
| | transmitter timing jitter with TX_TCLK |
| | (master) (40.6.1.2.5) |
| | transmitter timing jitter with TX_TCLK |
| | (slave) (40.6.1.2.5) |
| | transmitter timing jitter without TX_TCLK |
| | (master) (40.6.1.2.5) |
| | transmitter timing jitter without TX_TCLK |
| | (master) (40.6.1.2.5) |
| 100BASE-TX EEE | sleep time (24.2.3.4 and 78.2) |
| (requires R&S [®] RT-ZF5) | LPI quiet time (24.2.3.4 and 78.2) |
| | LPI refresh time (24.2.3.4 and 78.2) |
| | LPI transmitter timing jitter (24.2.3.4 and |
| | 78.2) |
| | transmit wake time (24.2.3.4 and 78.2) |

| 10BASE-Te | no TPM | link test pulse template (14.3.1.2.1) |
|------------------------------------|----------|--|
| (requires R&S [®] RT-ZF4) | | TP_IDL template (14.3.1.2.1) |
| | | peak differential voltage (14.3.1.2.1) |
| | | harmonic content (14.3.1.2.1) |
| | | output timing jitter (14.3.1.2.3) |
| | with TPM | link test pulse template (14.3.1.2.1) |
| | | TP_IDL template (14.3.1.2.1) |
| | | MAU template (14.3.1.2.1) |
| | | output timing jitter (14.3.1.2.3) |
| | common | transmitter return loss (14.3.1.2.2), |
| | | receiver return loss (14.3.1.3.4) |
| | | common mode output voltage |
| | | (14.3.1.2.5) |

R&S®RTP-K23 Ethernet compliance test (2.5/5/10GBASE-T)

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K23 performs Ethernet compliance test measurements with the R&S[®]ScopeSuite, including tests for 2.5GBASE-T, 5GBASE-T and 10GBASE-T with the R&S[®]RTP. R&S[®]ScopeSuite supports the R&S[®]RT-ZF2 Ethernet compliance test fixture set; R&S[®]ScopeSuite supports Windows 7, 8 and 10.

| Standard reference | IEEE 802.3-2012 and IEEE P802.3bz |
|--------------------|---|
| 2.5/5GBASE-T | maximum output droop (126.5.3.1) |
| | transmitter nonlinear distortion (126.5.3.2) |
| | transmitter timing jitter master mode and clock frequency (126.5.3.3 and 126.5.3.5) |
| | transmitter timing jitter slave mode (126.5.3.3) |
| | transmitter power spectral density and power level (126.5.3.4) |
| | MDI return loss (126.6.2.1) |
| 10GBASE-T | maximum output droop (55.5.3.1) |
| | transmitter linearity (55.5.3.2) |
| | transmitter timing jitter master mode (55.5.3.3) |
| | transmitter timing jitter slave mode |
| | (55.5.3.3) |
| | transmitter power spectral density |
| | (55.5.3.4) |
| | transmitter power level (55.5.3.4) |
| | transmitter clock frequency (55.5.3.5) |
| | MDI return loss (55.8.2.1) |

R&S®RTP-K24 Ethernet compliance test (100BASE-T1)

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K24 performs 100BASE-T1 compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports the R&S[®]RT-ZF2, R&S[®]RT-ZF7A and R&S[®]RT-ZF8 Ethernet compliance test fixtures. The chapters after the test cases refer to IEEE 802.3-2018 and OPEN Alliance ECU specification version 2.0.

| Supported Ethernet compliance tests | |
|-------------------------------------|---|
| 100BASE-T1 | transmitter output droop (96.5.4.1) |
| | transmitter distortion with and without |
| | disturber (96.5.4.2) |
| | transmitter timing jitter master mode |
| | (96.5.4.3) |
| | transmitter timing jitter slave mode |
| | (96.5.4.3) |
| | transmitter power spectral density |
| | (96.5.4.4) |
| | transmitter clock frequency (96.5.4.5) |
| | transmitter peak differential output |
| | (96.5.6) |
| | MDI return loss (96.7.1.3) |
| | MDI mode conversion loss (96.8.2.2) |
| | MDI mode conversion loss adapter |
| | verification (OABR_PMA_TX_06) |
| | MDI common mode emission |
| | (OABR_PMA_TX_07) |

R&S[®]RTP-K26 MIPI D-PHY compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K26 performs D-PHY compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports Windows 7, 8 and 10. The numbers behind the test refer to the MIPI CTS for D-PHY V1.1 and V1.2.

| Supported D-PHY compli | | |
|------------------------|-------------------------------------|--|
| D-PHY | group 1 (7 tests): data lane LP-TX | data lane LP-TX Thevenin output high |
| | signaling requirements | level voltage (V_{OH}) – 1.1.1 |
| | | data lane LP-TX Thevenin output low |
| | | level voltage $(V_{OL}) - 1.1.2$ |
| | | data lane LP-TX from 15 % to |
| | | 85 % rise time $(T_{RLP}) - 1.1.3$ |
| | | data lane LP-TX from 85 % to |
| | | 15 % fall time (T _{FLP}) – 1.1.4 |
| | | data lane LP-TX slew rate versus C _{LOAD} |
| | | $(\delta V/\delta t_{SR}) - 1.1.5$ |
| | | data lane LP-TX pulse width of |
| | | exclusive-OR clock $(T_{LP-PULSE-TX}) - 1.1.6$ |
| | | data lane LP-TX period of exclusive-OR |
| | | clock (T _{LP-PER-TX}) – 1.1.7 |
| | group 2 (5 tests): clock lane LP-TX | clock lane LP-TX Thevenin output high |
| | signaling requirements | level voltage (V _{OH}) – 1.2.1 |
| | | clock lane LP-TX Thevenin output low |
| | | level voltage (V _{OL}) – 1.2.2 |
| | | clock lane LP-TX from 15 % to |
| | | 85 % rise time (T _{RLP}) – 1.2.3 |
| | | clock lane LP-TX from 85 % to |
| | | 15 % fall time (T _{FLP}) – 1.2.4 |
| | | clock lane LP-TX slew rate versus CLOAD |
| | | $(\delta V/\delta t_{SR}) - 1.2.5$ |
| | group 3 (16 tests): data lane HS-TX | data lane HS entry: data lane T _{LPX} value |
| | signaling requirements | 1.3.1 |
| | | data lane HS entry: data lane |
| | | T _{HS-PREPARE} value – 1.3.2 |
| | | data lane HS entry: data lane |
| | | T _{HS-PREPARE} + T _{HS-ZERO} value – 1.3.3 |
| | | data lane HS-TX differential voltages |
| | | $V_{OD(0)}$ and $V_{OD(1)} - 1.3.4$ |
| | | data lane HS-TX differential voltage |
| | | mismatch $\Delta V_{OD} - 1.3.5$ |
| | | data lane HS-TX single-ended output |
| | | voltages VOHHS(DP) and VOHHS(DN) - 1.3.6 |
| | | data lane HS-TX static common mode |
| | | voltages $V_{CMTX(1)}$ and $V_{CMTX(0)} - 1.3.7$ |
| | | data lane HS-TX static common mode |
| | | voltage mismatch $\Delta V_{CMTX(1.0)} - 1.3.8$ |
| | | data lane HS-TX dynamic common-leve |
| | | variations from 50 MHz to 450 MHz |
| | | $\Delta V_{CMTX(LF)} - 1.3.9$ |
| | | data lane HS-TX dynamic common-leve |
| | | variations above 450 MHz $\Delta V_{CMTX(HF)}$ – |
| | | 1.3.10 |
| | | data lane HS-TX from 20 % to 80 % rise |
| | | time $t_{\rm R}$ – 1.3.11 |
| | | data lane HS-TX from 80 % to 20 % fall |
| | | time $t_F - 1.3.12$ |
| | | data lane HS exit: $T_{HS-TRAIL}$ value – 1.3.12 |
| | | data lane HS exit: T _{HS-TRAIL} value – 1.3.1. |
| | | |
| | | post-EoT rise time $T_{REOT} - 1.3.14$ |
| | | data lane HS exit: T_{EOT} value – 1.3.15 |
| | | data lane HS exit: T _{HS-EXIT} value – 1.3.16 |

| D-PHY | group 4 (18 tests): clock lane HS-TX | clock lane HS entry: T _{LPX} value – 1.4.1 |
|-------|--|--|
| | signaling requirements | clock lane HS entry: T _{CLK-PREPARE} value – |
| | | 1.4.2 |
| | | clock lane HS entry: |
| | | T _{CLK-PREPARE} + T _{CLK-ZERO} value – 1.4.3 |
| | | clock lane HS-TX differential voltages |
| | | $V_{OD(0)}$ and $V_{OD(1)} - 1.4.4$ |
| | | clock lane HS-TX differential voltage |
| | | mismatch $\Delta V_{OD} - 1.4.5$ |
| | | clock lane HS-TX single-ended output |
| | | voltages $V_{OHHS(DP)}$ and $V_{OHHS(DN)} - 1.4.6$ |
| | | clock lane HS-TX static common mode |
| | | voltages $V_{CMTX(1)}$ and $V_{CMTX(0)} - 1.4.7$ |
| | | clock lane HS-TX static common mode |
| | | voltage mismatch $\Delta V_{CMTX(1, 0)} - 1.4.8$ |
| | | clock lane HS-TX dynamic common-level |
| | | variations from 50 MHz to 450 MHz |
| | | $\Delta V_{\text{CMTX(LF)}} - 1.4.9$ |
| | | clock lane HS-TX dynamic common-level |
| | | variations above 450 MHz $\Delta V_{CMTX(HF)}$ – |
| | | 1.4.10 |
| | | clock lane HS-TX from 20 % to 80 % rise |
| | | time $t_R - 1.4.11$ |
| | | clock lane HS-TX from 80 % to 20 % fall |
| | | time $t_F = 1.4.12$ |
| | | clock lane HS exit: T _{CLK-TRAIL} value – 1.4.13 |
| | | clock lane HS exit: from 30 % to 85 % |
| | | |
| | | post-EoT rise time $T_{REOT} - 1.4.14$ clock lane HS exit: T_{EOT} value - 1.4.15 |
| | | clock lane HS exit: $T_{HS-EXIT}$ value – 1.4.16 |
| | | clock lane HS clock instantaneous: |
| | | UI_{INST} value – 1.4.17 |
| | | clock lane HS clock delta UI: |
| | | (ΔUI) value – 1.4.18 |
| | group 5 (6 tests): HS-TX clock-to-data | HS entry: $T_{CLK-PRE}$ value – 1.5.1 |
| | lane timing requirements | HS exit: T _{CLK-POST} value – 1.5.2 |
| | 5 - 1 | HS clock rising edge alignment to first |
| | | payload bit – 1.5.3 |
| | | data-to-clock skew (T _{SKEW[TX]}) – 1.5.4 |
| | | initial HS skew calibration burst |
| | | T _{SKEWCAL-SYNC} T _{SKEWCAL} - 1.5.5 |
| | | periodic HS skew calibration burst |
| | | T _{SKEWCAL-SYNC} T _{SKEWCAL} – 1.5.6 |

R&S®RTP-K27 MIPI D-PHY 2.5 compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K27 performs D-PHY2 compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports Windows 7, 8 and 10. The numbers behind the test refer to the MIPI CTS for D-PHY V2.0, V2.1 and V2.5.

| Supported D-PHY compliance D-PHY | group 1 (7 tests): data lane LP-TX | data lane LP-TX Thevenin output high |
|-------------------------------------|-------------------------------------|---|
| | signaling requirements | level voltage (V_{OH}) – 1.1.1 |
| | eignamig requiremente | data lane LP-TX Thevenin output low |
| | | level voltage (V_{OL}) – 1.1.2 |
| | | data lane LP-TX from 15 % to |
| | | 85 % rise time (T _{RLP}) – 1.1.3 |
| | | |
| | | data lane LP-TX from 85 % to |
| | | 15 % fall time $(T_{FLP}) - 1.1.4$ |
| | | data lane LP-TX slew rate versus C_{LOAD} ($\delta V/\delta t_{SR}$) – 1.1.5 |
| | | data lane LP-TX pulse width of |
| | | exclusive-OR clock (T _{LP-PULSE-TX}) – 1.1.6 |
| | | data lane LP-TX period of exclusive-OR |
| | | clock $(T_{LP-PER-TX}) - 1.1.7$ |
| | group 2 (5 tests): clock lane LP-TX | clock lane LP-TX Thevenin output high |
| | signaling requirements | level voltage (V_{OH}) – 1.2.1 |
| | signaling requirements | clock lane LP-TX Thevenin output low |
| | | |
| | | level voltage $(V_{OL}) - 1.2.2$ |
| | | clock lane LP-TX from 15 % to |
| | | 85 % rise time (T _{RLP}) – 1.2.3 |
| | | clock lane LP-TX from 85 % to |
| | | 15 % fall time (T _{FLP}) – 1.2.4 |
| | | clock lane LP-TX slew rate versus CLOAD |
| | | (δV/δt _{SR}) – 1.2.5 |
| | group 3 (16 tests): data lane HS-TX | data lane HS entry: data lane T _{LPX} value |
| | signaling requirements | 1.3.1 |
| | | data lane HS entry: data lane |
| | | T _{HS-PREPARE} value – 1.3.2 |
| | | data lane HS entry: data lane |
| | | T _{HS-PREPARE} + T _{HS-ZERO} value – 1.3.3 |
| | | data lane HS-TX differential voltages |
| | | $V_{OD(0)}$ and $V_{OD(1)} - 1.3.4$ |
| | | data lane HS-TX differential voltage |
| | | mismatch $\Delta V_{OD} - 1.3.5$ |
| | | data lane HS-TX single-ended output |
| | | voltages $V_{OHHS(DP)}$ and $V_{OHHS(DN)} - 1.3.6$ |
| | | data lane HS-TX static common mode |
| | | |
| | | voltages $V_{CMTX(1)}$ and $V_{CMTX(0)} - 1.3.7$ |
| | | data lane HS-TX static common mode |
| | | voltage mismatch $\Delta V_{CMTX(1.0)} - 1.3.8$ |
| | | data lane HS-TX dynamic common-leve |
| | | variations from 50 MHz to 450 MHz |
| | | $\Delta V_{CMTX(LF)} - 1.3.9$ |
| | | data lane HS-TX dynamic common-leve |
| | | variations above 450 MHz $\Delta V_{\text{CMTX(HF)}}$ – |
| | | 1.3.10 |
| | | data lane HS-TX from 20 % to 80 % rise |
| | | time t _R – 1.3.11 |
| | | data lane HS-TX from 80 % to 20 % fall |
| | | time t _F - 1.3.12 |
| | | data lane HS exit: T _{HS-TRAIL} value – 1.3.1 |
| | | data lane HS exit: from 30 % to 85 % |
| | | post-EoT rise time $T_{REOT} - 1.3.14$ |
| | | data lane HS exit: T_{EOT} value – 1.3.15 |
| | | |

| Options | R&S [®] RTP-K136 (max. 8 Gbps) or R&S [®] RTP-K137 (max. 16 Gbps) R&S [®] RTP-K140 (max. 8 Gbps) or R&S [®] RTP-K141 (max. 16 Gbps) or R&S [®] RTP-SIBDL1 | advanced eye analysis high speed serial pattern trigger signal integrity bundle (contains the R&S®RTP-K141 16 Gbps high speed serial pattern option) |
|--------------|--|---|
| Requirements | | HS-TX data and clock eye diagram –1.5.7 |
| | eye test (3 tests) | $\label{eq:transformation} \begin{array}{c} T_{\text{SKEWCAL-SYNC}} T_{\text{SKEWCAL}} - 1.5.5 \\ \hline \text{periodic HS skew calibration burst} \\ T_{\text{SKEWCAL-SYNC}} T_{\text{SKEWCAL}} - 1.5.6 \\ \hline \text{alternate calibration sequence } T_{\text{ALTCAL-SYNC}} \\ \hline \text{and } T_{\text{ALTCAL}} - 1.5.8 \\ \hline \text{preamble sequence } T_{\text{PREAMBLE}} \\ \hline \text{and } T_{\text{EXTSYNC}} - 1.5.9 \\ \hline \text{clock and data lane TX HS-Idle } T_{\text{HS-IDLE-PRE}} \\ \hline \text{post}, \\ T_{\text{HS-IDLE-CLKHS0}}, \\ T_{\text{HS-IDLE-PRE}} - 1.5.10 \\ \hline \text{clock lane HS clock delta UI } (\Delta \text{UI}) - 1.4.18 \\ \hline \text{clock lane HS clock period jitter} - 1.4.20 \\ \hline \end{array}$ |
| | group 5 (9 tests): HS-TX clock-to-data lane timing requirements | $\begin{tabular}{ c c c c c } \hline requirements (1.4.19) \\ \hline HS entry: $T_{CLK-PRE}$ value $-$ 1.5.1$ \\ \hline HS exit: $T_{CLK-POST}$ value $-$ 1.5.2$ \\ \hline HS clock rising edge alignment to first payload bit $-$ 1.5.3$ \\ \hline data-to-clock skew ($T_{SKEW[TX]}$) $-$ 1.5.4$ \\ \hline initial HS skew calibration burst \\ \hline \end{tabular}$ |
| | | $\begin{array}{c} \text{post-EoT rise time } T_{\text{REOT}} - 1.4.14 \\ \hline \text{clock lane HS exit: } T_{\text{EOT}} \text{ value } - 1.4.15 \\ \hline \text{clock lane HS exit: } T_{\text{HS-EXIT}} \text{ value } - 1.4.16 \\ \hline \text{clock lane HS clock instantaneous: } \\ \hline Ul_{\text{INST}} \text{ value } - 1.4.17 \\ \hline \text{clock lane HS clock delta UI: } \\ \hline (\Delta \text{UI}) \text{ value } - 1.4.18 \\ \hline \text{TX spread spectrum clocking (SSC)} \end{array}$ |
| | | |
| | | voltage mismatch $\Delta V_{CMTX(1, 0)} - 1.4.8$ clock lane HS-TX dynamic common-level variations from 50 MHz to 450 MHz $\Delta V_{CMTX(LF)} - 1.4.9$ clock lane HS-TX dynamic common-level variations above 450 MHz $\Delta V_{CMTX(HF)} - 1.4.10$ |
| | | $ \begin{array}{c} V_{OD(0)} \text{ and } V_{OD(1)} - 1.4.4 \\ \text{clock lane HS-TX differential voltages} \\ \text{mismatch } \Delta V_{OD} - 1.4.5 \\ \text{clock lane HS-TX single-ended output} \\ \text{voltages } V_{OHHS(DP)} \text{ and } V_{OHHS(DN)} - 1.4.6 \\ \text{clock lane HS-TX static common mode} \\ \text{voltages } V_{CMTX(1)} \text{ and } V_{CMTX(0)} - 1.4.7 \\ \text{clock lane HS-TX static common mode} \\ \end{array} $ |
| D-PHY | group 4 (19 tests): clock lane HS-TX signaling requirements | clock lane HS entry: T _{LPX} value – 1.4.1 clock lane HS entry: T _{CLK-PREPARE} value – 1.4.2 clock lane HS entry: T _{CLK-PREPARE} + T _{CLK-ZERO} value – 1.4.3 clock lane HS-TX differential voltages |

R&S[®]RTP-K28 MIPI C-PHY compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K28 performs C-PHY compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports Windows 7, 8 and 10. The numbers behind the test refer to the MIPI CTS for C-PHY V1.2 and V2.1.

| Supported C-PHY complia C-PHY | group 1 (8 tests): data lane LP-TX signaling requirements | data lane LP-TX Thevenin output high level voltage (V_{OH}) – 1.1.1 |
|----------------------------------|---|---|
| | signaling requirements | data lane LP-TX Thevenin output low |
| | | level voltage (V_{OL}) – 1.1.2 |
| | | data lane LP-TX from 15 % to |
| | | 85 % rise time (T_{RLP}) – 1.1.3 |
| | | data lane LP-TX from 85 % to |
| | | 15 % fall time (T _{FLP}) – 1.1.4 |
| | | data lane LP-TX slew rate versus C_{LOAD} ($\delta V / \delta t_{SR}$) – 1.1.5 |
| | | data lane LP-TX pulse width of |
| | | exclusive-OR clock (T _{LP-PULSE-TX}) – 1.1.6 |
| | | data lane LP-TX period of exclusive-OR clock (T _{LP-PER-TX}) – 1.1.7 |
| | | data lane T _{LP-EXIT} – 1.1.8 |
| | group 2 (17 tests): data lane HS-TX signaling requirements | data lane HS entry: data lane T _{LPX} value 1.2.1 |
| | | data lane HS entry: data lane |
| | | T _{3-PREPARE} value – 1.2.2 |
| | | data lane HS entry: data lane |
| | | T _{3-PREBEGIN} value – 1.2.3 |
| | | data lane HS entry: data lane |
| | | T _{3-PROGSEQ} value – 1.2.4 |
| | | data lane HS entry: data lane |
| | | T _{3-PREEND} value – 1.2.5 |
| | | data lane HS entry: data lane |
| | | T _{3-SYNC} value – 1.2.6 |
| | | data lane HS-TX static common mode |
| | | voltages V _{CPTX} – 1.2.10 |
| | | data lane HS-TX static common mode |
| | | voltage mismatch $\Delta V_{CPTX(HS)} - 1.2.11$ |
| | | data lane HS-TX dynamic common-leve |
| | | variations from 50 MHz to 450 MHz |
| | | $\Delta V_{CPTX(LF)} - 1.2.12$ |
| | | data lane HS-TX dynamic common-leve |
| | | variations above 450 MHz $\Delta V_{CPTX(HF)}$ – |
| | | 1.2.13 |
| | | data lane HS-TX rise time t _R – 1.2.14 |
| | | data lane HS-TX fall time t _F – 1.2.15 |
| | | data lane T _{3-POST} duration – 1.2.16 |
| | | data lane HS exit: from 30 % to 85 % |
| | | post-EoT rise time T _{REOT} – 1.2.17 |
| | | data lane HS exit: T _{HS-EXIT} value – 1.2.18 |
| | | data lane HS clock instantaneous UI Ul _{ir} |
| | | value – 1.2.19 |
| | | data lane HS clock delta UI ΔUI value - |
| | | 1.2.20 |
| | group 2 (5 tests): data lane HS-TX | data lane HS-TX differential voltages |
| | signaling requirements eye test | V_{OD_AB} , V_{OD_BC} and $V_{CA} - 1.2.7$ |
| | | data lane HS-TX differential voltage mismatch $\Delta V_{OD} - 1.2.8$ |
| | | data lane HS-TX single-ended output |
| | | voltages V _{OHHS(AB)} , V _{OHHS(BC)} and V _{OHHS(CA)} 1.2.9 |
| | | data lane TX eye diagram test – 1.2.21 |
| | | data lane HS-TX UI jitter UI_Jitter _{peak+tx} |
| | | value – 1.2.22 |

| Requirements | | |
|--------------|---|--|
| Options | R&S [®] RTP-K136 (max. 8 Gbps) or | advanced eye analysis |
| | R&S®RTP-K137 (max. 16 Gbps) | |
| | R&S [®] RTP-K140 (max. 8 Gbps) or | high speed serial pattern trigger |
| | R&S [®] RTP-K141 (max. 16 Gbps) or | |
| | R&S [®] RTP-SIBDL1 | signal integrity bundle (contains the |
| | | R&S [®] RTP-K141 16 Gbps high speed |
| | | serial pattern option) |

R&S[®]RTP-K35 bus analysis

| General description | The R&S [®] RTP-K35 bus analysis option adds bus measurements and analysis | | | |
|---------------------|---|---|--|--|
| | functions for dedicated protocols. | | | |
| | supported protocol options | R&S®RTP-K1 (I ² C, SPI), R&S®RTP-K2 (UART), R&S®RTP-K3 (CAN, LIN), R&S®RTP-K8 (Ethernet), R&S®RTP-K9 (CAN-FD), R&S®RTP-K40 (RFFE), R&S®RTP-K57 (100BASE-T1) | | |
| Measurements | field value | allows the selection of frame types and displays the value of a specified field; the value can be displayed as track and histogram | | |
| | frame to frame | measures the distance between the starts of two selectable frame types in seconds | | |
| | trigger to frame | measures the distance between the trigger event and the start of a selectable frame type in seconds; alternatively, measures the distance between the start of a selectable frame type and the trigger event | | |
| | frame count | counts the total number of frames in each acquisition | | |
| | gap time | measures the distance between the end of a selectable frame type to the start of another selectable frame type in seconds | | |
| | bus idle ratio | measures the percentage of idle time on bus; idle time is defined as the time when the bus is not occupied by frames | | |
| | main bit rate | measures the main bit rate of a protocol based on the relevant bits in a frame; if a protocol provides multiple bit rates, the most relevant bit rate is being measured | | |
| | secondary bit rate | for protocols with multiple bit rates, the secondary bit rate is available | | |
| | frame error count | counts the total number of erroneous frames in each acquisition | | |
| | frame error rate | measures the percentage of erroneous frames in relation to the total frames | | |
| | consecutive frame error rate | measures the percentage of follow up (consecutive) frame errors, ignoring all single frame errors | | |

R&S®RTP-K37 spectrogram

| General description | | The R&S [®] RTP-K37 spectrogram option allows advanced signal analysis in the requency domain by visualization of the frequency spectrum versus time. | |
|---------------------|-------------------------|---|--|
| Spectrogram | display characteristics | spectrogram display; a separate spectrogram can be created for each FFT display; each FFT segment of a captured acquisition is displayed in a separate spectrogram line support of logarithmic frequency x-axis | |
| | number of spectrograms | up to 4 | |
| | signal colors | predefined or user-defined color tables for persistence display with the spectrogram | |
| | time lines | in stop mode two separate time lines can be used to navigate through a spectrogram in time; for each time line the relevant FFT segment is displayed in a diagram; the difference in acquisition time between the timelines is displayed | |

R&S[®]RTP-K39 user-defined math

| General description | The R&S®RTP-K39 user-defined math option provides a Python interface to apply user |
|---------------------|--|
| | functions defined by Python scripts to the waveform processing. The output can be |
| | visualized as a waveform math signal. |

R&S®RTP-K40 MIPI RFFE serial triggering and decoding

| Protocol configuration | signal type | two channel, single-ended |
|------------------------|----------------------|---|
| | bit rate | auto-detected |
| | auto threshold setup | assisted threshold configuration |
| | full autoset | full autoset of horizontal and vertical |
| | | settings and auto threshold setup |
| | source (SCLK, SDATA) | any two input channels, math waveforms, |
| | | reference waveforms or logical channels |
| | supported version | 1.X, 2.0, 2.1 and 3.0 |
| | read mode | standard or sRead mode |
| | glitch filter | configurable glitch filter |
| | gap detection | detect gaps between sequences |

Trigger

| trigger event setup | sequence start, sequence stop, register 0 write, register write, register read, extended register write, extended register read, extended register write long, extended register read long, error condition types |
|--|--|
| sequence start setup | 4 bit slave address; conditions =, ≠, <, ≤, >, ≥, in range, out of range |
| sequence stop setup | 4 bit slave address; conditions =, ≠, <, ≤, >, ≥, in range, out of range |
| register 0 write setup | 4 bit slave address, 7 bit data word; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options |
| register write/read | 4 bit slave address, 5 bit register address 8 bit data word; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options |
| extended register write/read | 4 bit slave address; 8 bit address, byte count: 0 to 15 (inclusive), data pattern: 1 byte to 16 byte (hex or binary); conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options; index: 1 to 16 selects the specific data frame byte; conditions =, ≠, <, ≤, >, ≥, in range |
| extended register write long/read long | 4 bit slave address, 8 bit address, byte count: 0 to 7 (inclusive), data pattern: 0 to 8 byte (hex or binary); conditions =, \neq , <, \leq , >, \geq , in range, out of range for each of these options; index: 1 to 8 selects the specific data frame byte; conditions =, \neq , <, \leq , >, \geq , in range |
| interrupt summary and notification | 4 bit slave address, bit count 0 to 32, notification and interrupt bits |
| masked write | 4 bit slave address; 8 bit address, 8 bit mask, 8 bit data pattern; conditions =, \neq , $<$, \leq , $>$, \geq , in range, out of range for each of these options; frame byte; conditions =, \neq , $<$, \leq , $>$, \geq , in range |
| master ownership handover | 2 bit MID; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options; frame byte; conditions =, ≠, <, ≤, >, ≥, in range |
| master write/read | 2 bit MID, 8 bit address, 16 bit data pattern; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options; frame byte; conditions =, ≠, <, ≤, >, ≥, in range |
| master context transfer write/read | 2 bit MID, 8 bit byte count, 8 bit address, data pattern: 1 byte to 8 byte (hex or binary); conditions =, \neq , <, \leq , >, \geq , in range, out of range for each of these options; index: 1 to 256 selects the specific data frame byte; conditions =, \neq , <, \leq , >, \geq , in range |
| error condition | SSC error; length error, bus park error, parity error, no response, unknown sequence, version error, min. gap between frames: 1 ns to 10 us |

| Decode | display type | decoded bus, logical signal, bus + logical signal, tabulated list, decode layers |
|--------|--------------------|--|
| | color coding | sequence, frame, error |
| | data format | hex, octal, binary, signed, unsigned |
| | decode layer | off, edges, bit |
| | result export | export of all result data into CSV, XML, HTML and PY file formats |
| Search | search event setup | sequence start, sequence stop, register 0 write, register write, register read, extended register write, extended register read, extended register write long, extended register read long, master read, master write, master ownership handover, interrupt summary and notification, error condition types |
| | event settings | same as trigger event settings |

R&S[®]RTP-K42 MIPI D-PHY serial triggering and decoding

| single-ended) |
|---|
| ine (1 Mbps to |
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| e |
| waveforms, |
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| , DSI v. 1.3 |
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| |
| word count; in range, out of ount |
| word count, nditions =, ≠, <, |
| nge for data |
| alue |
| data index; |
| in range, out of |
| nd data value |
| st, details, |
| t, uctans, |
| ding to trace, |
| data word |
| unsigned |
| HS burst bit, HS |
| te, HS merged |
| es, LP active |
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R&S[®]RTP-K44 MIPI M-PHY serial triggering and decoding

| | J. J. J. | 9 |
|------------------------|---------------------|--|
| Protocol configuration | signal type | up to 4 channels, differential |
| | bit rate | clock recovery |
| | source (SDATA) | analog and math channels, |
| | , | reference waveforms |
| | variants | UniPro 1.6 and M-PHY 4.0 |
| Trigger | trigger event setup | M-PHY burst |
| | | M-PHY adapt |
| | | M-PHY LCC |
| | | UniPro DL_PDU frames |
| | | UniPro PACP frames |
| | | UniPro trigger upper frames |
| | | M-PHY/UniPro errors |
| Decode | display type | decoded bus, logical signal, bus + logical |
| | | signal, tabulated list, details, decode |
| | | layers |
| | color coding | for different cells/frame types |
| | data format | K/D symbols; with UniPro additionally: |
| | | hex, octal, binary, signed, unsigned |
| | decode layer | off, edges, bit, 8b10b synbols, LCC bit; |
| | | with UniPro additionally: filter/descrambler |
| | | lane merge, byte |
| Search | search event setup | M-PHY burst |
| | | M-PHY adapt |
| | | M-PHY LCC |
| | | UniPro DL_PDU frames |
| | | UniPro PACP frames |
| | | UniPro trigger upper frames |
| | | M-PHY/UniPro errors |

R&S®RTP-K50 Manchester and NRZ serial triggering and decoding

| Protocol configuration | signal type | selectable, |
|------------------------|--|---|
| | | one channel, differential or single-ended, |
| | | two channel, differential or single-ended |
| | bit rate | auto detected, adjustable |
| | auto threshold setup | assisted threshold configuration |
| | source | analog, math. channels, logical (only NRZ) |
| | bit encoding variants | Manchester, |
| | | Manchester II, |
| | | NRZ clocked, |
| | | NRZ unclocked |
| | properties | active state (high/low), idle state |
| | | (high/low), clock edge (first/second) |
| | frame separation | gap, enable signal (only NRZ) |
| Frame format | frame | multiple frame management, |
| | | frame identification and sync, |
| | | variable length frames, |
| | | variable number of cells |
| | cells | name, size (bit), numeric format, bit order, |
| | | color |
| | file storage of frame format | save/load as xml files |
| Trigger | variants | all supported bit encodings |
| | trigger event setup | frame start |
| | | pattern |
| | | advanced trigger |
| | frame start | gap, start bit |
| | pattern | up to 256 bit pattern within 65 535 bit |
| | | frame |
| | advanced trigger | frame type (with OR combinations), frame |
| | | fields (with AND combinations), frame field |
| | | data; conditions =, \neq , <, ≤, >, ≥, in range, |
| | | out of range for data count, word count, |
| | | data value; error types |
| Decode | display type | decoded bus, logical signal, bus signal, |
| | | tabulated list, result details, decode layers |
| | color coding | according to cell configuration table |
| | data format | according to cell configuration table |
| | decode layer | edges, binary |
| Search | event settings | same as advanced trigger settings |
| Filter | V | ode events that shall be shown in the result table. |
| | Events that do not match the criteria set will not be displayed in the table when the filter | |
| | is turned on. | |
| | settings | same as advanced trigger settings |

R&S[®]RTP-K52 8b10b serial triggering and decoding

| Protocol configuration | signal type | one/two channel, differential, single-ended |
|------------------------|---|---|
| | bit rate | selectable/adjustable auto configuration, ideal for bitrate up to 6.25 Gbit/s |
| | auto threshold setup | assisted threshold configuration |
| | one click setup | convenient way for perfect decode results; auto scaling of waveforms, auto threshold and bitrate estimation on one click |
| | source (differential, single-ended D+/D-) | full combination of either analog, math, reference channels |
| | variants | all layer 1 (physical layer) encoded 8b10b protocols, recommended for Ethernet, FibreChannel 1G, 2G, PCI Express, Serial ATA, Serial Rapid IO (SRIO), XAUI |
| Trigger | trigger event setup | symbols, errors |
| | symbols | K/D symbol (8 bit/10 bit), complex expression (combination of K/D symbols, wildcards, disparity) |
| | errors | disparity, glitching and unknown symbol |
| Decode | display type | decoded bus, bus signal, tabulated list, details, decode layers |
| | color coding | sync symbol, K symbols, data (Dx.y) coding and error coding |
| | data format | hex, 10 bit and K/D representation |
| | decode layer | edges, bit |
| Search | search event setup | symbols, errors |
| | event settings | same as trigger event settings |

R&S®RTP-K55 MDIO serial triggering and decoding

| Protocol configuration | bit rate | up to 5 Mbps (auto-detected) |
|------------------------|---|--|
| | auto threshold setup | assisted threshold configuration for |
| | | MDIO triggering and decoding |
| | device list | associate frame address with symbolic ID |
| Trigger | source (clock and data) | any input channel or logical channel |
| | trigger event setup | start, stop, ST, OP, PHY address, register |
| | | address, data |
| | ST setup | 01 (clause 22), 00 clause 45, any |
| | OP setup | address, write, post read, read, any |
| | PHY address setup | 5 bit address (hex, decimal, octal or |
| | | binary); equal |
| | PHY register (clause 22)/device type | 5 bit value (hex, decimal, octal or binary); |
| | (clause 45) setup | equal |
| | data (clause 22)/data/address (clause 45) | 16 bit value (hex, decimal, octal or |
| | | binary); equal |
| Decode | source (clock and data) | any input channel, math waveform, |
| | | reference waveform, logical channel |
| | display type | decoded bus, logical signal, bus + logical |
| | | signal, tabulated list, decode layers |
| | color coding | frame, PHY address, PHY register, |
| | | address, data, turnaround |
| | PHYAD/PRTAD | symbolic names for user-defined |
| | | addresses |
| | address/data field format | hex, decimal, octal, binary, ASCII, signed, |
| | | unsigned |
| | decode layer | final, edges, binary |
| Search | source (clock and data) | any input channel, math waveform, |
| | | reference waveform, logical channel |
| | search event setup | start, stop, ST, OP, PHY address, register |
| | | address, data |
| | event settings | same as trigger event settings |

R&S®RTP-K57 Ethernet (100BASE-T1) serial triggering and decoding

| Protocol configuration | signal type | one channel differential, two channels single-ended, optional additional use of |
|------------------------|-----------------------|---|
| | | reverse channels for signal improvement: |
| | | one channel differential, two channels |
| | | single-ended |
| | symbol rate | 66.667 Msymbol/s, adjustable for testing |
| | thresholds | upper/lower, assisted threshold configuration |
| | source | any analog input channels, math waveforms, reference waveforms |
| | polarity | normal, inverted |
| | mode | slave, master |
| Trigger | trigger event setup | frame start |
| | | MAC frame |
| | | idle frame |
| | | error conditions |
| | MAC frame setup | destination address (condition =, \neq , <, >, |
| | | ≥, ≤, in range, out of range), source |
| | | address (condition =, \neq , <, >, ≥, ≤, in |
| | | range, out of range), length/type |
| | | (condition =, \neq , <, >, ≥, ≤, in range, out of |
| | | range), frame check (condition =, \neq , <, >, |
| | | ≥, ≤, in range, out of range), data |
| | | (condition =, \neq , <, >, ≥, ≤, in range, out of |
| | | range), data index (condition =, <, >, \geq , \leq , range) |
| | error condition setup | preamble error, CRC error, SFD error |
| Decode | display type | decoded bus, tabulated list, details, |
| | | decode layers |
| | color coding | for different cells types |
| | data format | hex, octal, binary, signed, unsigned |
| | decode layer | reversed bit, descrambled bit, scrambled bit, ternary symbols |
| | result export | export of all result data into CSV, XML, |
| | | HTML and PY file formats |
| Search | search event setup | frame start |
| | | MAC frame |
| | | idle frame |
| | | error conditions |
| | event settings | same as trigger event settings |

R&S®RTP-K58 Ethernet (1000BASE-T1) serial triggering and decoding

| Protocol configuration | signal type | one channel differential, two channels single-ended, optional additional use of reverse channels for signal improvement: one channel differential, two channels single-ended |
|------------------------|-----------------------|--|
| | symbol rate | 750 Msymbol/s, adjustable for testing |
| | thresholds | automatically adjusted during decoding |
| | source | any analog input channels, math |
| | | waveforms, reference waveforms |
| | polarity | normal, inverted |
| | mode | slave, master |
| Trigger | trigger event setup | frame start |
| | | MAC frame |
| | | idle frame |
| | | error conditions |
| | MAC frame setup | destination address (condition =, ≠, <, >, |
| | | \geq , \leq , in range, out of range), source |
| | | address (condition =, \neq , <, >, ≥, ≤, in |
| | | range, out of range), length/type |
| | | (condition =, \neq , <, >, \geq , \leq , in range, out of |
| | | range), frame check (condition =, \neq , <, >, |
| | | \geq , \leq , in range, out of range), data |
| | | (condition =, \neq , <, >, \ge , \le , in range, out of range), data index (condition =, <, >, \ge , \le , |
| | | range) |
| | error condition setup | RS-FEC error, out of range error, |
| | | CRC error, SFD error |
| Decode | display type | decoded bus, tabulated list, details, |
| | | decode layers |
| | color coding | for different cells types |
| | data format | hex, octal, binary, signed, unsigned |
| | decode layer | ternary symbols, scrambled bit, descrambled bit, corrected RS-FEC |
| | | symbols |
| | result export | export of all result data into CSV, XML, |
| | | HTML and PY file formats |
| Search | search event setup | frame start |
| | | MAC frame |
| | | idle frame |
| | | error conditions |
| | event settings | same as trigger event settings |

R&S[®]RTP-K60 USB 1.0/1.1/2.0 serial triggering and decoding

| Protocol configuration | signal type | single-ended, differential |
|------------------------|---|--|
| - | protocol type | low, full and high speed |
| | bit rate | standard bit rates (1.5/12/480 Mbit/s) |
| | source | any input channel |
| | probe type | |
| | for low and full speed | single-ended probe |
| | for high speed | differential probe (R&S®RT-ZDx) |
| | auto threshold setup | assisted threshold configuration for USB triggering and decoding |
| Trigger ¹² | trigger event setup | start of packet, end of packet, PID token (IN, OUT, SETUP, SOF), PID data (Data0 Data1, Data2 ¹¹ , MData ¹¹), PID handshake (ACK, NAK, STALL, NYET ¹¹), PID special (PRE ¹² , ERR ¹¹ , SPLIT ¹¹ , PING ¹¹); bus state (reset ¹² , resume ¹² , suspend ¹²); error condition |
| | address, endpoint and frame setup SC, port, SEU, ET check (SPLIT) ¹² | condition =, \neq , \geq , \leq , in range, out of range |
| | data setup | data pattern up to 4 byte (hex, decimal, octal, binary or ASCII), bit separately configurable (1, 0 or don't care); condition =, ≠; position based or window based triggering (first occurrence in packe payload) |
| | error condition | any error, PID error, CRC5 error, CRC16 error, bit stuffing error, unexpected PID, SE1 error ¹² and glitching error |
| Decode | source | any input channel, math waveform |
| | display type | decoded bus, logical signal, bus + logical signal, tabulated list |
| | color coding | packet identifier, payload length, frame, address, endpoint, data payload, CRC5, CRC16, error condition |
| | data format | hexadecimal, decimal, octal, binary, ASCII, unsigned |
| Search | search event setup | combination of start of packet, PID token (IN, OUT, SETUP, SOF), PID data (Data0 Data1, Data2 ¹¹ , MData ¹¹), PID handshake (ACK, NAK, STALL, NYET ¹¹), PID special (PRE ¹² , ERR ¹¹ , SPLIT ¹¹ , PING ¹¹); error condition (any error, PID error, CRC5 error, CRC16 error, bit stuffing error, unexpected PID, SE1 error ¹² and glitching error) |
| | address, endpoint and frame setup SC, port, SEU, ET check (SPLIT) | condition =, \neq , \geq , \leq , in range, out of range |
| | data setup | data pattern up to 4 byte (hex, decimal, octal, binary or ASCII), bit separately configurable (1, 0 or don't care); condition =, ≠; position based or window based triggering (first occurrence in packe payload) |
| | error condition | any error, PID error, CRC5 error, CRC16 error, bit stuffing error, unexpected PID, SE1 error ¹² and glitching error |

¹¹ Only available in high speed.

¹² Only available in low and full speed.

R&S®RTP-K61 USB 3.1 Gen 1 serial triggering and decoding

| Protocol configuration | signal type | one channel |
|------------------------|---------------------------|--|
| | bit rate | auto detected |
| | auto threshold setup | supported |
| | source | any analog input channels, math |
| | | channels, reference channels |
| | scrambling | selectable |
| | digital signal processing | CTLE continuous time equalizer; |
| | | DFE decision feedback equalizer |
| Trigger | trigger event setup | frame start |
| | | frame content |
| | | errors |
| | frame content | USB packet types: TSEQ, TSET1, TSET2, set link function, U2 inactivity timeout, vendor device test, port capability, port configuration, port, config. resp., link delay meas, ACK, NRDY, ERDY, STATUS, STALL, function wake, latency tolerance, bus interval, adjust, host role request, sublink speed, ping, ping response, data packet header, data packet payload, DPP aborted, isochronous timestamp, link command, info, BRST, BDAT, BERC, BCNT, idle; fields according to selected USB packet |
| | | with content conditions =, \neq , <, >, \geq , \leq , in range, out of range |
| | errors | CRC, length, value out of range |
| Decode | display type | decoded bus, tabulated list, details, decode layers |
| | color coding | cell and frame types |
| | data format | hexadecimal, octal, binary, ASCII, signed unsigned, symbols |
| | decode layer | edges, bit, scrambled symbols, descrambled symbols, byte |
| | result export | export of all result data into CSV, XML, HTML and PY file formats |
| Search | search event setup | frame start |
| | | frame content |
| | | errors |
| | event settings | same as trigger event settings |

R&S®RTP-K62 USB 3.1 Gen 2 serial triggering and decoding

| Protocol configuration | signal type | one channel |
|------------------------|---------------------------|---|
| | bit rate | auto detected |
| | auto threshold setup | supported |
| | source | any analog input channels, math channels, reference channels |
| | scrambling | selectable |
| | digital signal processing | CTLE continuous time equalizer; DFE decision feedback equalizer |
| Trigger | trigger event setup | frame start |
| | | frame content |
| | | errors |
| | frame content | USB packet types: TSEQ, TSET1, TSET2, set link function, U2 inactivity timeout, vendor device test, port capability, port configuration, port, config. resp., link delay meas, ACK, NRDY, ERDY, STATUS, STALL, function wake, latency tolerance, bus interval, adjust, host role request, sublink speed, ping, ping response, data packet header, data packet payload, DPP aborted, isochronous timestamp, link command, info, BRST, BDAT, BERC, BCNT, idle; fields according to selected USB packet with content conditions =, ≠, <, >, ≥, ≤, in range, out of range |
| | errors | CRC, length, value out of range |
| Decode | display type | decoded bus, tabulated list, details, decode layers |
| | color coding | cell and frame types |
| | data format | hexadecimal, octal, binary, ASCII, signed unsigned, symbols |
| | decode layer | edges, bit, scrambled symbols, descrambled symbols, byte |
| | result export | export of all result data into CSV, XML, HTML and PY file formats |
| Search | search event setup | frame start |
| | | frame content |
| | | errors |
| | event settings | same as trigger event settings |

R&S[®]RTP-K63 USB power delivery serial triggering and decoding

| • | / 55 | 8 |
|------------------------|---------------------|--|
| Protocol configuration | signal type | one channel |
| | bit rate | auto detected |
| | source | any analog input channel, logical channels, math channels, reference channels |
| | thresholds | data, advertisements |
| | data details | detailed breakdown selectable |
| Trigger | trigger event setup | frame start |
| | | frame content |
| | | errors |
| | frame content | extended, NumDataObjs, MsgID, PwrRole/Plug, Rev, DataRole, MsgType, voltage advertisements (content conditions =, ≠, <, >, ≥, ≤, in range, out of range) |
| | errors | 4b5b, preamble, CRC, length, SOP warning |
| Decode | display type | decoded bus, logical signal, bus + logical signal, tabulated list, details, decode layers |
| | color coding | cell and frame types |
| | data format | hex, octal, binary, signed, unsigned |
| | decode layer | edges, bit, 4b5b symbols |
| Search | search event setup | frame start |
| | | frame content |
| | | errors |
| | event settings | same as trigger event settings |
| | | |

R&S®RTP-K64 USB 3.1 SSIC serial triggering and decoding

| Protocol configuration | signal type | up to 4 lanes differential |
|------------------------|---------------------------|---|
| | bit rate | auto detected |
| | source | any analog input channels, math channels reference channels |
| | scrambling | selectable |
| | digital signal processing | CTLE continuous time equalizer; DFE decision feedback equalizer |
| Trigger | trigger event setup | frame start |
| | | frame content |
| | | errors |
| | frame content | USB packet types: TSEQ, TSET1, TSET2, set link function, U2 inactivity timeout, vendor device test, port capability, port configuration, port, config. resp., link delay meas, ACK, NRDY, ERDY, STATUS, STALL, function wake, latency tolerance, bus interval, adjust, host role request, sublink speed, ping, ping response, data packet header, data packet payload, DPP aborted, isochronous timestamp, link command, info, BRST, BDAT, BERC, BCNT, idle; fields according to selected USB packet with content conditions =, ≠, <, >, ≥, ≤, in range, out of range |
| | errors | CRC, length, value out of range |
| Decode | display type | decoded bus, tabulated list, details, decode layers |
| | color coding | cell and frame types |
| | data format | hex, octal, binary, signed, unsigned |
| | decode layer | off, edges, bit, byte, 8b10b symbols, LCC bit, descrambler, lane merge |
| Search | search event setup | frame start |
| | | frame content |
| | | errors |
| | event settings | same as trigger event settings |

R&S®RTP-K65 SpaceWire serial triggering and decoding

| Protocol configuration | signal type | two channels: strobe and data (differential or single-ended) |
|------------------------|------------------------|---|
| | bit rate | auto adjust (strobe + data) |
| | source | any analog input channels, logical |
| | | channels ¹³ , math channels, reference |
| | | channels |
| Trigger | trigger event setup | control frame, data pattern, null frame, |
| | | time code, error condition |
| | control frame setup | any, FCT, EOP, EEP |
| | data pattern setup | 8 bit (condition =, \neq , <, >, ≥, ≤, in range, |
| | | out of range) |
| | time code setup | 8 bit (condition =, \neq , <, >, ≥, ≤, in range, |
| | | out of range) |
| | errors condition setup | parity, ESC |
| Decode | display type | decoded bus, logical signal, bus + logical signal, tabulated list, decode layers |
| | color coding | control frame, data frame, null frame, time code |
| | data format | hex, octal, binary, signed, unsigned |
| Search | search event setup | control frame, data pattern, null frame, time code, error |
| | event settings | same as trigger event settings |

¹³ SpaceWire protocol trigger on logical channels is not available.

R&S[®]RTP-K72 PCI Express 1.1/2.0 serial triggering and decoding

| Protocol configuration | signal type | up to four channels (x1, x2, x4 link size) differential signals |
|------------------------|---------------------------------|--|
| | bit rate | predefined 2.5 Gbit/s for Gen 1 and 5 Gbit/s for Gen 2 |
| | source | any analog input channels, math channels, reference channels |
| | digital signal processing | CTLE continuous time equalizer; DFE decision feedback equalizer |
| Trigger | trigger event setup | TLP (transaction layer packets), DLLP (data layer packets), ordered sets, errors |
| | transaction layer packets (TLP) | any type, memory request (32 bit/64 bit, R/W, ordering, snoop, seq. number, Requester ID), I/O transactions, configuration requests, message requests (incl. routing and message code), completion packets (status, completer ID), atomic operation (FetchAdd, SWAP, CAS) for 32 bit/64 bit |
| | data layer packets (DLLP) | any type, Ack and Nak (seq. number), InitFC1, InitFC2, updateFC (credit type C, NP, Cpl and virtual channel), power management with PM type, vendor packet format. multi-root I/O virtualization (MRDLLP): MRInit (phase, VH FC, mixed type, authorized, device/port type), MRReset (A, VH Group), MRUpdateFC, MRInitFC1 and MRInitFC2 (VL number, VH absent, TLP type, credit type) |
| | ordered sets | SKP OS, training sequence (TS1, TS2), fast training sequence (FTS), electrical idle OS, electrical idle exit OS, compliance and modified compliance pattern |
| | errors condition setup | CRC16, ECRC, LCRC, disparity, invalid packets (corrupt header or length errors) |
| Decode | display type | decoded bus, tabulated list, decode layers, detailed result display for packets |
| | color coding | TLP, DLLP, K-code, D-code, ordered sets, errors |
| | data format | K/D symbol, 8 bit format (hex) |
| | decode layer | 8b10b, descrambled 8b10b, bit |
| | result export | export of all result data into CSV, XML, HTML and PY file formats |
| Search | search event setup | TLP, DLLP, ordered sets, errors |
| | event settings | same as trigger event settings |

R&S®RTP-K73 PCI Express 3.0 serial triggering and decoding

| Protocol configuration | signal type | up to four channels (x1, x2, x4 link size) differential signals |
|------------------------|---------------------------------|---|
| | bit rate | predefined 8 Gbit/s |
| | source | any analog input channels, math |
| | | channels, reference channels |
| | digital signal processing | CTLE continuous time equalizer; |
| | | DFE decision feedback equalizer |
| Trigger | trigger event setup | TLP (transaction layer packets), DLLP (data layer packets), ordered sets, errors |
| | transaction layer packets (TLP) | any type, memory request (32 bit/64 bit, R/W, |
| | | ordering, snoop, seq. number, requester ID), I/O transactions, configuration |
| | | requests, message requests (incl. routing and message code), completion packets (ctatus, completer ID), ctamic apartition |
| | | (status, completer ID), atomic operation (FetchAdd, SWAP, CAS) for 32 bit/64 bit |
| | data layer packets (DLLP) | any type, Ack and Nak (seq. number), InitFC1, InitFC2, updateFC (credit type C, |
| | | NP, Cpl and virtual channel), power management with PM type, vendor packet |
| | | format. multi-root I/O virtualization (MRDLLP): |
| | | MRInit (phase, VH FC, mixed type, |
| | | authorized, device/port type), MRReset (A, VH Group), MRUpdateFC, MRInitFC1 and MRInitFC2 (VL number, VH absent, |
| | | TLP type, credit type) |
| | ordered sets | SKP OS, training sequence (TS1, TS2), fast training sequence (FTS), electrical idle OS, electrical idle exit OS, |
| | | compliance and modified compliance pattern |
| | errors condition setup | CRC16, ECRC, LCRC, disparity, invalid packets (corrupt header or length errors) |
| Decode | display type | decoded bus, tabulated list, decode layers, detailed result display for packets |
| | color coding | TLP, DLLP, K-code, D-code, ordered sets, errors |
| | data format | hex, octal, binary |
| | decode layer | edges, bit |
| | result export | export of all result data into CSV, XML, HTML and PY file formats |
| Search | search event setup | TLP, DLLP, ordered sets, errors |
| | event settings | same as trigger event settings |

R&S®RTP-K81 PCI Express 1.1/2.0 compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K81 performs PCIe 1.x/2.0 (up to 2.5GT/s) compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports Windows 7, 8 and 10. The chapters after the category refer to PCI Express Base Specification Revision 1.1 and 2.1.

| PCle 1.1 | signal quality (4.3.3) | mean unit interval |
|----------|------------------------------------|---|
| | | data rate |
| | | template tests |
| | | min eye width |
| | | median to max. jitter |
| | | differential output voltage |
| | reference clock (1.32) | differential input high voltage |
| | | differential input low voltage |
| | | duty cycle |
| | | average clock period |
| | | rising edge rate |
| | | falling edge rate |
| | common-mode output voltage (4.3.3) | RMS AC peak common mode output |
| | | voltage |
| | | AVG DC common mode output voltage |
| | | DC common mode line delta |
| | | DC common mode output voltage variation |
| | common-mode input voltage (4.3.3) | AC common mode input voltage |
| PCle 2.0 | signal quality (4.3.3) | mean unit interval |
| | | data rate |
| | | template tests |
| | | min eye width |
| | | median to max. jitter |
| | | differential output voltage |

R&S®RTP-K83 PCI Express 1.1/2.0/3.0 compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K83 performs PCIe 1.1/2.0/3.0 compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports Windows 7, 8 and 10.

| Supported PCIe complian | ce tests | |
|-------------------------|------------------------------------|---|
| PCIe 1.1 | signal quality (4.3.3) | mean unit interval |
| | | data rate |
| | | template tests |
| | | min. eye width |
| | | median to max. jitter |
| | | differential output voltage |
| | reference clock (1.32) | differential input high voltage |
| | | differential input low voltage |
| | | duty cycle |
| | | average clock period |
| | | rising edge rate |
| | | falling edge rate |
| | common mode output voltage (4.3.3) | RMS AC peak common mode output |
| | | voltage |
| | | AVG DC common mode output voltage |
| | | DC common mode line delta |
| | | DC common mode output voltage variation |
| | common mode input voltage (4.3.3) | AC common mode input voltage |
| PCIe 2.0 | signal quality (4.3.3) | mean unit interval |
| | | data rate |
| | | template tests |
| | | min eye width |
| | | median to max. jitter |
| | | differential output voltage |

| PCle 3.0 | signal quality (4.3.3.13) | mean unit interval |
|----------|---------------------------------------|---|
| | | data rate |
| | | template tests |
| | | min. eye width |
| | TX base specifications (4.3.3.13.1) | TX voltage with no equalization |
| | | min. swing during electrical idle exit sequence ordered set (EIEOS) |
| | | pseudo package loss |
| | | uncorrelated total jitter |
| | | uncorrelated deterministic jitter |
| | | uncorrelated total pulse width jitter |
| | | uncorrelated deterministic pulse width |
| | | jitter |
| | | data dependent jitter |
| | reference clock (4.3.8) | REF _{CLK} frequency |
| | | REF _{CLK} jitter |
| | | sSsc frequency range |
| | | ssc deviation |
| | common-mode output voltage (4.3.3.13) | AC common mode voltage |
| | | (30 kHz to 500 MHz) |
| | | AC common mode voltage |
| | | (< 4 GHz lowpass filter) |
| | | transmitter avg dc common mode voltage |
| | | DC common mode voltage |
| | | between d+ and d- |
| | | DC common mode voltage |
| | | during I0 and electrical idle |
| | TX equalization presets (4.3.3.5.2) | p0-p10 deemphasis |
| | | p0-p10 preshoot |

R&S®RTP-K87 Ethernet compliance test (1000BASE-T1)

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K87 performs 1000BASE-T1 compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports the R&S[®]RT-ZF6 frequency converter as well as R&S[®]RT-ZF7A and R&S[®]RT-ZF8 test fixtures; R&S[®]ScopeSuite supports Windows 7, 8 and 10. The chapters in front of the test cases refer to IEEE 802.3-2018. OPEN Alliance ECU specification supported, where applicable.

| Supported 1000BASE-T1 compliance tests | |
|--|---|
| 1000BASE-T1 | 97.5.3.3 transmitter timing jitter master mode |
| | 97.5.3.3 transmitter timing jitter slave mode |
| | 97.5.3.3 transmitter timing MDI jitter |
| | 97.5.3.6 transmitter clock frequency |
| | 97.5.3.2 transmitter distortion |
| | 97.5.3.4 transmitter power spectral density (PSD) |
| | 97.5.3.4 transmitter power level |
| | 97.5.3.5 transmitter peak differential output |
| | 97.5.3.1 maximum output droop |
| | 97.7.2.1 MDI return loss |
| | 97.7.2.2 MDI mode conversion loss |
| | MDI adapter verification |

R&S[®]RTP-K88 Ethernet compliance test (MGBASE-T1)

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K88 performs MGBASE-T1 compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports R&S[®]RT-ZF7A and R&S[®]RT-ZF8 test fixtures; R&S[®]ScopeSuite supports Windows 7, 8 and 10. The chapters in front of the test cases refer to IEEE P802.3ch.

| Supported MGBASE-T1 compliance tests | |
|--------------------------------------|--|
| MGBASE-T1 (2.5/5/10G) | 149.5.2.1 maximum output droop |
| | 149.5.2.2 transmitter linearity |
| | 149.5.2.3 transmitter timing jitter master |
| | 149.5.2.3 transmitter timing jitter slave |
| | 149.5.2.3.1 transmit MDI random jitter in master mode |
| | 149.5.2.3.2 transmit MDI deterministic jitter in master mode |
| | 149.5.2.4 transmitter power spectral density (PSD) and power level |
| | 149.5.2.5 transmitter peak differential output |
| | 149.5.2.6 transmitter clock frequency |
| | 149.8.2.1 MDI return loss |

R&S®RTP-K89 Ethernet compliance test (10BASE-T1)

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K89 performs 10BASE-T1 compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports the R&S[®]RT-ZF7A and R&S[®]RT-ZF8 test fixtures; R&S[®]ScopeSuite supports Windows 7, 8 and 10. The chapters in front of the test cases refer to IEEE P802.3cg.

| Supported 10BASE-T1 compliance tests | |
|--------------------------------------|--|
| 10BASE-T1S | 147.5.4.1 transmitter output voltage |
| | 147.5.4.3 transmitter timing jitter |
| | 147.5.4.2 transmitter output droop |
| | 147.5.4.4 transmitter power spectral density (PSD) |
| | 147.7.2 MDI return loss |
| | 147.7.3 MDI mode conversion |
| 10BASE-T1L | 146.5.4.1 transmitter output voltage |
| | 146.5.4.3 transmitter timing jitter |
| | 146.5.4.5 transmitter clock frequency |
| | 146.5.4.4 transmitter power spectral density (PSD) and power level |
| | 146.8.3 MDI return loss |
| | 146.8.4 MDI mode conversion |

R&S[®]RTP-K91 DDR3/DDR3L/LPDDR3 signal integrity debug and compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K91 performs DDR3 (JESD79-3F), DDR3L(JESD79-3-1A.01) and LPDDR3 (JEDS209-3C) compliance test measurements with R&S[®]ScopeSuite. Furthermore, it enables the DDR3 decode capability to separate read and write bursts as well as the eye analysis function for mask testing on the oscilloscope. R&S[®]ScopeSuite supports Windows 7, 8 and 10.

| Supported DDR3 compliance tests Timing tests | clock timing (12.1) | tCK(avg) (12.1.1) |
|--|--------------------------------------|---|
| | CIOCK UITIITIG (12.1) | |
| | | tCK(abs) (12.1.2) tCL(avg) (12.1.3) |
| | | tCH(avg) (12.1.3) |
| | | |
| | | tJIT(per) (12.1.4) tJIT(duty) (12.1.4) |
| | | tJIT(cc) (12.1.5) |
| | | tERR(nper) (12.1.6) |
| | data timing (112.2, 12.4, 12.6) | tDS(base) (13.6) |
| | data timing (4.13.2, 13.4, 13.6) | tDH(base) (13.6) |
| | | tDS(derate) (13.6) |
| | | tDH(derate) (13.6) |
| | | tHZ (4.13.2) |
| | | tLZ (4.13.2) |
| | | tDIPW (13.4 note 28) |
| | | tDQSQ (4.13.2) |
| | | tQH (4.13.2) |
| | strobe timing (4.13, 4.14, 8.3.1) | tDQSCK (4.13.2) |
| | | tLZ (4.13.2) |
| | | tHZ (4.13.2) |
| | | tRPRE (4.13.2) |
| | | tRPST (4.13.2) |
| | | tQSH (4.13.2) |
| | | tQSL (4.13.2) |
| | | tDQSS (4.14.2) |
| | | tDQSH (4.14.2) |
| | | tDQSL (4.14.2) |
| | | tDSS (4.14.2) |
| | | tDSH (4.14.2) |
| | | tWPST (4.14.2) |
| | | tWPRE (4.14.2) |
| | | tDVAC (strobe) (8.3.1) |
| | | tDVAC (clock) (8.3.1) |
| | command timing (13.5) | tIS (13.5) |
| | | tIS (derated) (13.5) |
| | | tlH (13.5) |
| | | tIH (derated) (13.5) |
| | | tIPW (13.5) |
| | | tVAC (CA) (13.5) |
| | address timing (13.5) DDR3 and DDR3L | tlS (13.5) |
| | | tIS (derated) (13.5) |
| | | tlH (13.5) |
| | | tIH (derated) (13.5) |
| | | tIPW (13.5) |
| | | tVAC (CA) (13.5) |
| | address timing (4.2) LPDDR3 | tISCA (4.2) |
| | | tIHCA (4.2) |
| | | tIPWCA (4.2) |
| | | tVAC (CA) (13.5) |
| | chip select timing (13.5) DDR3 and | tlS (13.5) |
| | DDR3L | tIS (derated) (13.5) |
| | | tlH (13.5) |
| | | tIH (derated) (13.5) |
| | | tIPW (13.5) |
| | chip select timing (4.2) LPDDR3 | tISCS (4.2) |
| | , | tIHCS (4.2) |
| | | tIPWCS (4.2) |
| | | tVAC(CS) (11.5) |

| Electrical tests single-ended | input slew rate for ADD and CMD DDR3 | SR(tIS) rising |
|--|---|---|
| measurements | and DDR3L (8.5, 13.5) LPDDR3 (7.6, | SR(tIS) falling |
| | 11.5) | SR(tIH) rising |
| | | SR(tIH) falling |
| | input slew rate for DQ and DM DDR3 and | SR(tIS) rising |
| | DDR3L (8.5, 13.6) LPDDR3 (7.6, 11.6) | SR(tIS) falling |
| | | SR(tIH) rising |
| | | SR(tIH) falling |
| | AC and DC input levels for ADD and CMD | VIH (AC) |
| | DDR3(8.1.1) DDR3L(3.1) LPDDR3(7.1.1) | VIL (AC) |
| | | VIH (DC) |
| | | VIL (DC) |
| | AC input levels for CK and DQS (8.3.3) | VSEH (AC) |
| | AC input levels for Cit and DQS (0.3.3) | VSEL (AC) |
| | output alow rate for DO (0.2) | |
| | output slew rate for DQ (9.3) | SRQse rising |
| | AC and DC autout lavala far DC (0.2) | SRQse falling |
| | AC and DC output levels for DQ (9.2) | VOH(AC) |
| | | VOL(AC) |
| | | VOH(DC) |
| | | VOL(DC) |
| | AC overshoot and undershoot for ADD | overshoot amplitude |
| | and CMD (9.6.1) | overshoot area |
| | | undershoot amplitude |
| | | undershoot area |
| | AC overshoot and undershoot for CK, DQ, | overshoot amplitude |
| | DQS and DM (9.6.2) | overshoot area |
| | | undershoot amplitude |
| | | undershoot area |
| Electrical tests differential measurements | AC input levels for CK and DQS (8.3) | VIHdiff (AC) |
| | | VILdiff (AC) |
| | AC differential cross point voltage for CK (8.4) | VIX (AC) |
| | differential output slew rate for DQS (9.4) | SRQdiff rising |
| | | SRQdiff falling |
| | differential AC output levels for DQS (9.2) | VOHdiff(AC) |
| | | VOLdiff(AC) |
| Debug | trigger write cycle | configures the oscilloscope to trigger on a |
| Debug | lingger white byoic | write cycle |
| | trigger read cycle | configures the oscilloscope to trigger on a |
| | lingger read byoic | read cycle |
| DDR3 decoding | | |
| Protocol configuration | signal type | DQ, DQS |
| i leteel een galaaten | bit rate | adjustable |
| | threshold setup | manual threshold/hysteresis configuration |
| | source | analog channels |
| Decode | display type | decoded bus, tabulated list, details |
| | | read frame, write frame |
| | color coding | |
| | data format | hex, octal, binary, signed, unsigned |
| | de se de levren | a deva a la travada |
| Connek | decode layer | edges, bit, words |
| Search | search event setup | frame content, error |
| Search | | |

| General description | The DDR3 eye diagram allows the user to generate eye diagrams from long multi- period acquisitions of clock signals and serial data signals. It allows the fine control of the signal content that contributes to the eye diagram and enables the advanced analysis, measurement, mask test and navigation functions. | | | |
|-----------------------|--|--|--|--|
| General configuration | number of eye diagram instances | | | |
| | main source | analog channels, differential channels, math channels, reference channels, track channels | | |
| | timing reference source | analog channels, differential channels, math channels, reference channels, track channels | | |
| | horizontal settings | range, position; expressed in absolute time or relative to user-defined bit rate | | |
| Display | persistence | 50 ms to 50 s, or infinite | | |
| | trace colors | predefined or user-defined color tables | | |
| | eye stripe | displays position of eye diagram slices and masks violations time-correlated to the main source waveform; always enabled, for mask tests only, disabled | | |
| Qualification | gate | | | |
| | position | start, stop; absolute time or relative to display in percent | | |
| | coupling | none, cursor #, zoom # | | |
| | signal | | | |
| | source | analog channels, math channels, reference channels | | |
| | condition | greater than, less than, in range, out of range; relative to selected reference leve | | |
| Filter | DDR3 protocol | | | |
| | frame type | any, read frame, write frame | | |
| | error | length | | |
| | bit sequence | | | |
| | mode | all, level transition, constant level, bit pattern | | |
| | bit pattern setup | up to 8 prefix bit and up to 5 suffix bit with respect to central eye diagram bit | | |
| Mask testing | mask test results | | | |
| | counters | acquisitions, slices, sample hits, slice hits fail rate | | |
| | violation details | number and position of mask violation, expressed as time instant and slice index | | |
| | navigation and zoom | use zoom coupling to navigate to violatio upon clicking the corresponding table iter | | |

R&S[®]RTP-K92 eMMC compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K92 performs eMMC (HS200, HS400) compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports Windows 7, 8 and 10.

| Supported eMMC compliance te | ests | |
|------------------------------|------------------------------------|--|
| HS200 (JESD84-B50) | CLK (10.5.2, 10.8.1) | bus signal levels tests (VIH, VIL) |
| | | interface timing tests |
| | | (t _{Period} , rise time, fall time, duty cycle) |
| | CMD push pull (10.5.2, 10.8.1) | bus signal levels tests |
| | | (VIH, VIL, VOH, VOL) |
| | | interface timing tests |
| | | (setup time, hold time) |
| | CMD open drain (10.5.1) | bus signal levels tests (VOH, VOL) |
| | DAT data write (10.5.2, 10.8.1) | bus signal levels tests (VIH, VIL) |
| | | interface timing tests |
| | | (setup time, hold time) |
| | DAT data read (10.5.2, 10.8.1) | bus signal levels tests (VOH, VOL) |
| HS400 (JESD84-B50) | CLK (10.5.2, 10.10.1) | bus signal levels tests (VIH, VIL) |
| | | interface timing tests |
| | | (t _{Period} , slew rate, duty cycle distortion, |
| | | minimum pulse width) |
| | CMD push pull (10.5.2, 10.10.1) | bus signal levels tests |
| | | (VIH, VIL, VOH, VOL) |
| | | interface timing tests |
| | | (setup time, hold time) |
| | CMD open drain (10.5.1) | bus signal levels tests (VOH, VOL) |
| | DAT data write (10.5.2, 10.10.1) | bus signal levels tests (VIH, VIL) |
| | | interface timing tests |
| | | (setup time, hold time, slew rate) |
| | DAT data read (10.5.2, 10.10.2) | bus signal levels tests (VOH, VOL) |
| | | interface timing tests (output skew, output |
| | | hold skew, slew rate) |
| | data strobe for data read (10.5.2, | bus signal levels tests (VOH, VOL) |
| | 10.10.1) | interface timing tests |
| | | (t _{Period} , slew rate, duty cycle distortion, |
| | | minimum pulse width) |

R&S®RTP-K93 DDR4/LPDDR4 signal integrity debug and compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K93 performs DDR4 (JESD79-4B), LPDDR4 (JESD209-4B) and LPDDR4X(JESD209-4-1) compliance test measurements with R&S[®]ScopeSuite. Furthermore, it enables the DDR4 decode capability to separate read and write bursts as well as the eye analysis function for mask testing on the oscilloscope. R&S[®]ScopeSuite supports Windows 7, 8 and 10.

| Supported DDR4 compliance tests Timing tests | clock timing (13.3) | tCK(abs) (13.3.1) |
|--|---------------------------------------|-----------------------|
| 3 | 3(1-4) | tCK(avg) (13.3.2) |
| | | tCL(avg) (13.3.3) |
| | | tCH(avg) (13.3.3) |
| | | tJIT(per) (13.3.4) |
| | | tJIT(duty) (13.3.4) |
| | | tJIT(cc) (13.3.4) |
| | | tERR(nper) (13.3.4) |
| | data timing (4.24.1.2, 4.24.1.3) | tDQSQ (4.24.1.2) |
| | aaa | tQH (4.24.1.2) |
| | | tLZ(DQ) (4.24.1.3) |
| | | tHZ(DQ) (4.24.1.3) |
| | strobe timing (8.3.1, 4.24.1, 4.25.1) | tDVAC(Strobe) (8.3.1) |
| | | tDVAC(Clock) (8.3.1) |
| | | tLZ(DQS) (4.24.1) |
| | | tHZ(DQS (4.24.1) |
| | | tDQSCK (4.24.1) |
| | | tRPRE (4.24.1) |
| | | tRPST (4.24.1) |
| | | tQSH (4.24.1) |
| | | tQSL (4.24.1) |
| | | tDQSS (4.25.1) |
| | | tDQSH (4.25.1) |
| | | tDQSL (4.25.1) |
| | | tDSS (4.25.1) |
| | | tDSH (4.25.1) |
| | | tWPRE (4.25.1) |
| | command timing (13.7) | tIS(base) (13.7) |
| | | tIH(base) (13.7) |
| | | tIPW (13.7) |
| | address timing (13.7) | tlS(base) (13.7) |
| | | tlH(base) (13.7) |
| | | tIPW (13.7) |
| | chip select timing (13.7) | tlS(base) (13.7) |
| | | tlH(base) (13.7) |
| | | tIPW (13.7) |

| Electrical tests single-ended | AC and DC input levels for ADD and | VIH(AC) |
|--|---|--|
| measurements | CMD (8.1) | VIL(AC) |
| | - (-) | VIH(DC) |
| | | VIL(DC) |
| | AC input levels for CK (8.3.3) | VSEH(AC) |
| | | VSEL(AC) |
| | AC overshoot and undershoot for ADD, | VAOSP |
| | CMD (8.3.4) | VAOS |
| | CIVID (0.3.4) | VAUS |
| | | |
| | | AAOS2 |
| | | AAOS1 |
| | | AAUS |
| | AC overshoot and undershoot for | VCOSP |
| | CK (8.3.5) | VCOS |
| | | VCUS |
| | | ACOS2 |
| | | ACOS1 |
| | | ACUS |
| | AC overshoot and undershoot for DQ, | VDOSP |
| | DQS and DM (8.3.6) | VDOS |
| | | VDUS |
| | | VDUSP |
| | | ADOS2 |
| | | ADOS2 ADOS1 |
| | | |
| | | ADUS1 |
| | | ADUS2 |
| | input slew rate for ADD and CMD (8.4.2) | SR(tIS) rising |
| | | SR(tIS) falling |
| | | SR(tIH) rising |
| | | SR(tIH) falling |
| | AC & DC output levels for DQ (9.2) | VOH(AC) |
| | | VOL(AC) |
| | | VOH(DC) |
| | | VOL(DC) |
| | output slew rate for DQ (9.4) | SRQse rising |
| | | SRQse falling |
| Electrical tests differential measurements | AC and DC input levels for CK (8.3.2) | VIHdiff(AC) |
| | | VILdiff(AC) |
| | | |
| | | VIHdiff(DC) |
| | | VILdiff(DC) |
| | input slew rate for CK (8.4.1) | SRdiff rising |
| | | SRdiff falling |
| | differential cross point voltage for CK (8.5) | VIX(CK) |
| | AC input levels for DQS (8.7.2) | VIHDiffPeak |
| | | VILDiffPeak |
| | input slew rate for DQS (8.7.5) | SRdiff rising |
| | | SRdiff falling |
| | differential AC output levels for DQS (9.3) | VOHdiff(AC) |
| | | VOLdiff(AC) |
| | differential output slew rate for DQS (9.5) | SRQdiff rising |
| | , | SQQdiff falling |
| DDR4 decoding | 1 | |
| Protocol configuration | signal type | DQ, DQS |
| | bit rate | adjustable |
| | threshold setup | manual threshold/hysteresis configuration |
| | · · · · · · · · · · · · · · · · · · · | |
| Daaada | Source | analog channels |
| Decode | display type | decoded bus, tabulated list, details |
| | color coding | read frame, write frame |
| | data format | hex, octal, binary, signed, unsigned |
| | decode layer | edges, bit, words |
| Search | search event setup | frame content, error |
| | frame content | data; conditions =, \neq , <, ≤, >, ≥, in range, |
| | | |
| | | out of range |

| DDR4 eye diagram | | | |
|-----------------------|--|--|--|
| General description | The DDR4 eye diagram allows the user to generate eye diagrams from long multi- period acquisitions of clock signals and serial data signals. It allows the fine control of the signal content that contributes to the eye diagram and enables the advanced analysis, measurement, mask test and navigation functions. | | |
| General configuration | number of eye diagram instances | up to 4; independently configurable | |
| | main source | analog channels, differential channels, math channels, reference channels, track channels | |
| | timing reference source | analog channels, differential channels, math channels, reference channels, track channels | |
| | horizontal settings | range, position; expressed in absolute time or relative to user-defined bit rate | |
| Display | persistence | 50 ms to 50 s, or infinite | |
| | trace colors | predefined or user-defined color tables | |
| | eye stripe | displays position of eye diagram slices and masks violations time-correlated to the main source waveform; always enabled, for mask tests only, disabled | |
| Qualification | gate | · · · | |
| | position | start, stop; absolute time or relative to display in percent | |
| | coupling | none, cursor #, zoom # | |
| | signal | | |
| | source | analog channels, math channels, reference channels | |
| | condition | greater than, less than; relative to selected reference level | |
| Filter | DDR4 protocol | | |
| | frame type | any, read frame, non-consecutive read frame, write frame, non-consecutive write frame | |
| | error | length | |
| | bit sequence | bit sequence | |
| | mode | all, level transition, constant level, bit pattern | |
| | bit pattern setup | up to 8 prefix bit and up to 5 suffix bit with respect to central eye diagram bit | |
| Mask testing | mask test results | | |
| | counters | acquisitions, slices, sample hits, slice hits, fail rate | |
| | violation details | number and position of mask violation, expressed as time instant and slice index | |
| | navigation and zoom | use zoom coupling to navigate to violation upon clicking the corresponding table item | |

R&S®RTP-K99 R&S®ScopeSuite automation

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. It requires matching compliance test options (see below). R&S[®]RTP-K99 makes it possible to automate the supported compliance options remotely. After remote execution of a test case the user can collect the results to process them in a proprietary software to create own reports.

| Remote API to execute test cases of R&S [®] ScopeSuite | | |
|---|--------------------------|------------------------|
| API language | | C# |
| Supported options | R&S [®] RTP-K22 | 100BASE-TX, 1000BASE-T |
| | R&S [®] RTP-K24 | 100BASE-T1 |
| | R&S [®] RTP-K87 | 1000BASE-T1 |
| | R&S [®] RTP-K91 | DDR3, DDR3L, LPDDR3 |
| | R&S [®] RTP-K93 | DDR4, LPDDR4, LPDDR4X |

R&S®RTP-K101 USB 3.2 transmitter compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K101 performs USB 2.0/3.2 compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports Windows 7, 8 and 10.

| Supported USB 3.2 compliance | e tests | |
|------------------------------|--------------------------|---|
| USB 2.0 device test | high speed | signal quality (EL_2, 4, 5, 6, 7); packet parameters (EL_21, 22, 25); chirp timing (EL_28, 29, 31); suspend/resume/reset timing (EL_27, 28, 38, 39, 40); test J/K, SE0_NAK (EL_8, 9); receiver sensitivity (EL_16, 17, 18) |
| | full speed and low speed | full speed signal quality; back voltage; inrush current |
| USB 2.0 host test | high speed | signal quality (EL_2, 3, 6, 7); packet parameters (EL_21, 22, 23, 25, 55); chirp timing (EL_33, 34, 35); suspend/resume/reset timing (EL_39, 41); test J/K, SE0_NAK (EL_8, 9) |
| | full speed and low speed | low speed signal quality downstream; full speed signal quality downstream; drop; droop |
| USB 2.0 hub test | high speed | signal quality upstream (EL_2, 4, 6, 7); signal quality downstream (EL_2, 3, 6, 7); jitter downstream (EL_47); packet parameters upstream (EL_21, 22, 25); hub receiver sensitivity upstream (EL_16, 17, 18); repeater downstream (EL_42, 43, 44, 45, 48); repeater upstream (EL_42, 43, 44, 45); chirp timing upstream (EL_28, 29, 31); suspend/resume/reset timing upstream (EL_27, 28, 38, 39, 40); test J/K, SE0_NAK upstream (EL_8, 9); test J/K, SE0_NAK downstream (EL_8, 9) |
| | full speed and low speed | low speed signal quality downstream; full speed signal quality upstream; full speed signal quality downstream; inrush current upstream; drop downstream; droop downstream; back voltage |
| USB 3.2 device test | SuperSpeed (Gen 1) | TD 1.1: low frequency periodic signaling TX; TD 1.3: long channel transmitted eye; TD 1.3: short channel transmitted eye; TD 1.6: SSC profile |
| | SuperSpeedPlus (Gen 2) | TD 1.4: long channel transmitted eye; TD 1.4: short channel transmitted eye; TD 1.5: transmit equalization; TD 1.7: SSC profile |
| USB 3.2 host test | SuperSpeed (Gen 1) | TD 1.1: low frequency periodic signaling TX; TD 1.3: long channel transmitted eye; TD 1.3: short channel transmitted eye; TD 1.6: SSC profile |
| | SuperSpeedPlus (Gen 2) | TD 1.4: long channel transmitted eye; TD 1.4: short channel transmitted eye; TD 1.5: transmit equalization; TD 1.7: SSC profile |

| SuperSpeed (Gen 1) | TD 1.1: upstream low frequency periodic signaling TX; |
|------------------------|--|
| | TD 1.3: upstream long channel |
| | transmitted eye; |
| | TD 1.3: upstream short channel |
| | transmitted eye; |
| | TD 1.6: upstream SSC profile; |
| | TD 1.1: downstream low frequency |
| | periodic signaling TX; |
| | TD 1.3: downstream long channel |
| | transmitted eye; |
| | TD 1.3: downstream short channel |
| | transmitted eye; |
| | TD 1.6: downstream SSC profile |
| SuperSpeedPlus (Gen 2) | TD 1.4: upstream long channel |
| | transmitted eye; |
| | TD 1.4: upstream short channel |
| | transmitted eye; |
| | TD 1.5: upstream transmit equalization; |
| | TD 1.7: upstream SSC profile; |
| | TD 1.4: downstream long channel |
| | transmitted eye; TD 1.4: downstream short channel |
| | |
| | transmitted eye; TD 1.5: downstream transmit |
| | equalization; |
| | TD 1.7: downstream SSC profile |
| | |

R&S®RTP-K102 USB 3.2 receiver compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K102 performs USB 3.2 receiver compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports Windows 7, 8 and 10. The option requires an Anritsu MP1900A signal quality analyzer (BERT) with min. 21 Gbps and equipped with the following options: synthesizer (MU181000B), SI PPG (MU195020A), SI ED (MU195040A), jitter modulation source (MU181500B), noise generator (MU195050A) and MX183000A software with USB link training.

| Supported USB 3.2 receiver | compliance tests | |
|----------------------------|---|---|
| Calibration | USB 3.2 Gen 1: 5 GT/s (Std-A, Std-B, µB) | TD.1.8.1 calibrate swing and deemphasis; TD.1.8.2 Rj Sj and eye height calibration |
| | USB 3.2 Gen 1: 5 GT/s (Type-C) | TD.1.9.1 calibrate swing and deemphasis; TD.1.9.2 calibrate Rj and Sj |
| | USB 3.2 Gen 2: 10 GT/s (Std-A, μB, Type-C) | TD.1.10.1 calibrate swing and deemphasis; |
| | | TD.1.10.2 calibrate Rj; TD.1.10.3 calibrate Sj; |
| | | TD.1.10.4-8 load board analysis; TD.1.10.9-11 eye height calibration |
| Device/Hub/Host | USB 3.2 Gen 1 jitter tolerance in loopback mode | TD.1.8/1.9.3-19 measured with sinusoidal jitter at: 33/20/10/4.9/2/1 MHz, 500 kHz |
| | USB 3.2 Gen 2 jitter tolerance in loopback mode | TD.1.10.14-29 measured with sinusoidal jitter at: 50/30/15/7.5/4/2/1 MHz, 500 kHz |

R&S[®]RTP-K110 HDMI[™] 1.4/2.1 TMDS compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K110 performs HDMI[™] 1.4b/2.1 TMDS transmitter compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports Windows 7, 8 and 10.

| Supported HDMI [™] compliance t | | |
|--|---|--|
| HDMI™ 1.4b clock | all clock tests | V ₁ +, V ₁ (7-2) |
| | | rise/fall time (7-4) |
| | | intra pair skew (7-7) |
| | | duty cycle min./max. (7-8) |
| | | jitter (7-9) |
| | voltage off tests | V _{off} +, V _{off} - (7-3) |
| HDMI™ 1.4b data | single-ended tests | V ₁ +, V ₁ - (7-2) |
| | | intra pair skew (7-7) |
| | voltage off tests | V _{off} +, V _{off} - (7-3) |
| | differential timing tests | rise/fall time (7-4) |
| | jitter mask tests | differential voltage mask (7-10) |
| | | jitter (7-10) |
| | inter-pair skew | inter pair skew (7-6) |
| HDMI™ 2.1 TMDS clock | all clock tests | V ₁ +, V ₁ – (HF 1-1) |
| | | V_{swing} +, V_{swing} – (HF 1-1) |
| | | rise/fall time (HF 1-2) |
| | | intra pair skew (HF 1-4) |
| | | duty cycle min./max. (HF 1-6) |
| | | rate (HF 1-6) |
| | | V _{swing} TP1 (HF 1-7) |
| | | jitter worst case pos./neg. skew (HF 1-7) |
| HDMI™ 2.1 TMDS data | single-ended tests | V _I +, V _I – (HF 1-1) |
| | | V_{swing} +, V_{swing} – (HF 1-1) |
| | | intra pair skew (HF 1-4) |
| | differential timing tests | rise/fall time (HF 1-2) |
| | differential voltage mask tests | max./min. differential voltage (HF 1-5) |
| | jitter mask tests | mask test worst case pos./neg. skew (HF 1-8) |
| | inter-pair skew | inter-pair skew (HF 1-3) |
| Requirements | | |
| Options | R&S [®] RTP-K136 (max. 8 Gbps) or | advanced eye analysis |
| | R&S [®] RTP-K137 (max. 16 Gbps) | |
| | R&S [®] RTP-K140 (max. 8 Gbps) or | high speed serial pattern trigger |
| | R&S [®] RTP-K141 (max. 16 Gbps) or | |
| | R&S [®] RTP-SIBDL1 | signal integrity bundle (contains the |
| | | R&S [®] RTP-K141 16 Gbps high speed |
| | | serial pattern option) |

R&S®RTP-K114 DisplayPort (DP) 1.4a compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K114 performs DisplayPort v1.4a compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports Windows 7, 8 and 10. The numbers in front of the test refer to the DisplayPort v1.4a CTS.

| Supported DisplayPort v1.4a | compliance tests | |
|-----------------------------|------------------|--|
| DisplayPort v1.4a | main-link tests | 3.1 eye diagram tests |
| | | 3.2 HBR/RBR non-PE level verification |
| | | test |
| | | 3.3 HBR/RBR level verification and peak |
| | | to peak differential voltage test |
| | | 3.4 HBR3/HBR2 level verification test |
| | | 3.5 HBR3/HBR2 peak to peak differentia voltage test |
| | | 3.6 inter-pair skew test |
| | | 3.7 intra-pair skew test |
| | | 3.8 AC common mode noise test |
| | | 3.9 non-ISI jitter measurement tests |
| | | 3.10 HBR3 TX differential RL test |
| | | 3.11 TJ/RJ/DJ measurement test |
| | | 3.12 main-link frequency compliance tes |
| | | 3.13 spread-spectrum modulation |
| | | frequency test |
| | | 3.14 spread-spectrum modulation |
| | | deviation test |
| | | 3.15 dF/dT spread-spectrum deviation |
| | | high-frequency variation test |
| | AUX CH tests | 9.1 AUX_CH (Manchester-II) eye test |
| | | 9.2 AUX_CH (Manchester-II) sensitivity |
| | | test |
| | | 9.3 AUX_CH_N termination DC test |
| | | 9.4 AUX_CH_P termination DC test |
| | | 9.5 AUX_CH slew rate test |
| | DP_PWR tests | 9.6 inrush (Informative) and outrush |
| | | (Informative) test |

R&S®RTP-K115 Embedded DisplayPort (eDP) v1.4b/1.5 compliance test

The option is used in combination with the free-of-charge R&S[®]ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S[®]RTP-K114 performs Embedded DisplayPort v1.4b/1.5 compliance test measurements with R&S[®]ScopeSuite. R&S[®]ScopeSuite supports Windows 7, 8 and 10.

| Embedded DisplayPort v1.4b and v1.5 | main-link tests | eye diagram test |
|-------------------------------------|-----------------|---|
| | | jitter tests – non-ISI jitter |
| | | jitter tests – total jitter |
| | | jitter tests – random jitter |
| | | jitter tests – deterministic jitter |
| | | differential voltage test |
| | | main-link frequency compliance test |
| | | SSC tests – modulation frequency |
| | | SSC tests – modulation deviation |
| | | SSC tests – dF/dT spread-spectrum |
| | | deviation high-frequency variation |
| | | intra-pair tests – AC common mode noise |
| | | intra-pair tests – intra-pair skew |
| | | intra-pair tests - rise and fall time |
| | | mismatch |
| | | inter-pair skew test |
| | AUX CH tests | eye tests – mask test |
| | | eye tests – peak to peak voltage |
| | | eye tests – mask test |
| | | sensitivity test |

R&S®RTP-K121 deembedding base option

| General description | The R&S [®] RTP-K121 deembedding base option allows waveform correction based on S-parameters of the involved measurement blocks. The correction parameters of a cable or a modified probe can also be determined by using proven cable/proven probe. | |
|--------------------------|--|--|
| | | |
| Source | channel 1, channel 2, channel 3, | |
| | channel 4, | |
| Signal types | single-ended signals | |
| | differential signals based on two separate | |
| | cables by using two channels | |
| | full differential signals based on | |
| | differential probes | |
| S-parameter files | s2p-files and s4p-files | |
| Types of blocks | cables, connectors, fixtures and customer | |
| | defined blocks | |
| Maximum number of blocks | 10 | |

Proven cable/proven probe

| General description | Proven probe/cable is a part of the R&S [®] RTP-K121 deembedding base option. This function enables the user to determine the correction parameters of a cable or a modified probe based on the R&S [®] RTP-B7 differential pulse source. | |
|----------------------------------|---|---|
| Mode | | proven cable, proven probe (Rohde & Schwarz probes, user-defined) |
| Configurations | proven cable | single ended |
| | proven probe | single ended, differential |
| Correction method | cable, user-defined probe | transmission (magnitude and phase) |
| | Rohde & Schwarz probe | transmission (magnitude and phase) |
| Maximal group delay of DUT | | 20 ns |
| Maximal length of cables (setup) | | 3 m |
| Source | | step with amplitude of -200 mV |

R&S®RTP-K122 realtime deembedding extension

| General description | The R&S®RTP-K122 realtime deembedding extension option allows waveform | |
|------------------------------------|--|--|
| | correction based on S-parameters in realtime. This option is an extension to the | |
| | R&S®RTP-K121 deembedding base option. For details, see R&S®RTP-K121 option. | |
| Realtime waveform acquisition rate | see acquisition system | |

R&S[®]RTP-K130 TDR/TDT analysis

| General description | The R&S®RTP-K130 TDR/TDT option is a measurement technique used to determine | |
|----------------------------|---|--|
| | the characteristics of electrical lines by observing reflected and/or transmitted | |
| | waveforms. Together, they provide | e a powerful means of analyzing electrical |
| | transmission media. | |
| Mode | | TDR, TDT, TDR/TDT |
| Configuration | | single ended, full differential |
| Signals | | impedance/reflection coefficient |
| Domain | | time/distance |
| Bandwidth | TDR and/or TDT, single ended | |
| | R&S®RTP044B | 4 GHz |
| | R&S [®] RTP064B | 6 GHz |
| | R&S [®] RTP084B | 8 GHz |
| | R&S [®] RTP134B | 13 GHz |
| | R&S [®] RTP164B | 16 GHz |
| | TDR or TDT, differential | |
| | R&S [®] RTP044B | 4 GHz |
| | R&S [®] RTP064B | 6 GHz |
| | R&S [®] RTP084B | 8 GHz |
| | R&S [®] RTP134B | 13 GHz |
| | R&S [®] RTP164B | 16 GHz |
| | TDR and TDT, differential | |
| | R&S®RTP044B | 4 GHz |
| | R&S [®] RTP064B | 6 GHz |
| | R&S [®] RTP084B | 8 GHz |
| | R&S [®] RTP134B | 8 GHz |
| | R&S [®] RTP164B | 8 GHz |
| Step amplitude | | 200 mV |
| Repetition rate | | 50 Hz to 500 kHz |
| · | | (depends on horizontal scale) |
| Length of cable | max. | 15 ns (~ 3.2 m at ε_r = 2) |
| - | min. | 2 ns (~ 0.4 m at ε_r = 2) |
| Electrical length of short | range, adjustable by user | 0 ns to 2 ns |
| Reference impedance | single ended | 50 Ω |
| | differential | 100 Ω |

R&S®RTP-K133 advanced jitter analysis

| General description | The R&S [®] RTP-K133 option provides advanced jitter measurements and enables jitter separation. R&S [®] RTP-K133 option includes R&S [®] RTP-K12 option. | | |
|---------------------------------------|--|---|--|
| Jitter separation | total jitter (TJ), | | |
| | deterministic jitter (DJ), | | |
| | data dependent jitter (DDJ), | | |
| | periodic jitter (PJ), | | |
| | data dependent jitter plus periodic jitter (| | |
| | | | |
| | random jitter (RJ), (othor) bounded upcorrelated jitter ((O)BLU) | | |
| | (other) bounded uncorrelated jitter ((O)BUJ), random jitter plus (other) bounded uncorrelated jitter (RJ+(O)BUJ) | | |
| ccepted input signals | clock signals or data signals (NRZ) | | |
| Reference clock | | nd order, constant clock or feed forward) | |
| | or explicit clock signal | nu order, constant clock of feed forward) | |
| Pagia magguramanta | · · · · · · · · · · · · · · · · · · · | ot | |
| | symbol rate, symbol duration, event cou | | |
| itter measurements | total jitter at bit error rate (TJ@BER) | value in seconds or unit interval | |
| | | BER value selectable between 10 ⁻³² and 10 ⁻¹ | |
| | deterministic litter (D L dueL direc) | | |
| | deterministic jitter (DJ, dual-dirac) | value in seconds or unit interval | |
| | duty cycle distortion (DCD) | value in seconds or unit interval | |
| | inter symbol interference (ISI) | value in seconds or unit interval | |
| | total jitter (TJ) corresponds to | peak-to-peak value and RMS value in | |
| | time interval error (TIE) | seconds or unit interval | |
| | deterministic jitter (DJ) | peak-to-peak value and RMS value in | |
| | | seconds or unit interval | |
| | data dependent jitter (DDJ) | peak-to-peak value and RMS value in | |
| | | seconds or unit interval | |
| | periodic jitter (PJ) | peak-to-peak value and RMS value in | |
| | | seconds or unit interval | |
| | data dependent jitter plus periodic jitter | peak-to-peak value and RMS value in | |
| | (DDJ+PJ) | seconds or unit interval | |
| | periodic jitter components | amplitude, frequency, | |
| | | direction (vertical or horizontal) | |
| | random jitter (RJ) | RMS value in seconds or unit interval | |
| | (other) bounded uncorrelated jitter | peak-to-peak value and RMS value in | |
| | ((O)BUJ) | seconds or unit interval | |
| | (other) bounded uncorrelated jitter ((O)BUJ, dual-dirac) | value in seconds or unit interval | |
| | random jitter plus (other) bounded uncorrelated jitter (RJ+(O)BUJ) | peak-to-peak value and RMS value in seconds or unit interval | |
| Statistics | | max. and min. values for each jitter measurement type | |
| itter result plots | histogram (rising edges only) | TJ, DJ, DDJ, PJ, RJ+OBUJ | |
| - | histogram (falling edges only) | TJ, DJ, DDJ, PJ, RJ+OBUJ | |
| | histogram (both edges) | TJ, DJ, DDJ, PJ, RJ+OBUJ | |
| | TIE track | TJ, DDJ, PJ, RJ+OBUJ | |
| | power spectral density (PSD) | TJ, DDJ, PJ, RJ+OBUJ | |
| dditional result plots | step response | , | |
| · · · · · · · · · · · · · · · · · · · | bathtub | PJ and (O)BUJ removable from noise bathtub | |
| | synthetic eye diagram | DD only, DD+P(h), DD+P(v), DD+P | |

R&S®RTP-K134 advanced jitter and noise analysis

| General description The R&S [®] RTP-K134 option provides advanced jitter and noise mea | | ced jitter and noise measurements and | |
|---|--|---|--|
| | separation. R&S®RTP-K134 option includes R&S®RTP-K133 advanced jitter anal | | |
| | option and R&S [®] RTP-K12 basic jitter analysis option. | | |
| Noise separation | total noise (TN), | | |
| | deterministic noise (DN), | | |
| | data dependent noise (DDN), | | |
| | periodic noise (PN), | | |
| | data dependent noise plus periodic noise (DDN+PN), | | |
| | random noise (RN), | | |
| | (other) bounded uncorrelated noise ((O)BUN), | | |
| | random noise plus other (other) bounded un | | |
| Accepted input signals | clock signals or data signals (NRZ) | | |
| Reference clock | internal clock recovery (PLL first or second | order constant clock or feed forward) | |
| | or explicit clock signal | order, constant clock of recurior wardy | |
| Basic measurements | symbol rate, symbol duration, event count | | |
| Noise measurements | eye height at bit error rate (EN@BER) | absolute or relative, | |
| | eye height at bit enor fate (Erve DErt) | BER value selectable | |
| | | between 10^{-32} and 10^{-1} | |
| | level distortion (LD) | absolute or relative value | |
| | inter symbol interference noise (ISIN) | absolute or relative value | |
| | | | |
| | total noise (TN) | peak-to-peak value and RMS value, | |
| | deterministic naise (DNI) | absolute or relative | |
| | deterministic noise (DN) | peak-to-peak value and RMS value, | |
| | data danandarit naisa (DDN) | absolute or relative | |
| | data dependent noise (DDN) | peak-to-peak value and RMS value, | |
| | pariadia paiao (DNI) | absolute or relative | |
| | periodic noise (PN) | peak-to-peak value and RMS value, absolute or relative | |
| | data danandant naina alwa naviadia naina | | |
| | data dependent noise plus periodic noise (DDN+PN) | peak-to-peak value and RMS value, absolute or relative | |
| | | | |
| | periodic noise components | amplitude, frequency, direction (vertical or horizontal) | |
| | rondom noise (DNI) | | |
| | random noise (RN) | RMS value, absolute or relative | |
| | (other) bounded uncorrelated noise | peak-to-peak value and RMS value, | |
| | ((O)BUN) | absolute or relative | |
| | (other) bounded uncorrelated noise | absolute or relative value | |
| | ((O)BUN, dual-dirac), | neek to neek value and DMS value | |
| | random noise plus (other) bounded | peak-to-peak value and RMS value, | |
| Chartieries | uncorrelated noise (RJ+(O)BUN) | absolute or relative | |
| Statistics | max. and min. values for each noise measurement type | | |
| Noise result plots | histogram (level 0) | TN, DN, DDN, PN, RN+OBUN | |
| | histogram (level 1) | TN, DN, DDN, PN, RN+OBUN | |
| | histogram (both levels) | TN, DN, DDN, PN, RN+OBUN | |
| | TIE track | TN, DDN, PN, RN+OBUN | |
| | power spectral density (PSD) | TN, DDN, PN, RN+OBUN | |
| Additional result plots | step responses | | |
| | noise bathtub | PN and (O)BUN removable from noise | |
| | | bathtub | |
| | synthetic eye diagram | DD only, DD+P(h), DD+P(v), DD+P | |

R&S®RTP-K136 advanced eye analysis (8 Gbps)

| General description | The advanced eye analysis allows the user to generate eye diagrams from long multi- period acquisitions of clock signals, hardware-supported clock data recovery up to a bit rate of 8 Gbps, and serial data signals. It allows the fine control of the signal content that contributes to the eye diagram and enables the advanced analysis, measurement, mask test and navigation functions. | | |
|-----------------------|--|--|--|
| General configuration | number of eye diagram instances | up to 4; independently configurable | |
| | main source | analog channels, differential channels, math channels, reference channels, track channels | |
| | timing reference source | analog channels, differential channels, math channels, reference channels, track channels | |
| | horizontal settings | range, position; expressed in absolute time or relative to user-defined bit rate | |
| Display | persistence | 50 ms to 50 s, or infinite | |
| | trace colors | predefined or user-defined color tables | |
| | eye stripe | displays position of eye diagram slices and masks violations time-correlated to the main source waveform; always | |
| | | enabled, for mask tests only, disabled | |
| Qualification | gate | | |
| | position | start, stop; absolute time or relative to display in percent | |
| | coupling | none, cursor #, zoom # | |
| | signal | | |
| | source | analog channels, math channels, reference channels | |
| | condition | greater than, less than, in range, out of range; relative to selected reference levels | |
| Filter | DDR3/DDR4 protocol (only in combination with option R&S®RTP-K91/-K93) | | |
| | frame type | any, read frame, non-consecutive read frame, write frame, non-consecutive write frame | |
| | error | length | |
| | bit sequence | | |
| | mode | all, level transition, constant level, bit pattern | |
| | bit pattern setup | up to 8 prefix bit and up to 5 suffix bit with respect to central eye diagram bit | |
| Mask testing | mask test results | | |
| | counters | acquisitions, slices, sample hits, slice hits, fail rate | |
| | violation details | number and position of mask violation, expressed as time instant and slice index | |
| | navigation and zoom | use zoom coupling to navigate to violation upon clicking the corresponding table item | |
| CDR trigger | source | analog channels, differential channels | |
| | algorithm | feed forward, constant frequency | |
| | configuration parameters | serial standard, nominal bit | |
| | · · · | rate, bandwidth, relative bandwidth, sampling time | |
| | nominal bit rate | 21 kbps to 8 Gbps; supports bit rate estimation | |
| | bandwidth | 1/100 to 1/5000 of the nominal bit rate | |
| | sampling time | 0.0 to 1.0 UI | |

R&S[®]RTP-K137 advanced eye analysis (16 Gbps)

| General description | The advanced eye analysis allows the user to generate eye diagrams from long multi- period acquisitions of clock signals, hardware-supported clock data recovery up to a bit rate of 16 Gbps and serial data signals. It allows the fine control of the signal content that contributes to the eye diagram and enables the advanced analysis, measurement, mask test and navigation functions. | | |
|-----------------------|--|---|--|
| General configuration | number of eye diagram instances | up to 4; independently configurable | |
| Contra configuration | main source | analog channels, differential channels, math channels, reference channels, track channels | |
| | timing reference source | analog channels, differential channels, math channels, reference channels, track channels | |
| | horizontal settings | range, position; expressed in absolute time or relative to user-defined bit rate | |
| Display | persistence | 50 ms to 50 s, or infinite | |
| | trace colors | predefined or user-defined color tables | |
| | eye stripe | displays position of eye diagram slices | |
| | | and masks violations time-correlated to | |
| | | the main source waveform; always | |
| | | enabled, for mask tests only, disabled | |
| Qualification | gate | | |
| | position | start, stop; absolute time or relative to | |
| | | display in percent | |
| | coupling | none, cursor #, zoom # | |
| | signal | | |
| | source | analog channels, math channels, | |
| | | reference channels | |
| | condition | greater than, less than, in range, out of range; relative to selected reference levels | |
| Filter | DDR3/DDR4 protocol (only in combination | | |
| | frame type | any, read frame, non-consecutive read | |
| | | frame, write frame, non-consecutive write frame | |
| | error | length | |
| | bit sequence | | |
| | mode | all, level transition, constant level, bit pattern | |
| | bit pattern setup | up to 8 prefix bit and up to 5 suffix bit with | |
| | | respect to central eye diagram bit | |
| Mask testing | mask test results | | |
| | counters | acquisitions, slices, sample hits, slice hits, fail rate | |
| | violation details | number and position of mask violation, expressed as time instant and slice index | |
| | navigation and zoom | use zoom coupling to navigate to violation upon clicking the corresponding table item | |
| CDR trigger | source | analog channels, differential channels | |
| | algorithm | feed forward, constant frequency | |
| | configuration parameters | serial standard, nominal bit | |
| | | rate, bandwidth, relative bandwidth, sampling time | |
| | nominal bit rate | 21 kbps to 16 Gbps; supports bit rate estimation | |
| | bandwidth | 1/100 to 1/5000 of the nominal bit rate | |
| | sampling time | 0.0 to 1.0 UI | |

R&S®RTP-K140 high speed serial pattern trigger (8 Gbps)

| General description | The R&S [®] RTP-K140 high speed serial pattern trigger option provides triggering functions for simple or complex combinations of bit patterns or 8b10b words up to a rate of 8 Gbps including clock data recovery. | |
|---------------------|--|--|
| Source | data any analog channel | |
| Source | clock | any analog channel or extracted from data channel by using a clock data recovery |
| Trigger types | single bit pattern | up to 160 bit; wildcards supported |
| | dual bit pattern | two bit patterns with 160 bit each connected with logical OR; wildcards supported |
| | complex word pattern | frame alignment by bit pattern of up to 32 bit or timeout; up to 4 bit patterns (up to 160 bit in total) connected with logical AND or OR; conditions: =, \neq , <, >, \geq , \leq , in range, out of range; bit offset, length and search range definable for each pattern |
| | 8b10b | aligns on selectable comma symbol; trigger condition of up to 16 K/D symbols including wildcards; disparity error, symbol error |
| | PRBS error | locks to PRBS sequences of type 7, 9, 11, 15, 16, 17, 20, 23, 29, 31 and triggers on error |
| Clock data recovery | bit rate | 21 kbps to 8 Gbps; supports bit rate estimation |
| | unit interval position | 0 to 1 |

R&S®RTP-K141 high speed serial pattern trigger (16 Gbps)

| General description | The R&S [®] RTP-K141 high speed serial pattern trigger option provides triggering | | |
|---------------------|--|--|--|
| | functions for simple or complex combinations of bit patterns or 8b10b words up to a bit rate of 16 Gbps including clock data recovery. | | |
| Source | data | any analog channel | |
| | clock | any analog channel or extracted from data channel by using a clock data recovery | |
| Trigger types | single bit pattern | up to 160 bit; wildcards supported | |
| | dual bit pattern | two bit patterns with 160 bit each connected with logical OR; wildcards supported | |
| | complex word pattern | frame alignment by bit pattern of up to 32 bit or timeout; up to 4 bit patterns (up to 160 bit in total) connected with logical AND or OR; conditions: =, \neq , <, >, \geq , \leq , in range, out of range; bit offset, length and search range definable for each pattern | |
| | 8b10b | aligns on selectable comma symbol; trigger condition of up to 16 K/D symbols including wildcards; disparity error, symbol error | |
| | PRBS error | locks to PRBS sequences of type 7, 9, 11, 15, 16, 17, 20, 23, 29, 31 and triggers on error | |
| | 128b132b | aligns on selectable word; triggers on selectable word | |
| Clock data recovery | bit rate | 21 kbps to 16 Gbps; supports bit rate estimation | |
| | unit interval position | 0 to 1 | |

R&S®RTP-K553 external frontend control

| General description | The R&S®RTP-K553 external frontend control option enables the use of | | |
|------------------------------|--|---|--|
| | Rohde & Schwarz external frontends in combination with the R&S®RTP oscilloscope | | |
| | (\geq 8 GHz respectively \geq 13 GHz bandwidth). | | |
| Supported frontends | R&S®RTP084B, R&S®RTP134B or | R&S [®] FE44S | |
| | R&S [®] RTP164B | R&S [®] FE50DTR | |
| | R&S [®] RTP134B or R&S [®] RTP164B | R&S[®]FE110SR | |
| | | R&S[®]FE170SR | |
| Number of channels/frontends | R&S [®] FE44S, with bandwidth \leq 1 GHz | 4 | |
| | R&S [®] FE50DTR, with bandwidth ≤ 1 GHz | 4 | |
| | R&S [®] FE110SR, with bandwidth ≤ 10 GHz | 2 | |
| | R&S [®] FE170SR, with bandwidth ≤ 10 GHz | 2 | |
| Reference frequency | 10 MHz | Ref Out | |
| Recommended software options | At least one of these options is required to get a corrected frequency response. | | |
| | I/Q samples | R&S [®] RTP-K11 I/Q software interface | |
| | real samples | R&S [®] RTP-K121, deembedding option | |

Ordering information

| | Туре | Order No. |
|--|--|------------------------------|
| Base unit (including standard accessories: R&S [®] RT-ZA16 precision BNC to SM. | A adapter (2 pieces), qui | ck start guide, power cord |
| High-performance oscilloscope | R&S [®] RTP044B | 1803.7000.04 |
| 4 GHz, 100 Mpoints memory | R&S®RTP044B R&S®RTP064B | 1803.7000.04 |
| 6 GHz, 100 Mpoints memory | R&S®RTP064B | 1803.7000.08 |
| 8 GHz, 100 Mpoints memory | R&S [®] RTP134B | |
| 13 GHz, 100 Mpoints memory | | 1803.7000.13 |
| 16 GHz, 100 Mpoints memory | R&S [®] RTP164B | 1803.7000.16 |
| Hardware options (plug-in) | R&S [®] RTP-B1 | 4000 0404 00 |
| Mixed signal option, 400 MHz, 5 Gsample/s, 16 channels | R&S®RTP-B1 R&S®RTP-B1E | 1333.2424.02 |
| Digital extension port for R&S [®] RT-ZVC usage with R&S [®] RTP oscilloscope, included in R&S [®] RTP-B1 | R&S"RIP-BIE | 1337.9581.02 |
| Arbitrary waveform generator, 100 MHz, 2 analog channels, 8-bit pattern | R&S [®] RTP-B6 | 1333.2418.02 |
| | RAS RIF-DU | 1555.2416.02 |
| generator 16 GHz differential pulse source | R&S [®] RTP-B7 | 1333.2001.02 |
| Adapter rear option slot | R&S [®] RTP-B21 | 1338.0507.02 |
| Additional solid state disk | R&S®RTP-B21 | 1803.6855.02 |
| | R&S®RTP-B19B | |
| Memory upgrade, 200 Mpoints per channel | | 1337.9517.02 |
| Nemory upgrade, 500 Mpoints per channel | R&S®RTP-B105 | 1337.9523.02 |
| Memory upgrade, 1 Gpoints per channel | R&S®RTP-B110 | 1337.9530.02 |
| Nemory upgrade, 2 Gpoints per channel Nemory upgrade, 3 Gpoints per channel | R&S [®] RTP-B120 R&S [®] RTP-B130 | 1803.6455.02 1803.6610.02 |
| Bandwidth upgrades ¹⁴ | R&S°RTP-B130 | 1803.6610.02 |
| | | 4002 0204 02 |
| Upgrade of the R&S®RTP044B to 6 GHz bandwidth | R&S®RTP-B0406 | 1803.6261.02 |
| Upgrade of the R&S®RTP044B to 8 GHz bandwidth | R&S®RTP-B0408 | 1803.6278.02 |
| Upgrade of the R&S®RTP044B to 13 GHz bandwidth | R&S®RTP-B0413 | 1803.6284.02 |
| Upgrade of the R&S®RTP044B to 16 GHz bandwidth | R&S®RTP-B0416 | 1803.6290.02 |
| Upgrade of the R&S®RTP064B to 8 GHz bandwidth | R&S®RTP-B0608 | 1803.6303.02 |
| Upgrade of the R&S®RTP064B to 13 GHz bandwidth | R&S®RTP-B0613 | 1803.6310.02 |
| Upgrade of the R&S®RTP064B to 16 GHz bandwidth | R&S®RTP-B0616 | 1803.6326.02 |
| Upgrade of the R&S [®] RTP084B to 13 GHz bandwidth | R&S [®] RTP-B0813 | 1803.6332.02 |
| Upgrade of the R&S®RTP084B to 16 GHz bandwidth | R&S [®] RTP-B0816 | 1803.6349.02 |
| Upgrade of the R&S [®] RTP134B to 16 GHz bandwidth | R&S [®] RTP-B1316 | 1803.6355.02 |
| Software options | | |
| Serial triggering and decoding | | |
| I ² C/SPI serial triggering and decoding | R&S [®] RTP-K1 | 1337.8604.02 |
| UART/RS-232/RS-422/RS-485 serial triggering and decoding | R&S [®] RTP-K2 | 1337.8610.02 |
| CAN/LIN serial triggering and decoding | R&S [®] RTP-K3 | 1337.8627.02 |
| MIL-STD-1553 serial triggering and decoding | R&S [®] RTP-K6 | 1800.6654.02 |
| ARINC 429 serial triggering and decoding | R&S [®] RTP-K7 | 1800.6660.02 |
| Ethernet (10BASE-T/100BASE-TX) serial triggering and decoding | R&S [®] RTP-K8 | 1337.8633.02 |
| CAN-FD serial triggering and decoding | R&S [®] RTP-K9 | 1337.8640.02 |
| MIPI RFFE serial triggering and decoding | R&S [®] RTP-K40 | 1337.8733.02 |
| MIPI D-PHY serial triggering and decoding | R&S [®] RTP-K42 | 1337.8740.02 |
| MIPI M-PHY serial triggering and decoding | R&S [®] RTP-K44 | 1337.8756.02 |
| Manchester and NRZ serial triggering and decoding | R&S [®] RTP-K50 | 1337.8762.02 |
| 8b10b serial triggering and decoding | R&S [®] RTP-K52 | 1337.8779.02 |
| MDIO serial triggering and decoding | R&S [®] RTP-K55 | 1337.8785.02 |
| Ethernet (100BASE-T1) serial triggering and decoding | R&S [®] RTP-K57 | 1800.6548.02 |
| Ethernet (1000BASE-T1) serial triggering and decoding | R&S [®] RTP-K58 | 1800.6702.02 |
| USB 1.0/1.1/2.0 serial triggering and decoding | R&S [®] RTP-K60 | 1337.8791.02 |
| USB 3.1 Gen 1 serial triggering and decoding | R&S [®] RTP-K61 | 1337.8804.02 |
| USB 3.1 Gen 2 serial triggering and decoding | R&S [®] RTP-K62 | 1337.9100.02 |
| USB power delivery serial triggering and decoding | R&S®RTP-K63 | 1337.8810.02 |
| USB 3.1 SSIC serial triggering and decoding | R&S®RTP-K64 | 1337.9117.02 |
| SpaceWire serial triggering and decoding | R&S®RTP-K65 | 1800.6677.02 |
| PCI Express 1.1/2.0 serial triggering and decoding | R&S®RTP-K72 | 1337.8827.02 |
| PCI Express 3.0 serial triggering and decoding | R&S®RTP-K73 | 1800.6960.02 |
| Low speed serial buses, triggering and decoding (R&S [®] RTP-K1/-K2/-K50) | R&S®RTP-K510 | 1803.6632.02 |
| | R&S [®] RTP-K520 | 1803.6649.02 |
| Automotive protocols triggering and decoding $(P \& C^{\otimes} P T D_{-} K 2)/(K Q)$ | | |
| Automotive protocols, triggering and decoding (R&S [®] RTP-K3/-K9) Aerospace protocols, triggering and decoding (R&S [®] RTP-K6/-K7/-K65) | R&S®RTP-K530 | 1803.6655.02 |

¹⁴ The bandwidth upgrade is performed at a Rohde & Schwarz service center, where the oscilloscope will also be calibrated.

| Designation | Туре | Order No. |
|---|-----------------------------|--------------|
| MIPI low speed, triggering and decoding (R&S®RTP-K40) | R&S [®] RTP-K550 | 1803.6678.02 |
| Automotive Ethernet, triggering and decoding (R&S®RTP-K57/-K58) | R&S [®] RTP-K560 | 1803.6684.02 |
| USB protocols, triggering and decoding | R&S [®] RTP-K570 | 1803.6690.02 |
| (R&S [®] RTP-K60/-K61/-K62/-K63/-K64) | | |
| MIPI high speed, triggering and decoding (R&S [®] RTP-K42/-K44) | R&S [®] RTP-K580 | 1803.6703.02 |
| PCI express, triggering and decoding (R&S [®] RTP-K52/-K72/-K73) | R&S [®] RTP-K590 | 1803.6710.02 |
| Generic decode (R&S [®] RTP-K50/-K52) | R&S [®] RTP-K600 | 1803.6726.02 |
| Low speed trigger and decode bundle | R&S [®] RTP-TDBDL1 | 1803.6732.02 |
| (R&S [®] RTP-K500/-K510/-K520/-K530/-K540/-K550/-K600) | | |
| High speed trigger and decode bundle (R&S®RTP-K560/-K570/-K580/-K590) | R&S [®] RTP-TDBDL2 | 1803.6749.02 |
| Compliance tests | | |
| USB 2.0 compliance test | R&S [®] RTP-K21 | 1337.8685.02 |
| Ethernet compliance test (10/100/1000BASE-T/EEE) | R&S [®] RTP-K22 | 1337.8691.02 |
| Ethernet compliance test (2.5/5/10GBASE-T) | R&S [®] RTP-K23 | 1337.8704.02 |
| Ethernet compliance test (100BASE-T1) | R&S [®] RTP-K24 | 1800.6531.02 |
| MIPI D-PHY compliance test | R&S [®] RTP-K26 | 1337.8727.02 |
| MIPI D-PHY 2.5 compliance test | R&S [®] RTP-K27 | 1800.5993.02 |
| MIPI C-PHY 2.1 compliance test | R&S [®] RTP-K28 | 1802.9621.02 |
| PCI Express 1.1/2.0 compliance test | R&S [®] RTP-K81 | 1337.8885.02 |
| PCI Express 1.1/2.0/3.0 compliance test | R&S [®] RTP-K83 | 1800.6954.02 |
| Ethernet compliance test (1000BASE-T1) | R&S [®] RTP-K87 | 1800.6554.02 |
| Ethernet compliance test (MGBASE-T1) | R&S [®] RTP-K88 | 1800.6725.02 |
| Ethernet compliance test (10BASE-T1) | R&S [®] RTP-K89 | 1800.6719.02 |
| DDR3/DDR3L/LPDDR3 signal integrity debug and compliance test | R&S [®] RTP-K91 | 1337.8840.02 |
| eMMC compliance test | R&S [®] RTP-K92 | 1803.6378.02 |
| DDR4/LPDDR4 signal integrity debug and compliance test | R&S [®] RTP-K93 | 1801.3671.02 |
| R&S [®] ScopeSuite automation | R&S [®] RTP-K99 | 1326.4425.02 |
| USB 3.2 transmitter compliance test | R&S [®] RTP-K101 | 1800.6948.02 |
| USB 3.2 receiver compliance test | R&S [®] RTP-K102 | 1800.6990.02 |
| HDMI [™] 1.4/2.1 TMDS compliance test | R&S [®] RTP-K110 | 1802.9467.02 |
| DisplayPort (DP) 1.4a compliance test | R&S [®] RTP-K114 | 1803.6903.02 |
| Embedded DisplayPort (eDP) 1.4b/1.5 compliance test | R&S [®] RTP-K115 | 1803.6910.02 |
| Analysis | | |
| I/Q software interface | R&S [®] RTP-K11 | 1800.6683.02 |
| Jitter analysis | R&S [®] RTP-K12 | 1337.8656.02 |
| Zone trigger | R&S [®] RTP-K19 | 1337.8879.02 |
| Bus analysis | R&S [®] RTP-K35 | 1800.6648.02 |
| Spectrogram | R&S [®] RTP-K37 | 1338.1110.02 |
| User-defined math | R&S [®] RTP-K39 | 1803.6761.02 |
| Deembedding base option | R&S [®] RTP-K121 | 1326.3064.02 |
| Realtime deembedding extension | R&S [®] RTP-K122 | 1326.3070.02 |
| TDR/TDT analysis | R&S [®] RTP-K130 | 1326.3093.02 |
| Advanced jitter analysis | R&S [®] RTP-K133 | 1800.6860.02 |
| Advanced jitter and noise analysis | R&S [®] RTP-K134 | 1800.6977.02 |
| Advanced eye analysis (8 Gbps) | R&S [®] RTP-K136 | 1803.6561.02 |
| Advanced eye analysis (16 Gbps) | R&S [®] RTP-K137 | 1800.6983.02 |
| High speed serial pattern trigger (8 Gbps) | R&S [®] RTP-K140 | 1326.4554.02 |
| High speed serial pattern trigger (16 Gbps) | R&S [®] RTP-K141 | 1326.4560.02 |
| Bus analysis (R&S®RTP-K35) | R&S®RTP-K500 | 1803.6626.02 |
| External frontend control | R&S®RTP-K553 | 1803.6890.02 |
| Signal Integrity bundle (R&S [®] RTP-K12/-K19/-K121/-K122/-K141) | R&S®RTP-SIBDL1 | 1803.6755.02 |

| Designation | Туре | Order No. |
|--|---------------------------|---------------|
| Probes | | 4 400 7000 00 |
| 8.0 GHz transmission line probe, 10:1, 500 Ω, 0.3 pF, 20 V (RMS) | R&S®RT-ZZ80 | 1409.7608.02 |
| 3.0 GHz active voltage probe, single-ended, 1 MΩ, 0.8 pF | R&S®RT-ZS30 | 1410.4309.02 |
| 6.0 GHz active voltage probe, single-ended, 1 MΩ, 0.3 pF | R&S®RT-ZS60 | 1418.7307.02 |
| 4.0 GHz power rail probe, 1:1, low noise, 50 k Ω , large offset range ±60 V | R&S [®] RT-ZPR40 | 1800.5406.02 |
| 1.0 GHz active voltage probe, differential, 1 M Ω , 0.6 pF, incl. R&S [®] RT-ZA15 | R&S [®] RT-ZD10 | 1410.4715.02 |
| 1.5 GHz active voltage probe, differential, 1 M Ω , 0.6 pF | R&S [®] RT-ZD20 | 1410.4409.02 |
| 3.0 GHz active voltage probe, differential, 1 M Ω , 0.6 pF | R&S [®] RT-ZD30 | 1410.4609.02 |
| 4.5 GHz active voltage probe, differential, 1 MΩ, 0.4 pF | R&S [®] RT-ZD40 | 1410.5205.02 |
| 6.0 GHz modular probe amplifier, differential, 400 k Ω , multimode | R&S [®] RT-ZM60 | 1419.3105.02 |
| 9.0 GHz modular probe amplifier, differential, 400 k Ω , multimode | R&S [®] RT-ZM90 | 1419.3205.02 |
| 13.0 GHz modular probe amplifier, differential, 400 kΩ, multimode | R&S [®] RT-ZM130 | 1800.4500.02 |
| 16.0 GHz modular probe amplifier, differential, 400 kΩ, multimode | R&S [®] RT-ZM160 | 1800.4600.02 |
| Tip cable, solder in, length: 15 cm, multimode compatible | R&S [®] RT-ZMA10 | 1419.4301.02 |
| Tip cable, square pin, for 1.27 mm pin header, length: 15 cm, multimode compatible | R&S [®] RT-ZMA12 | 1419.4324.02 |
| Tip cable, quick connect, for solder in resistor connection, length: 15 cm, multimode | R&S [®] RT-ZMA15 | 1419.4224.02 |
| Browser module, variable span from 0.5 mm to 8 mm, spring-loaded, multimode | R&S [®] RT-ZMA30 | 1419.4353.02 |
| SMA module, 2.92 mm/3.5 mm/SMA, differential, 100 Ω, DC termination, multimode | R&S [®] RT-ZMA40 | 1419.4201.02 |
| Extended temperature kit, 1 m matched cable pair, multimode compatible | R&S [®] RT-ZMA50 | 1419.4218.02 |
| Multi-channel power probe, 2 × 4 voltage/current channels | R&S [®] RT-ZVC04 | 1326.0259.04 |
| Multi-channel power probe, 2 x 2 voltage/current channels | R&S®RT-ZVC02 | 1326.0259.02 |
| Compact probe set for E and H near-field measurements, 30 MHz to 3 GHz | R&S [®] HZ-15 | 1147.2736.02 |
| 3 GHz, 20 dB preamplifier, 100 V to 230 V power adapter, for R&S®HZ-15 | R&S [®] HZ-16 | 1147.2720.02 |
| Probe accessories | | |
| High-impedance buffer amplifier, incl. 500 MHz passive probe | R&S [®] RT-Z1M | 1337.9200.02 |
| Spare accessory set for R&S®RT-ZS10/-ZS10E/-ZS20/-ZS30 | R&S [®] RT-ZA2 | 1416.0405.02 |
| Pin set for R&S®RT-ZS10/-ZS10E/-ZS20/-ZS30 | R&S [®] RT-ZA3 | 1416.0411.02 |
| Mini clips | R&S [®] RT-ZA4 | 1416.0428.02 |
| Micro clips | R&S [®] RT-ZA5 | 1416.0434.02 |
| Lead set | R&S [®] RT-ZA6 | 1416.0440.02 |
| Pin set for R&S [®] RT-ZD20/-ZD30 | R&S®RT-ZA7 | 1417.0609.02 |
| Pin set for R&S®RT-ZD40 | R&S [®] RT-ZA8 | 1417.0867.02 |
| Probe box to N/USB adapter | R&S®RT-ZA9 | 1417.0909.02 |
| External attenuator, 10:1, 2.0 GHz, 70 V DC, 46 V AC (peak) | R&S®RT-ZA15 | 1410.4744.02 |
| Power rail browser kit | R&S®RT-ZA25 | 1800.5329.00 |
| Pigtail cable, solder-in, length: 15 cm, for R&S [®] RT-ZPR20 | R&S®RT-ZA26 | 1800.5258.00 |
| 3D probe positioner | R&S®RT-ZAP | 1326.3641.02 |
| | R&S®RT-ZAP | |
| Extended cable set for R&S [®] RT-ZVC, PCB probing, 1 current and voltage lead, length: 32 cm | | 1333.1686.02 |
| Extended cable set for R&S [®] RT-ZVC, 4 mm probing, 1 current and voltage lead, length: 32 cm | R&S®RT-ZA31 | 1333.1692.02 |
| Oscilloscope interface cable for R&S [®] RT-ZVC (included in R&S [®] RT-ZVC02/-ZVC04, 1326.0259.02/.04) | R&S®RT-ZA33 | 1333.1770.02 |
| Extended cable set for R&S [®] RT-ZVC, 4 mm probing, 1 current and voltage lead, length: 1 m | R&S [®] RT-ZA34 | 1333.1892.02 |
| Extended cable set for R&S [®] RT-ZVC, PCB probing, 1 current and voltage lead, length: 1 m | R&S [®] RT-ZA35 | 1333.1905.02 |
| Solder-in cable set for R&S [®] RT-ZVC, 4 current and voltage solder-in cables, solder-in pins | R&S [®] RT-ZA36 | 1333.1911.02 |
| Extended cable set for R&S [®] RT-ZVC, BNC connector, 1 current and voltage lead, length: 16 cm | R&S [®] RT-ZA37 | 1337.9130.02 |
| Adapter, Rohde & Schwarz probe interface to 2.92 mm/3.5 mm/SMA, incl. USB-C port | R&S [®] RT-ZA50 | 1803.5265.02 |
| Adapter, 2.92 mm/3.5 mm/SMA to Rohde & Schwarz probe interface, incl. USB-C port | R&S [®] RT-ZA51 | 1803.5365.02 |

| Designation | Туре | Order No. |
|---|---------------------------|--------------|
| Accessories | | |
| Precision BNC to SMA adapter | R&S [®] RT-ZA16 | 1320.7074.02 |
| Matched pair cable | R&S [®] RT-ZA17 | 1337.8991.02 |
| Front cover, for R&S [®] RTP oscilloscopes | R&S [®] RTP-Z1 | 1337.9569.02 |
| Front handles, for R&S [®] RTP oscilloscopes | R&S [®] RTP-B20B | 1803.6410.02 |
| Transit case, for R&S [®] RTP oscilloscopes | R&S [®] RTP-Z4 | 1801.4610.02 |
| USB 2.0 compliance test fixture set | R&S [®] RT-ZF1 | 1317.3420.02 |
| Ethernet compliance test fixture set | R&S [®] RT-ZF2 | 1317.5522.02 |
| Ethernet 1000BASE-T1 jitter test cable | R&S [®] RT-ZF2C | 1317.5639.02 |
| Frequency converter (100BASE-T1) | R&S [®] RT-ZF3 | 5025.0670.02 |
| Ethernet 10BASE-Te fixture | R&S [®] RT-ZF4 | 1333.0915.02 |
| Ethernet probe fixture | R&S [®] RT-ZF5 | 1333.0938.02 |
| Frequency converter (1000BASE-T1) | R&S [®] RT-ZF6 | 1337.8579.02 |
| Automotive Ethernet T&D fixture | R&S [®] RT-ZF7 | 1801.3688.02 |
| SMA adapter | R&S [®] RT-ZF7A | 1801.4126.02 |
| SMA adapter, for PoDL | R&S [®] RT-ZF7P | 1802.9680.02 |
| Automotive Ethernet compliance fixture | R&S [®] RT-ZF8 | 1801.3694.02 |
| Probe deskew and calibration test fixture | R&S [®] RT-ZF20 | 1800.0004.02 |
| Probe test fixture | R&S [®] RT-ZF30 | 1333.2099.02 |
| 19" rackmount kit for R&S [®] RTP oscilloscopes, 6 HU resulting height | R&S [®] ZZA-KN6 | 1175.3056.00 |

Warranty and service

| Warranty | | |
|--|-------------------------------------|-----------------------|
| Base unit | | 1 year |
| All other items | | 1 year |
| Service options | | |
| | Service plans | On demand |
| Calibration | up to five years ¹⁵ | pay per calibration |
| Warranty and repair | up to five years ¹⁵ | standard price repair |
| Find out more about our service portfolio under: | | |
| www.rohde-schwarz.com/service-support/service/ov | erview/service-overview 229461 html | |

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¹⁵ For extended periods, contact your Rohde & Schwarz sales office.

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